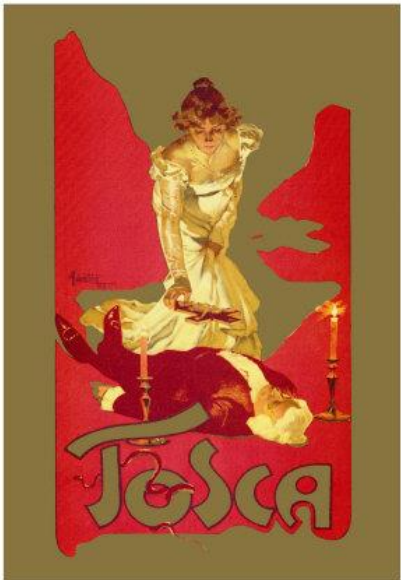
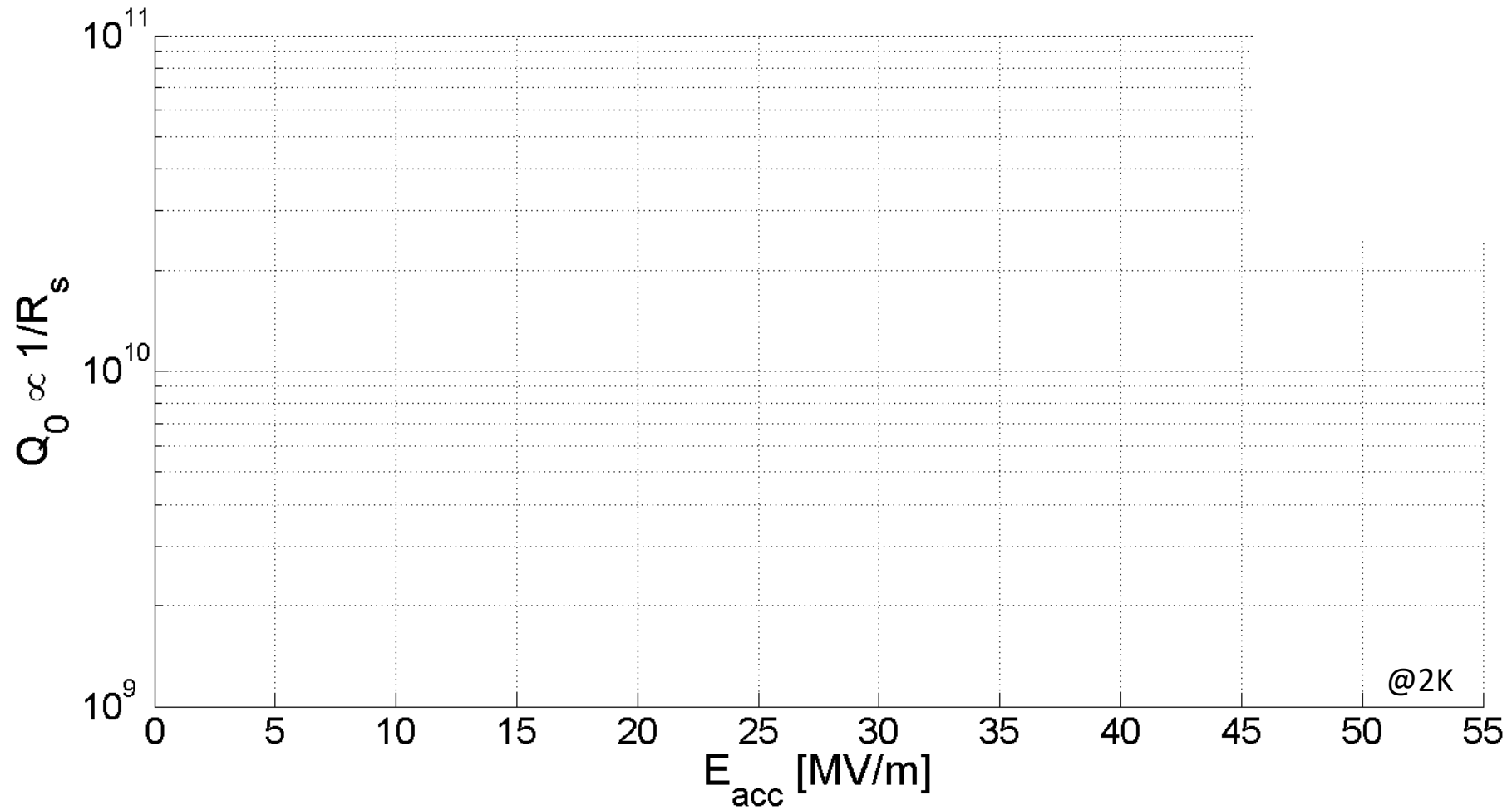


Interstitial oxygen tailoring by various surface treatments and how it impacts Q_0

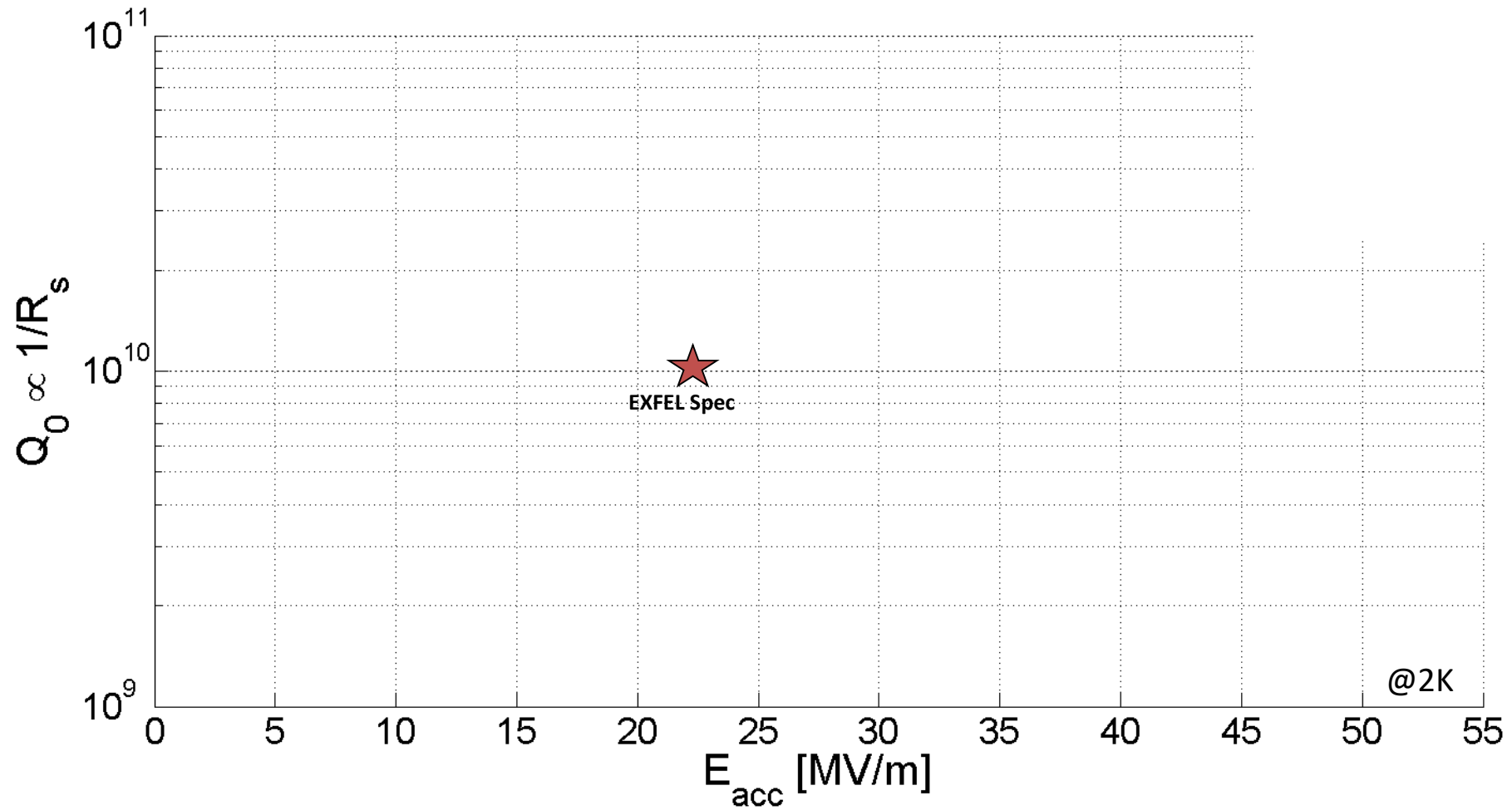


Rezvan Ghanbari, Artem Zaidman, Marc Wenskat
– on behalf of the UHH SRF R&D Team

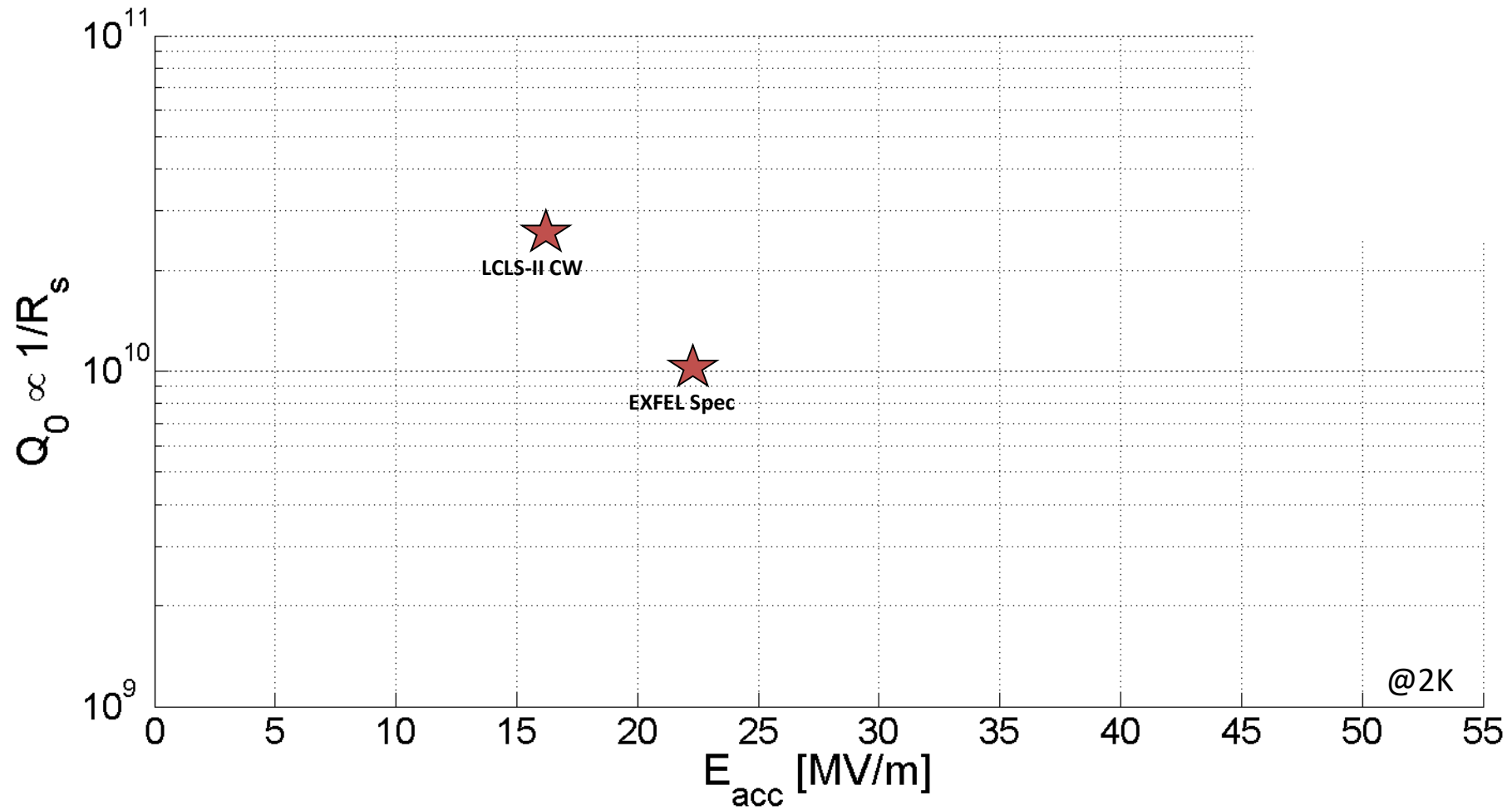
Recipes to choose from



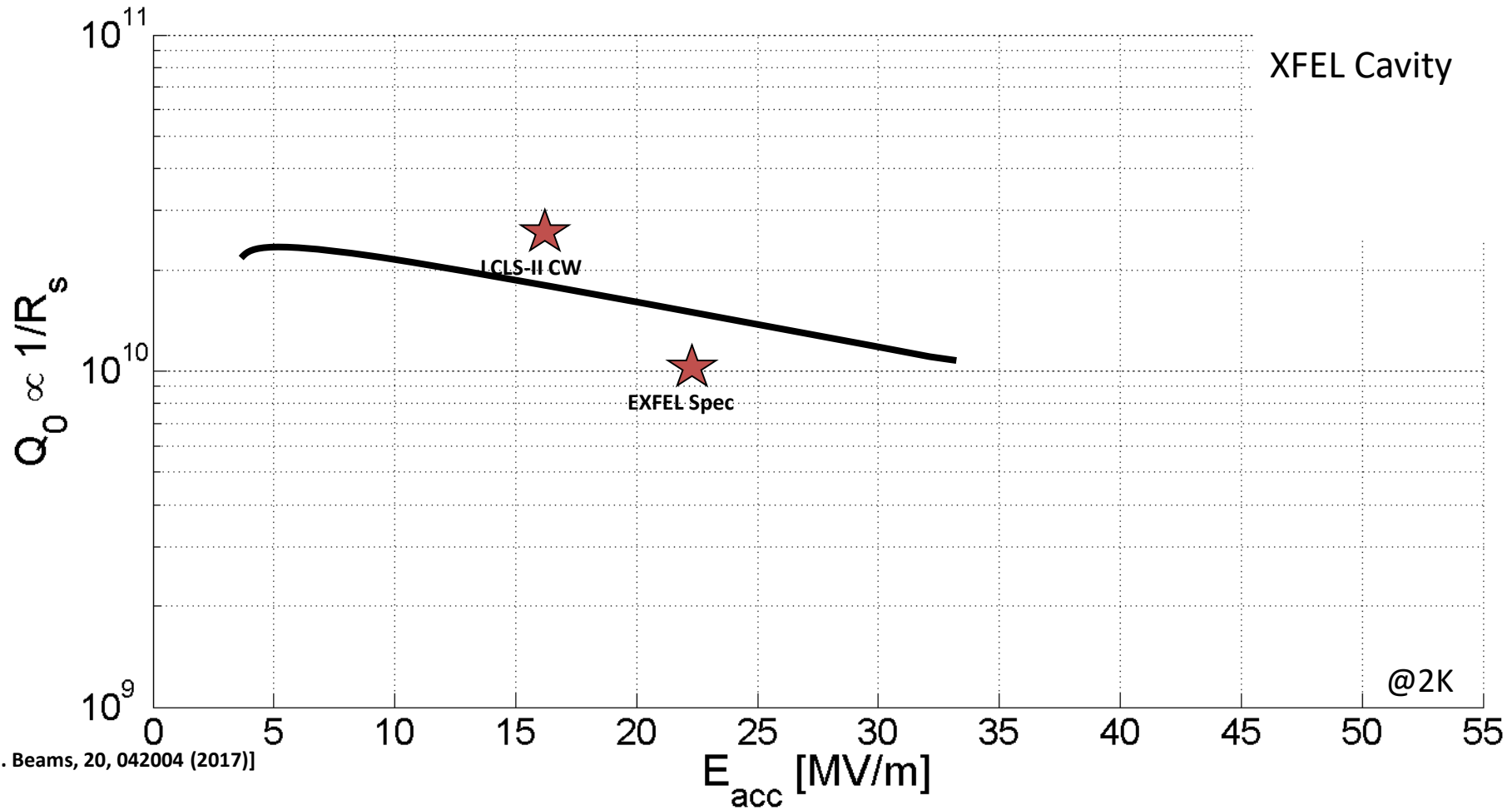
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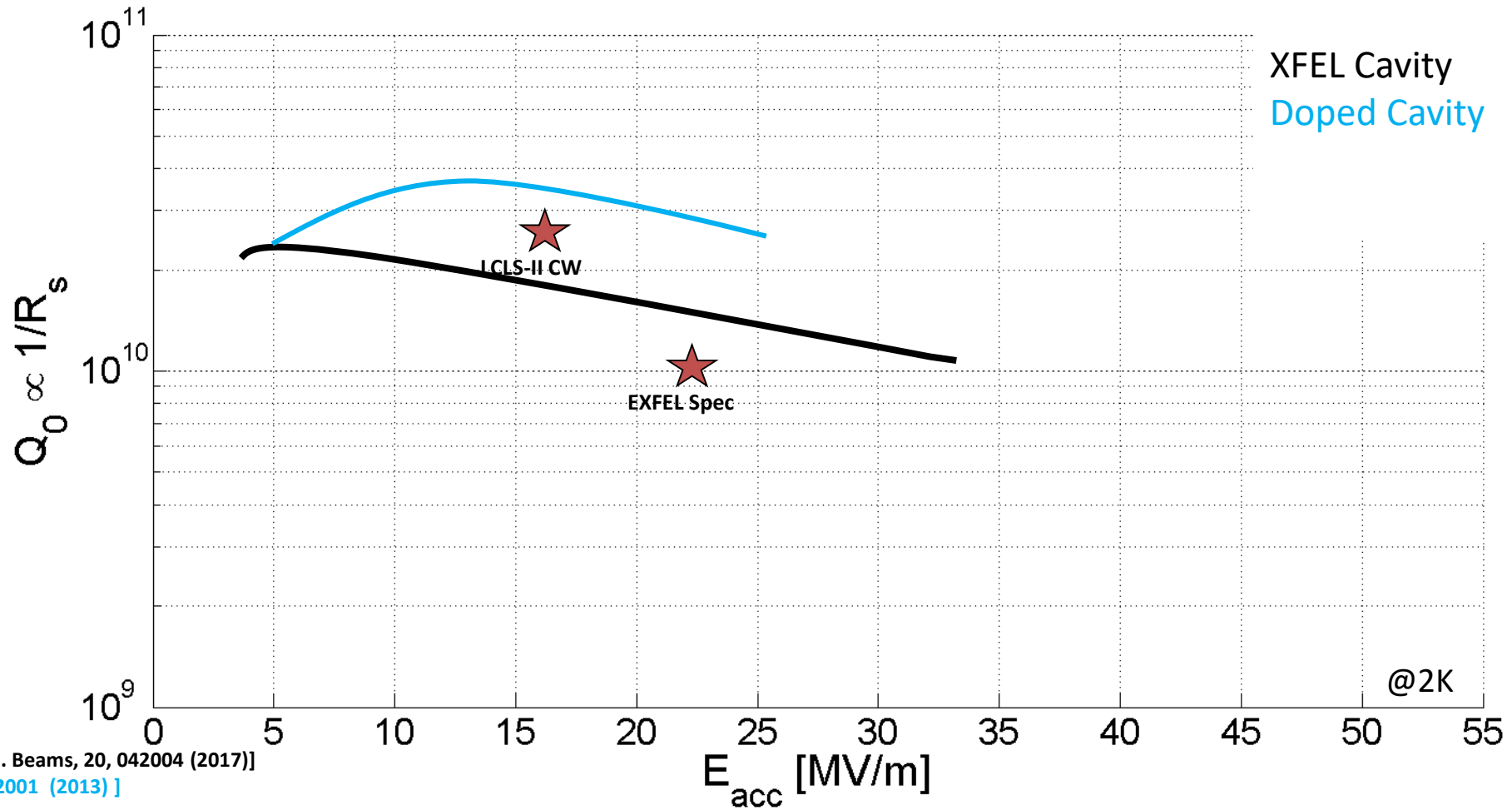
Recipes to choose from



[Reschke et al., Phys. Rev. Accel. Beams, 20, 042004 (2017)]

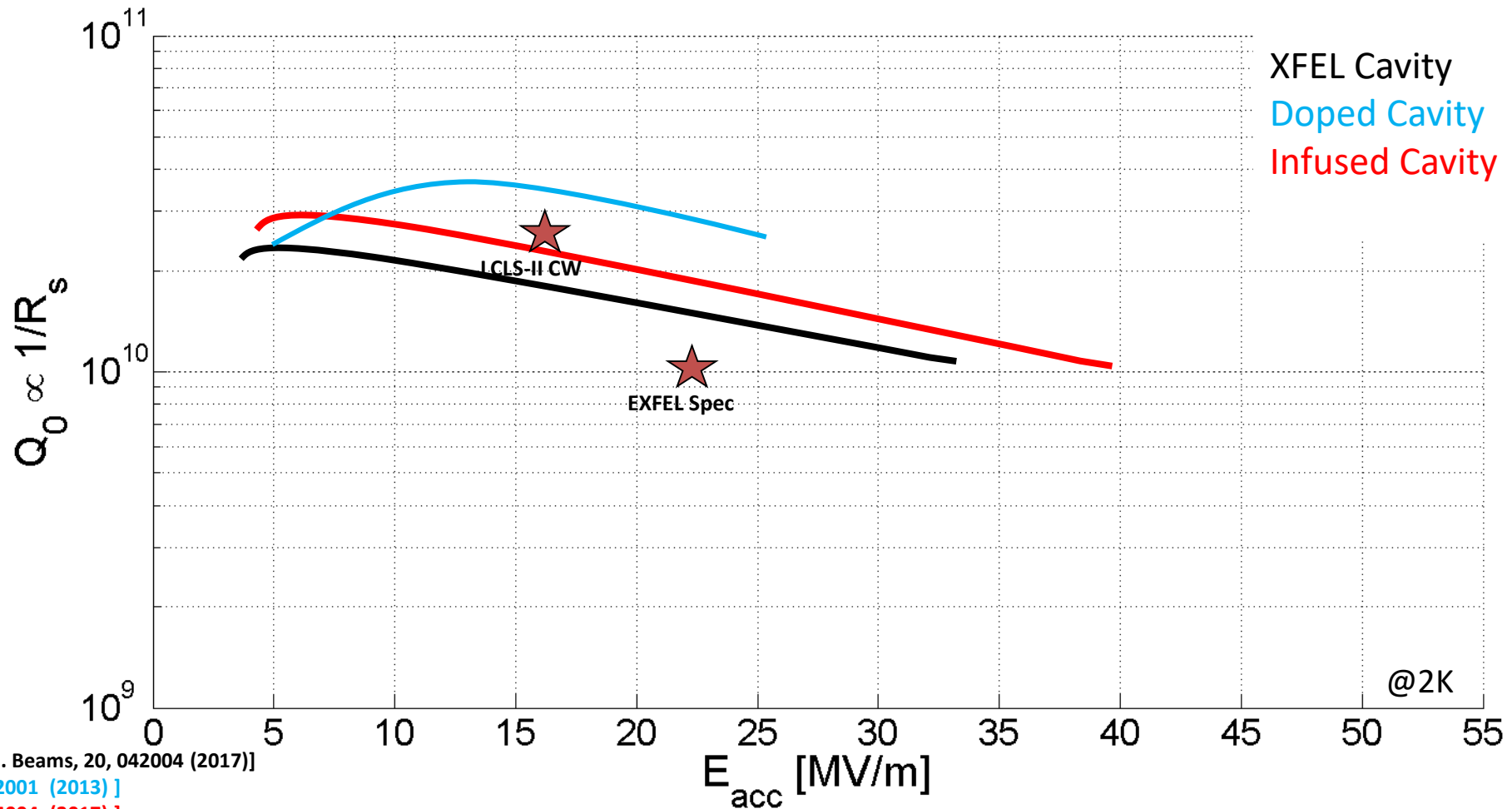
Cavities limited by quench

Recipes to choose from



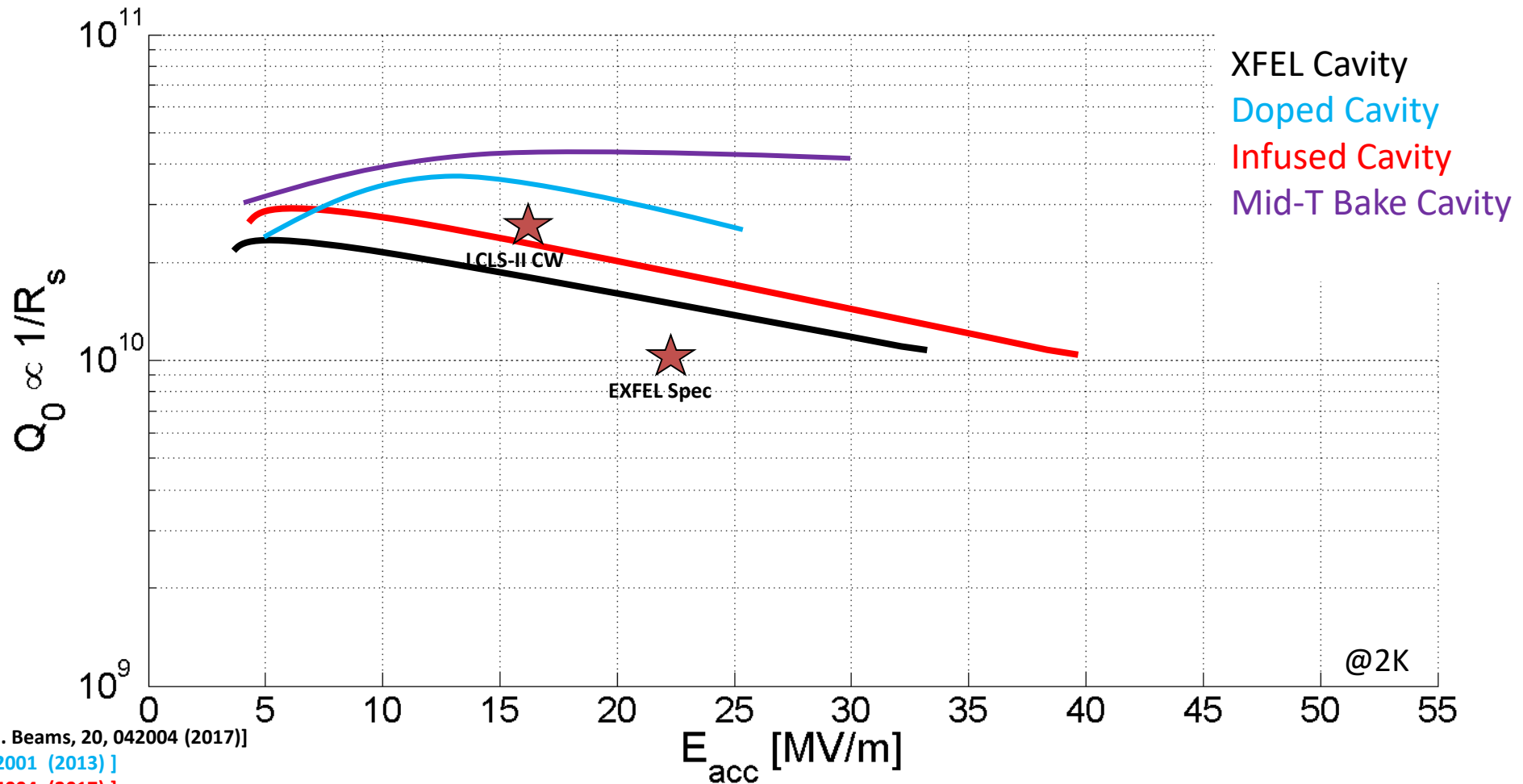
Cavities limited by quench

Recipes to choose from



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Cavities limited by quench

What happens during Mid-T Bake?

Mid-T Bake:

T: 300°C – 400°C

t ≈ 3-20h

p ≤ 10⁻⁶ mbar

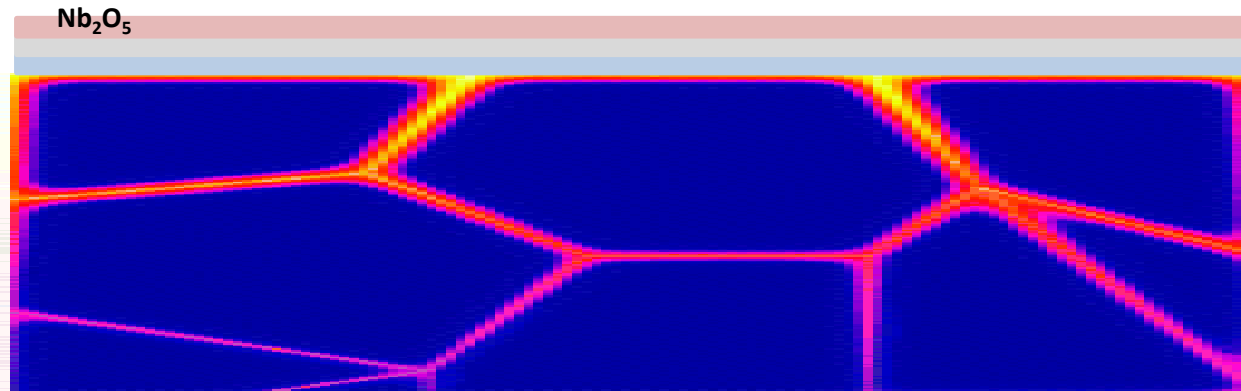
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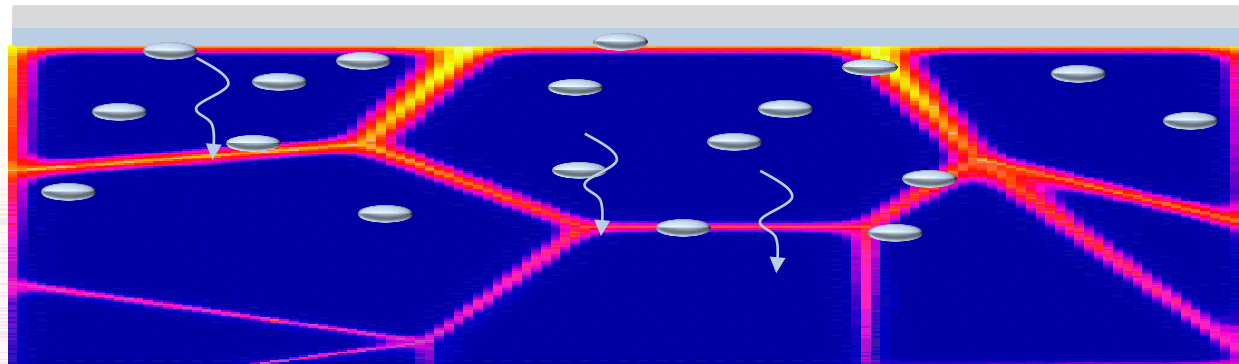
Mid-T Bake:

T: 300°C – 400°C

t ≈ 3-20h

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Nb₂O₅ dissolves around ≈250°C

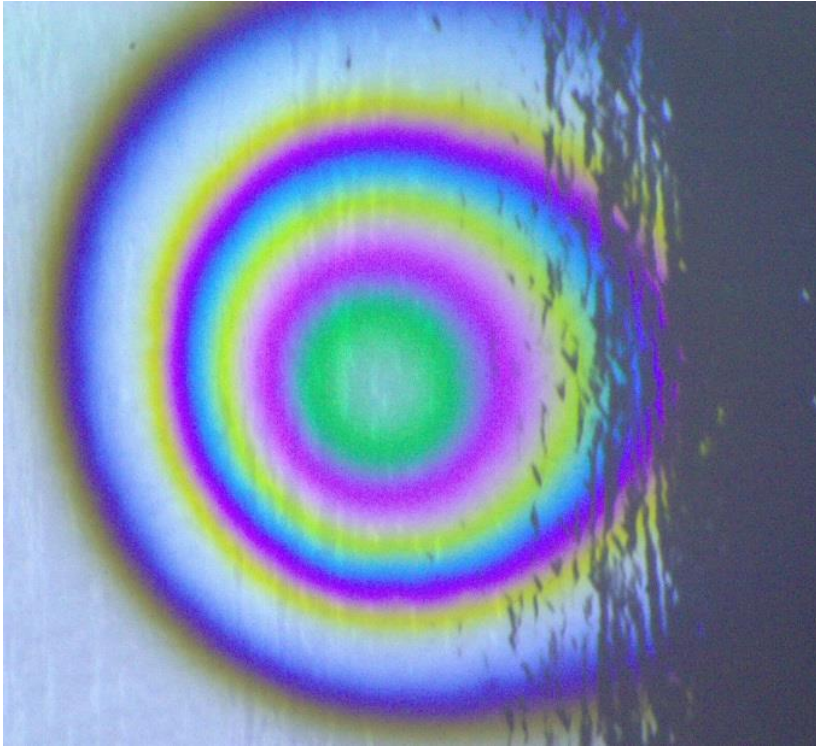


Oxygen

Failed HPR showed unwanted oxide growth

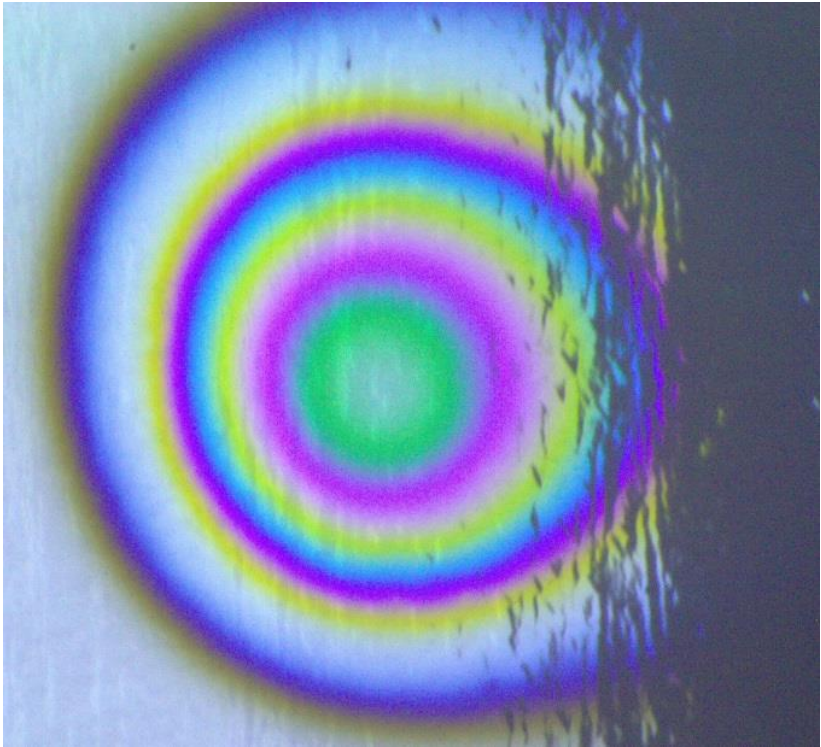
Failed HPR showed unwanted oxide growth

In two cases HPR on cavities created rainbows
(AC126, NXPKU5)

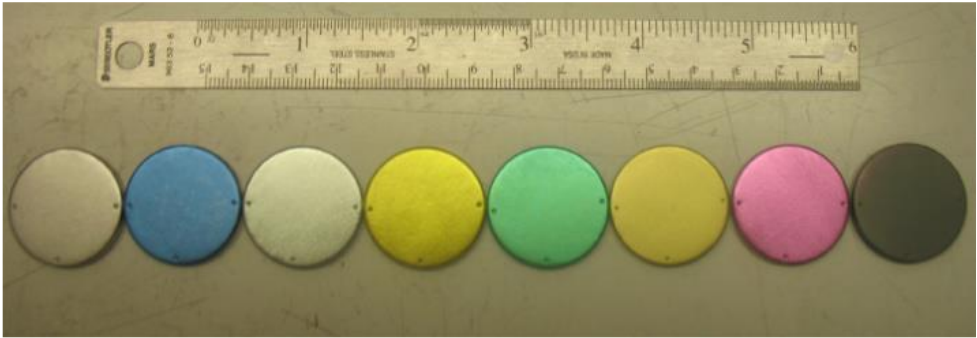


Failed HPR showed unwanted oxide growth

In two cases HPR on cavities created rainbows (AC126, NXPKU5)



[Wu, A. T., et al. *Effects of the thickness of niobium surface oxide layers on field emission*. IPAC 2018 - MOPC118]



Sample	1	2	3	4	5	6	7
Voltage (V)	25	37	45	80	95	110	230
Color	Blue	Cyan	Bright Yellow	Green	Yellow	Red	Dark Grey
Oxide Thickness (nm)	53	77	93	163	193	223	463

Obvious pentoxide growth due to failed HPR

Extensive HPR

[Ghanbari, R. TTC Workshop 2022, Aomori]

Extensive HPR

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X-Ray Photoelectron Spectroscopy (XPS)

Reference
0 HPR cycle

Standard recipe
6 HPR cycles

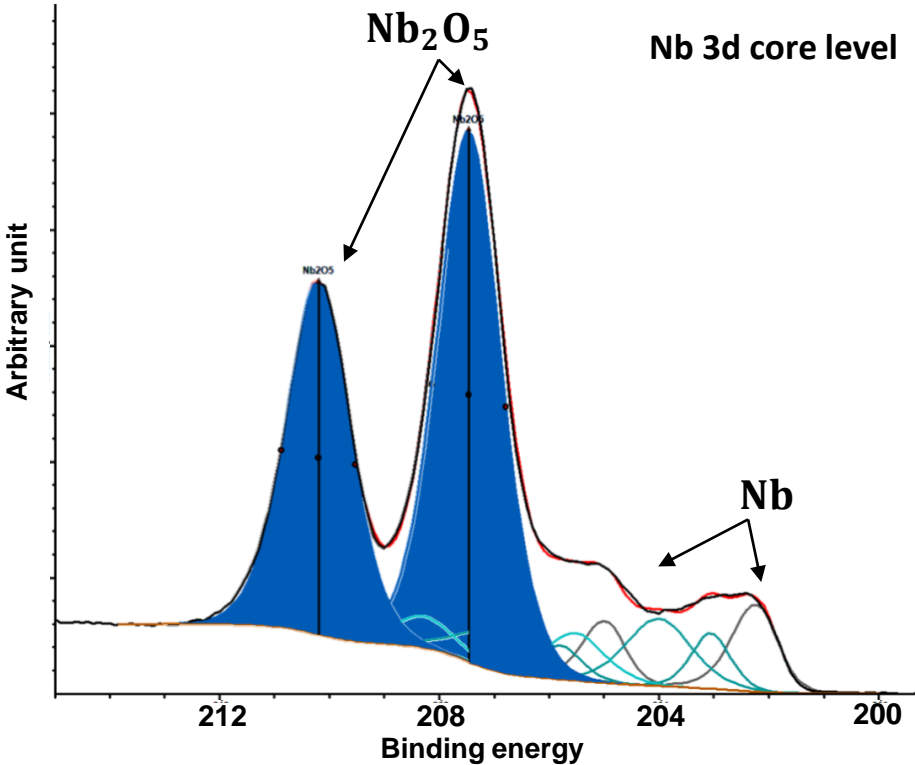
18 HPR cycles



Extensive HPR

[Ghanbari, R. TTC Workshop 2022, Aomori]

$$\frac{\text{component doublet peaks area}}{\text{total Nb 3d peak area}}$$

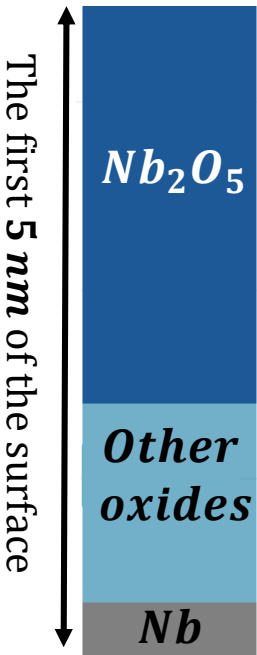


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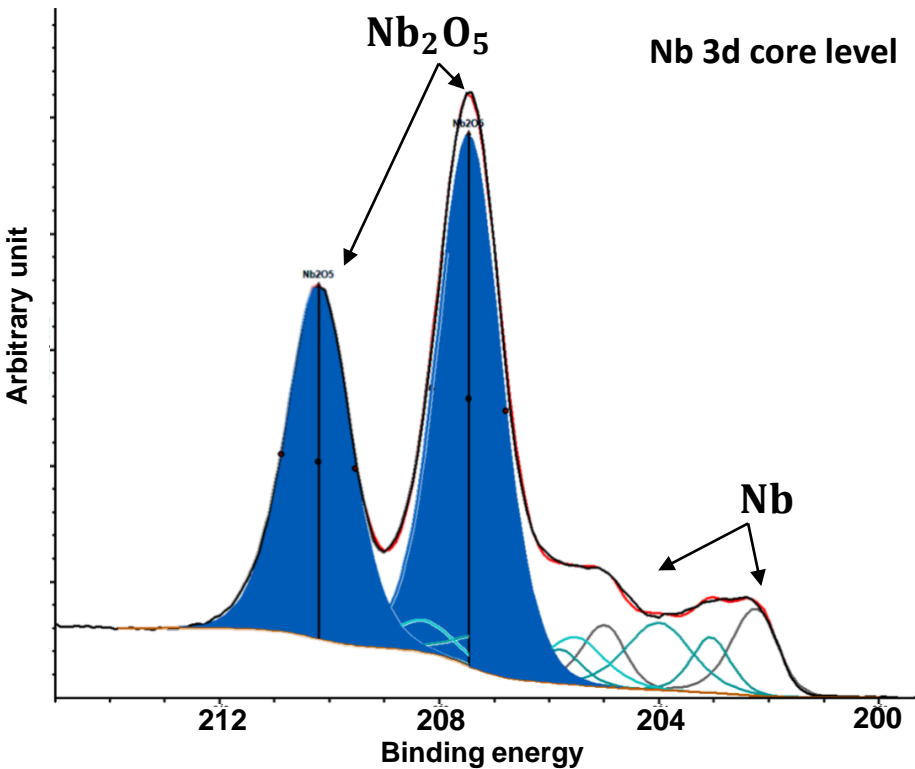
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Extensive HPR → thicker Nb₂O₅

[Ghanbari, R. TTC Workshop 2022, Aomori]

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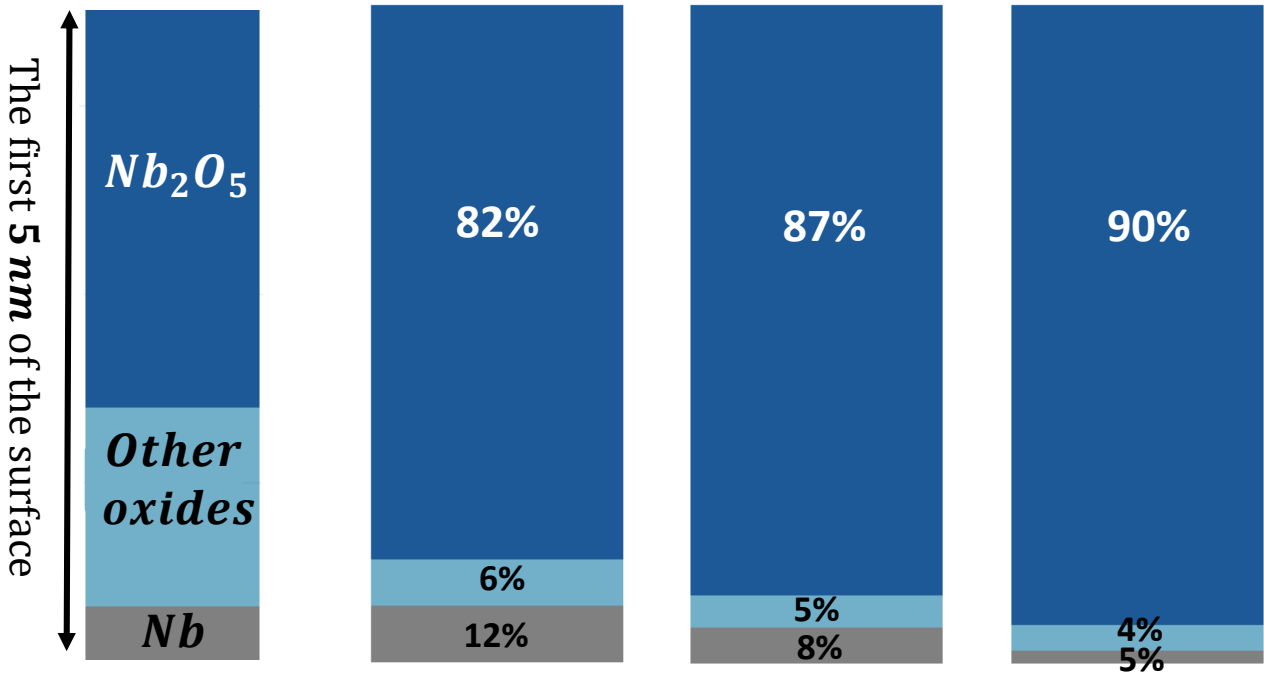


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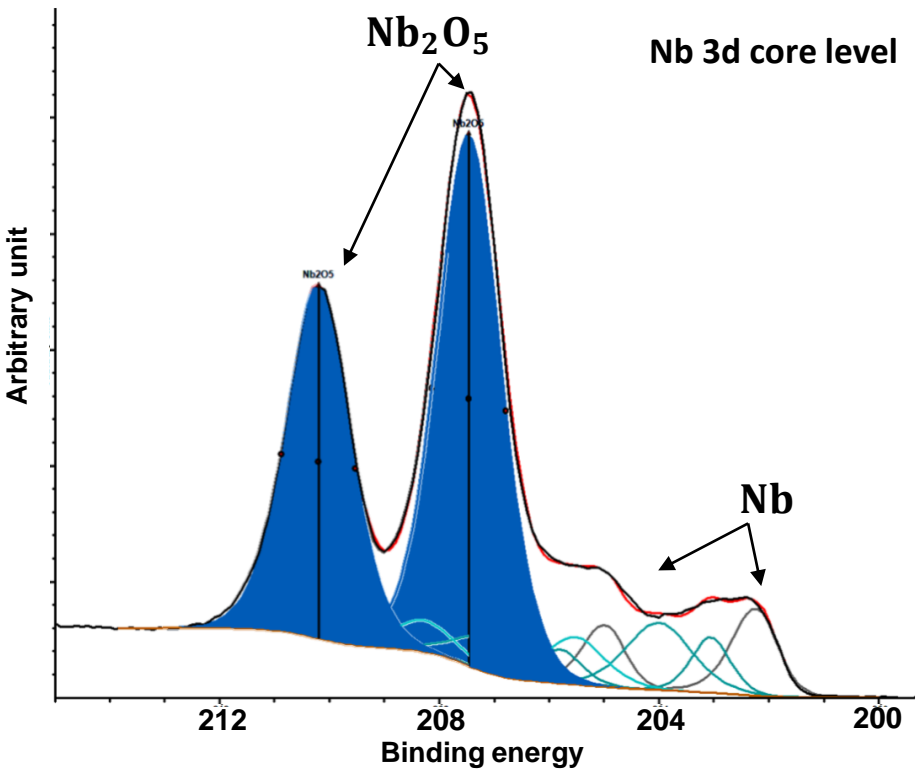
18 HPR cycles



Extensive HPR → thicker Nb_2O_5 → more O for mid-T

[Ghanbari, R. TTC Workshop 2022, Aomori]

$\frac{\text{component doublet peaks area}}{\text{total Nb 3d peak area}}$

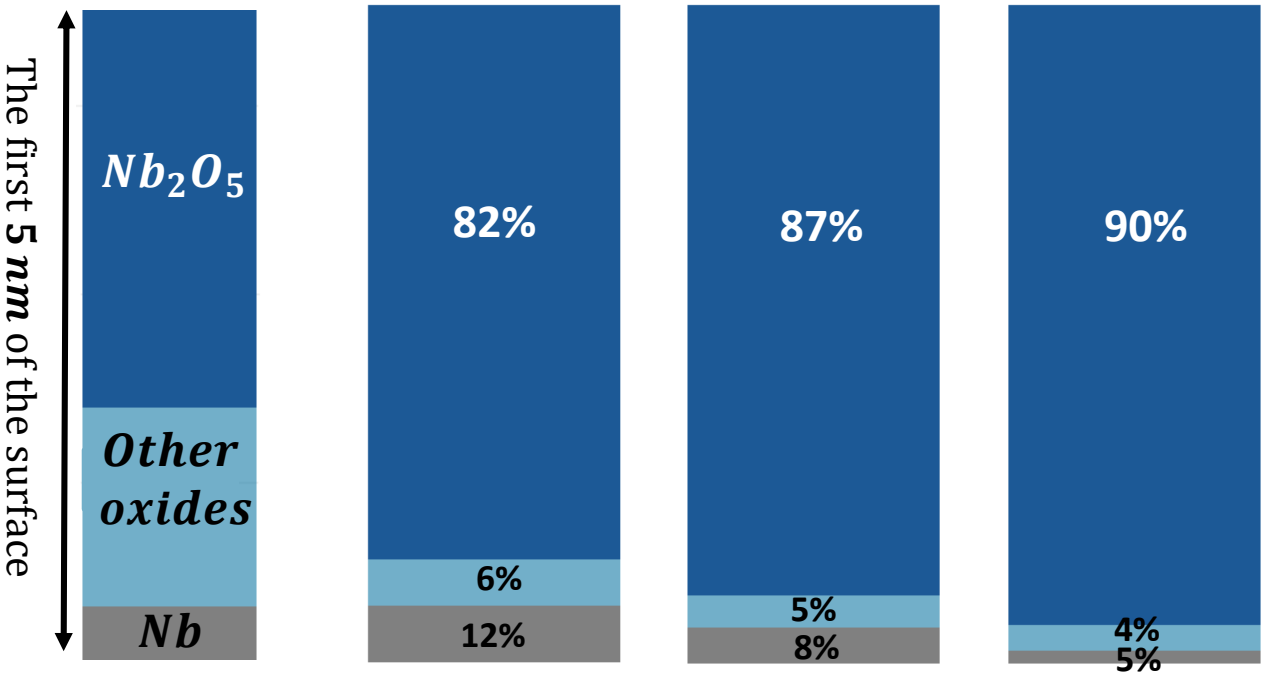


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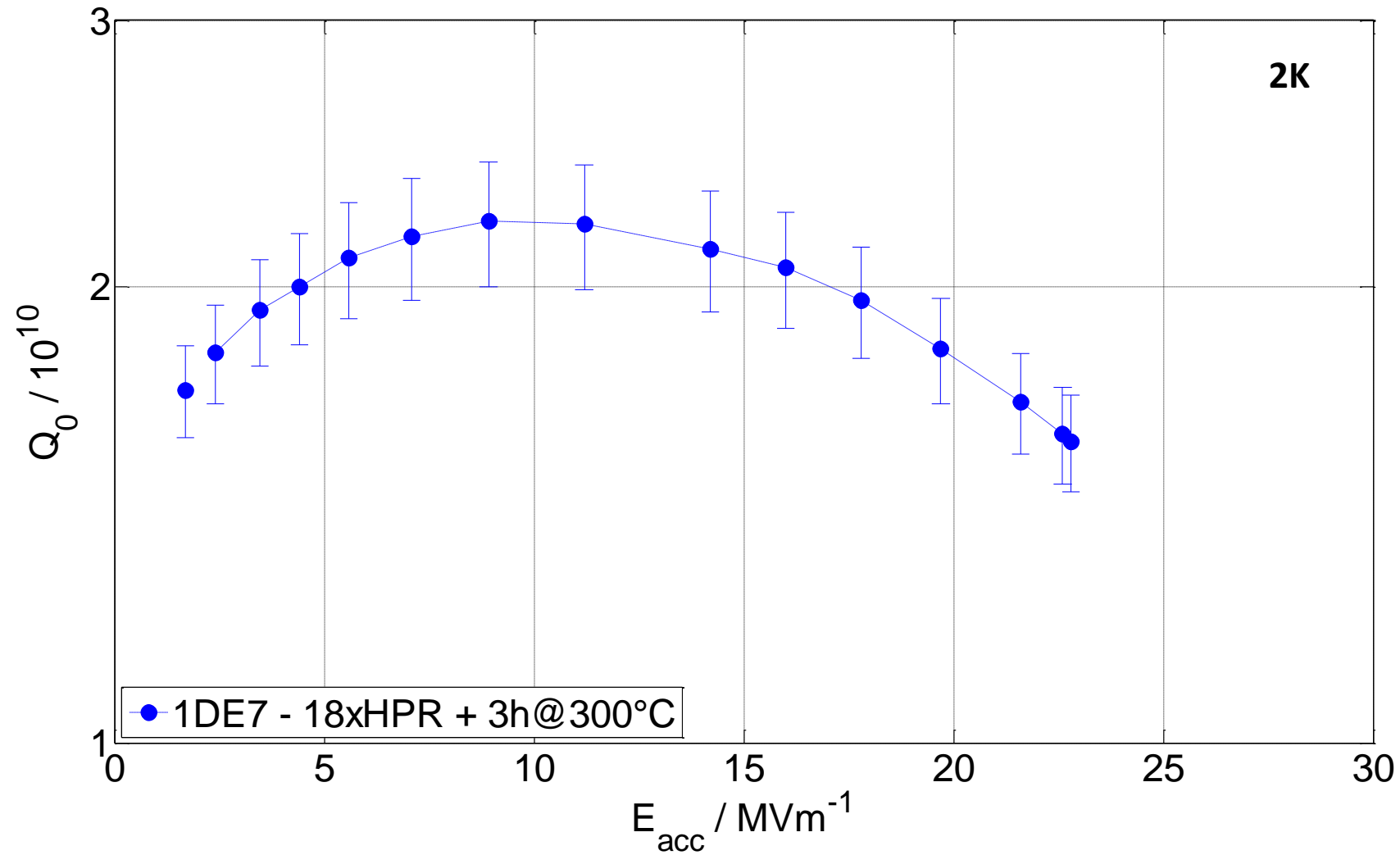
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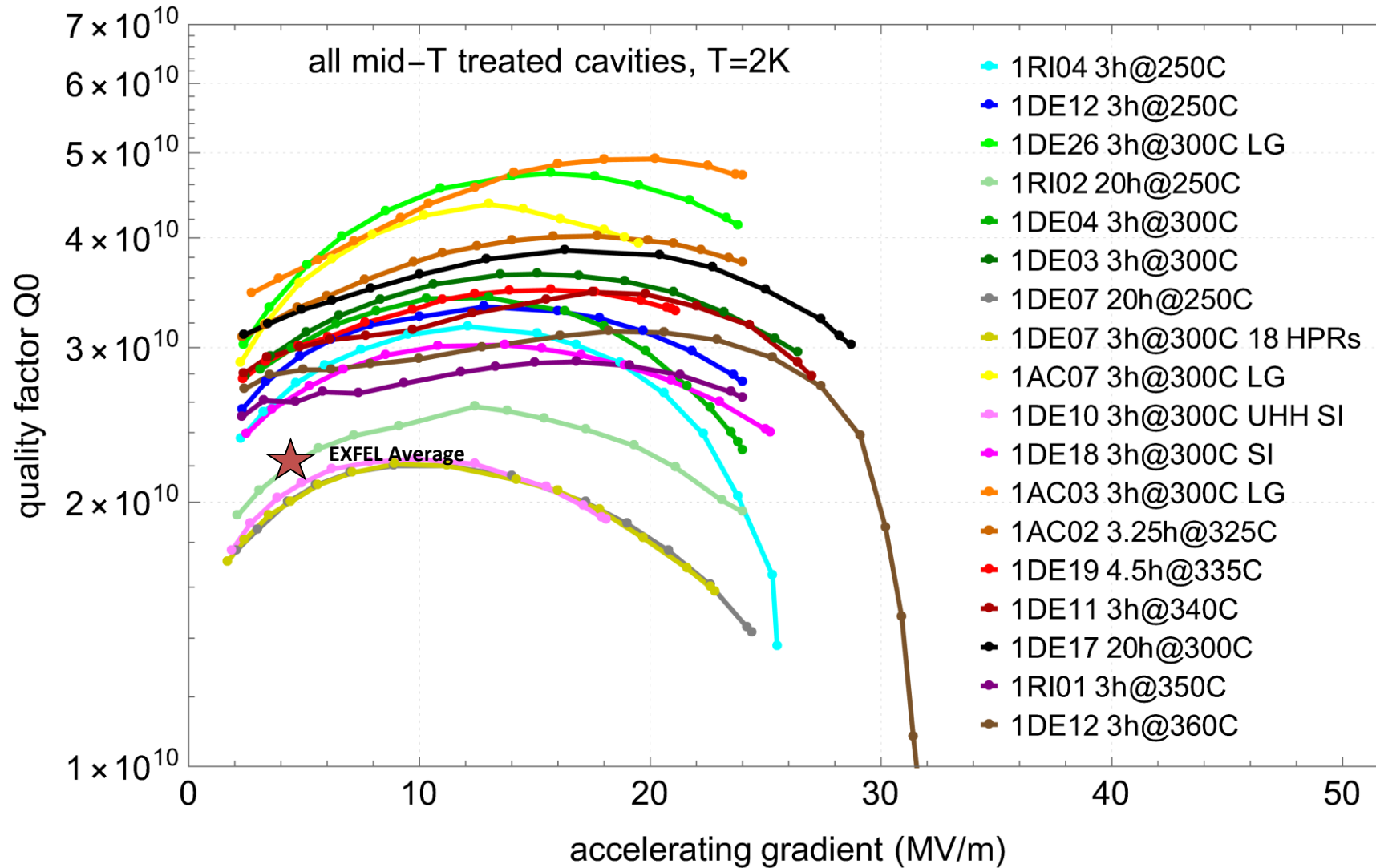
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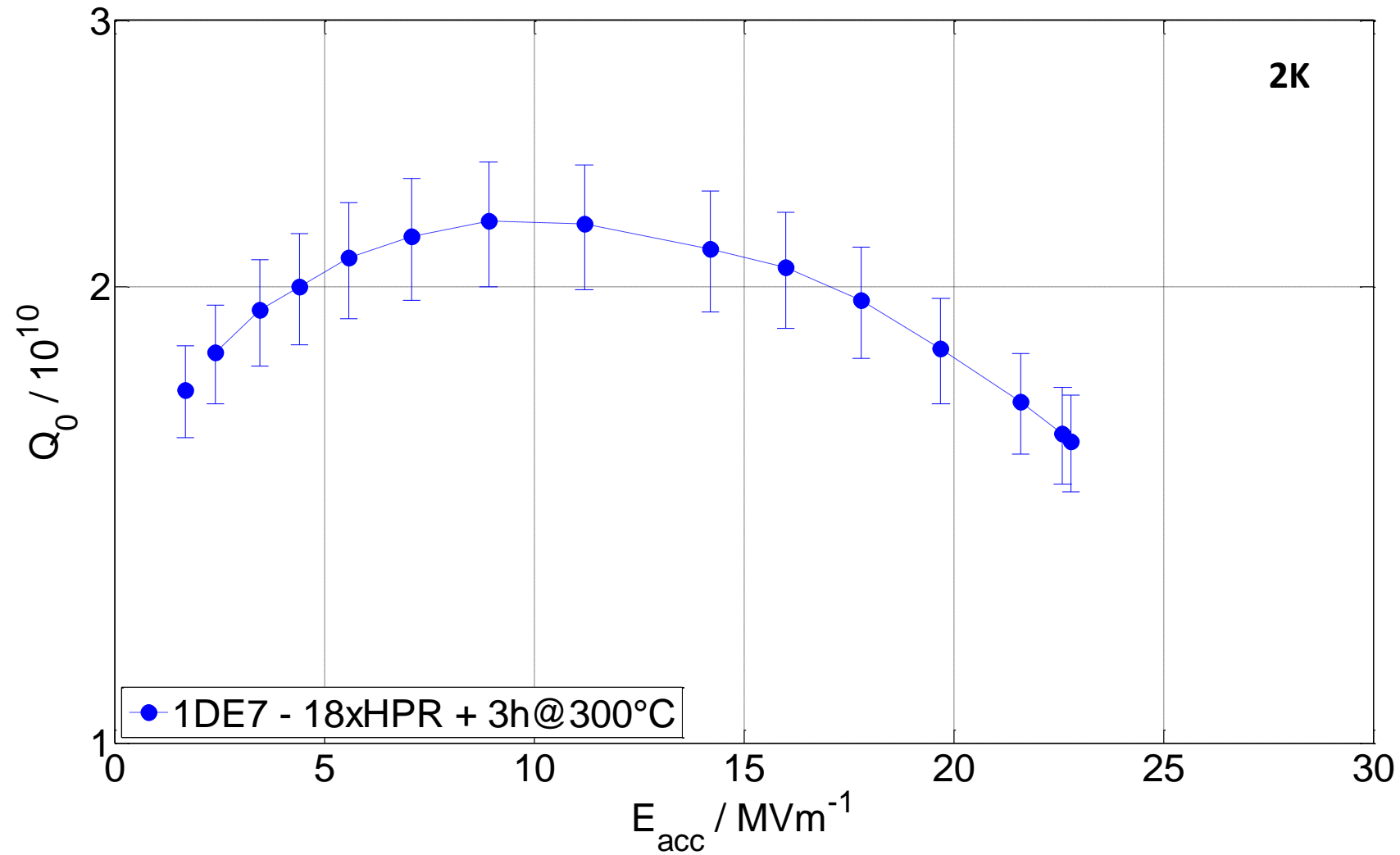
18x HPR is not beneficial for Q_0



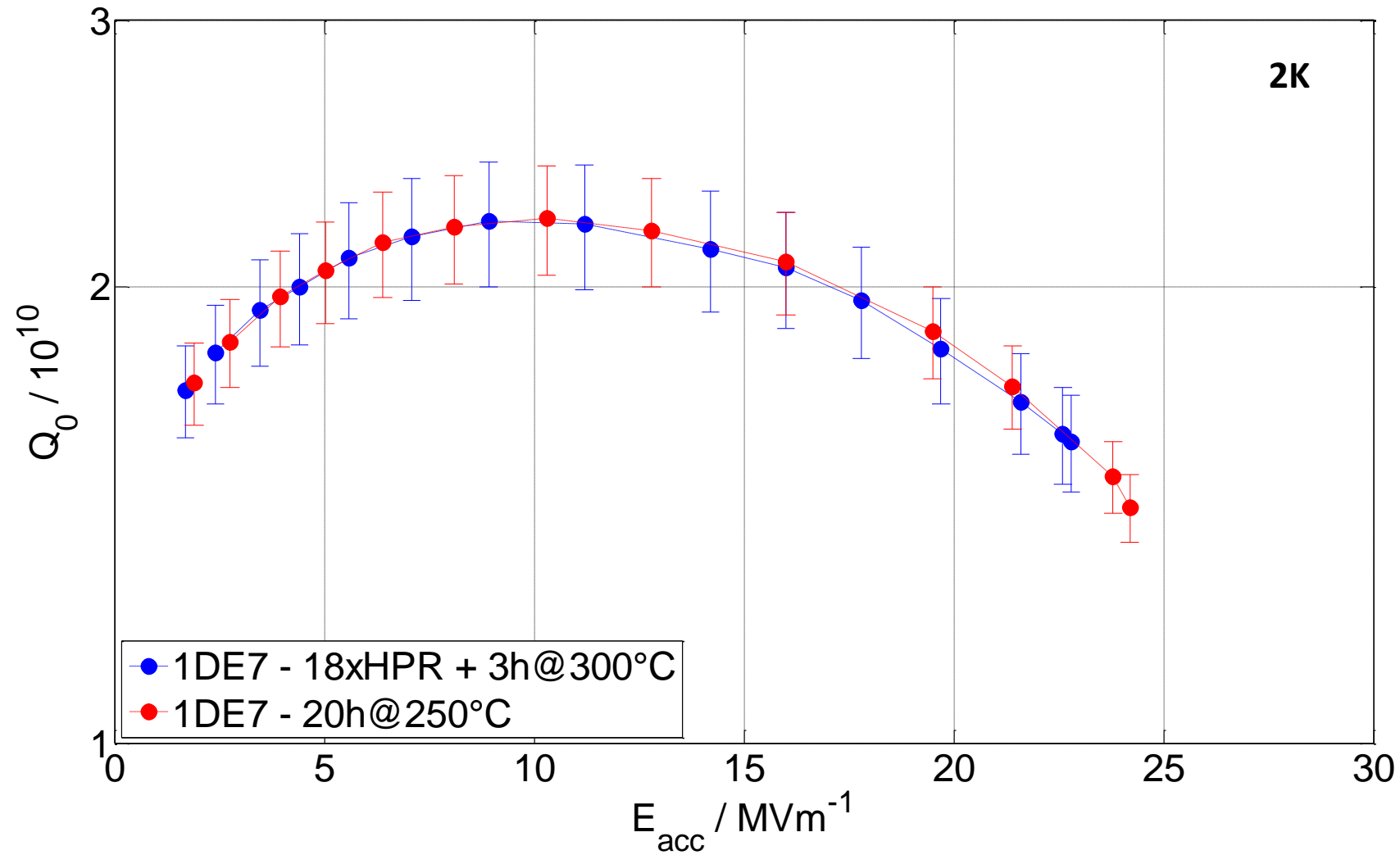
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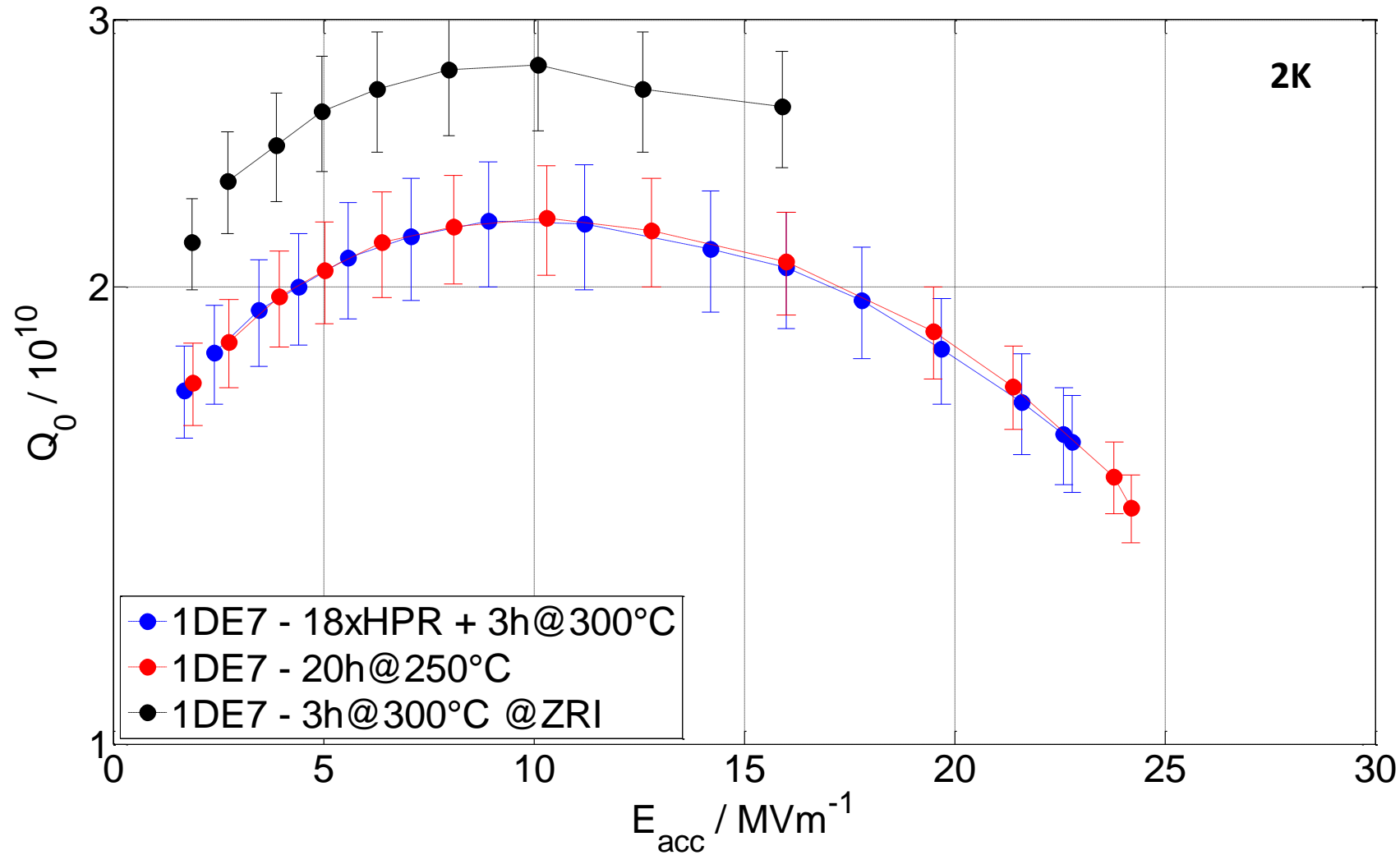
18x HPR is not beneficial for Q_0



Different treatments – same rf behaviour

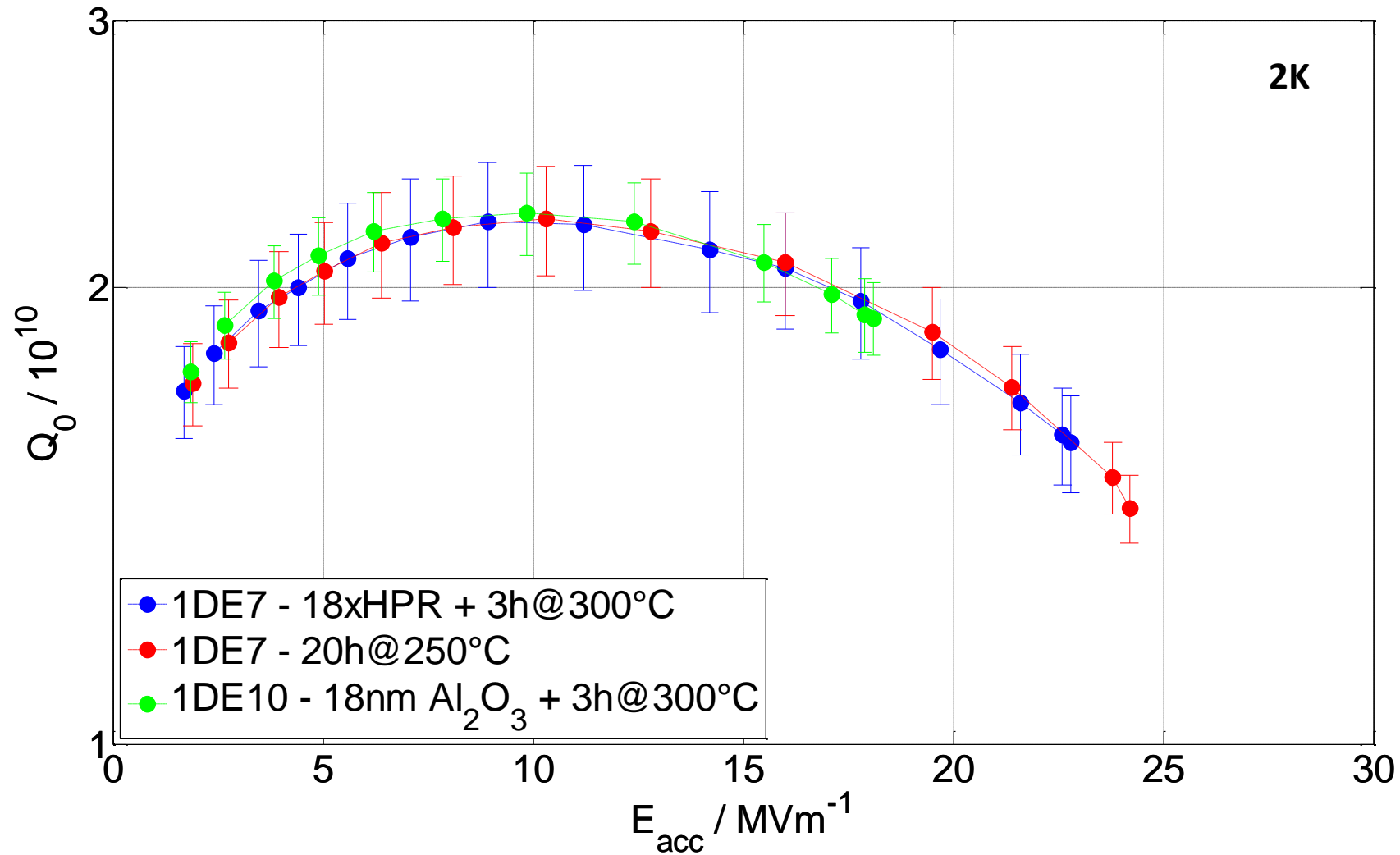


It's not the cavity!



20 μm EP between black and red
40 μm EP between red and blue

It's not the cavity!

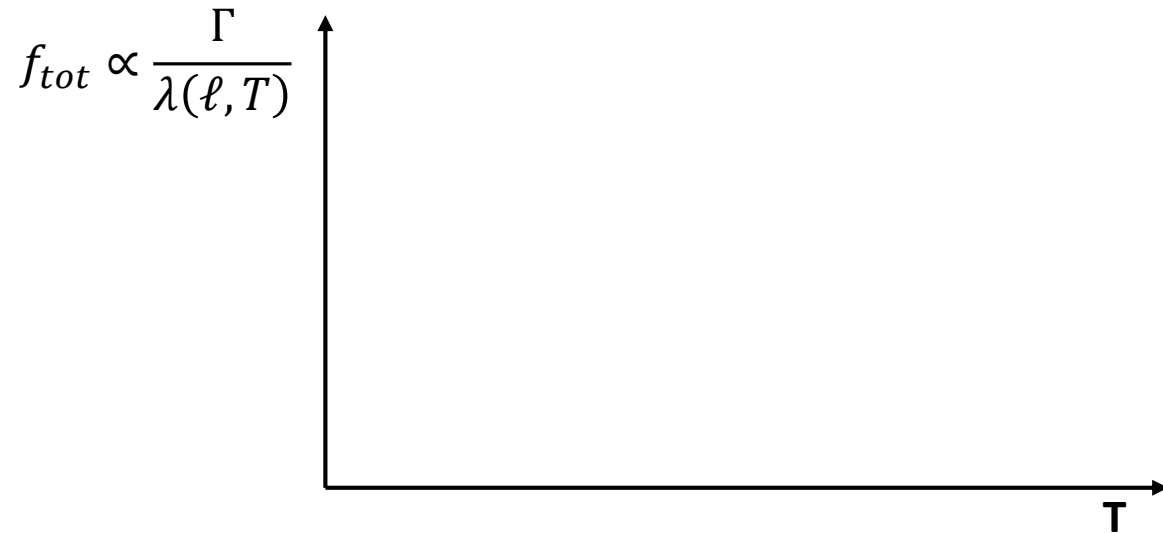


What information is encoded in f vs. T ?

- Frequency shift is sensitive to interstitial concentration

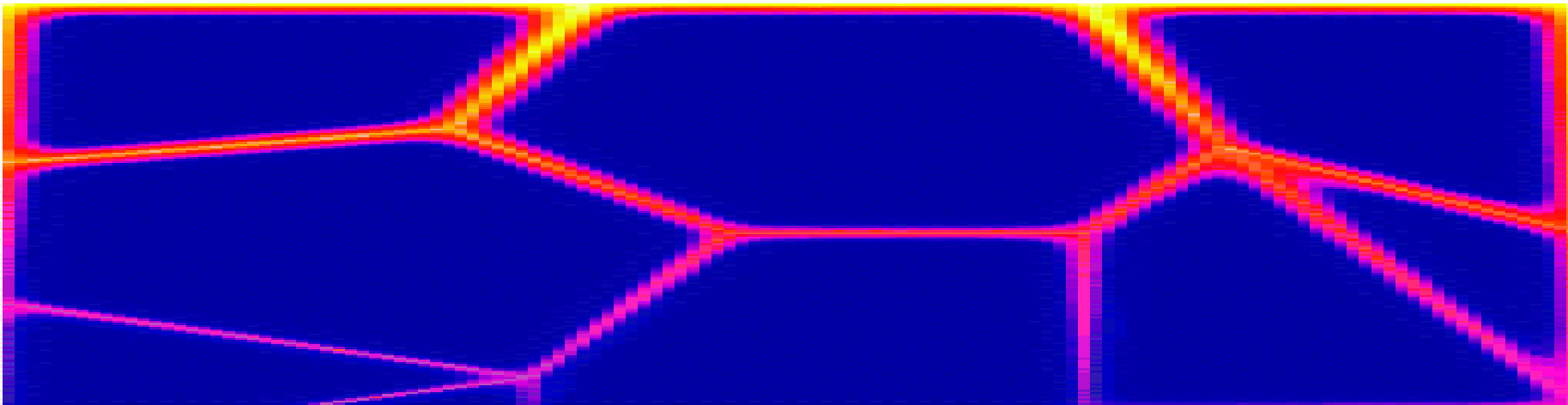
$$\lambda(\ell, T) = \lambda_L(T) \sqrt{1 + \frac{\xi_0}{\ell}} \quad \text{(equation valid for dirty limit)}$$

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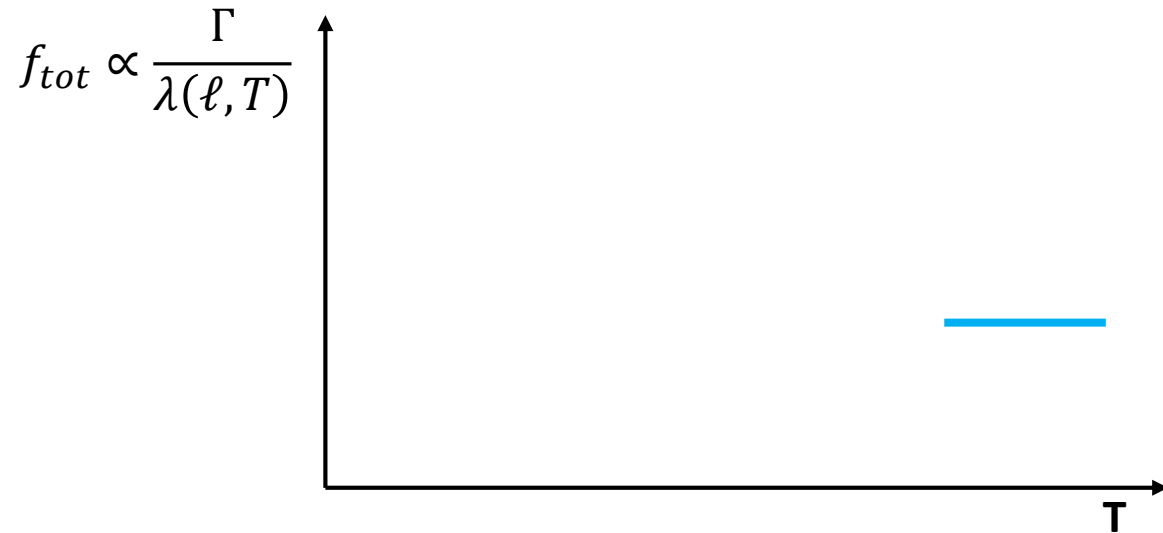


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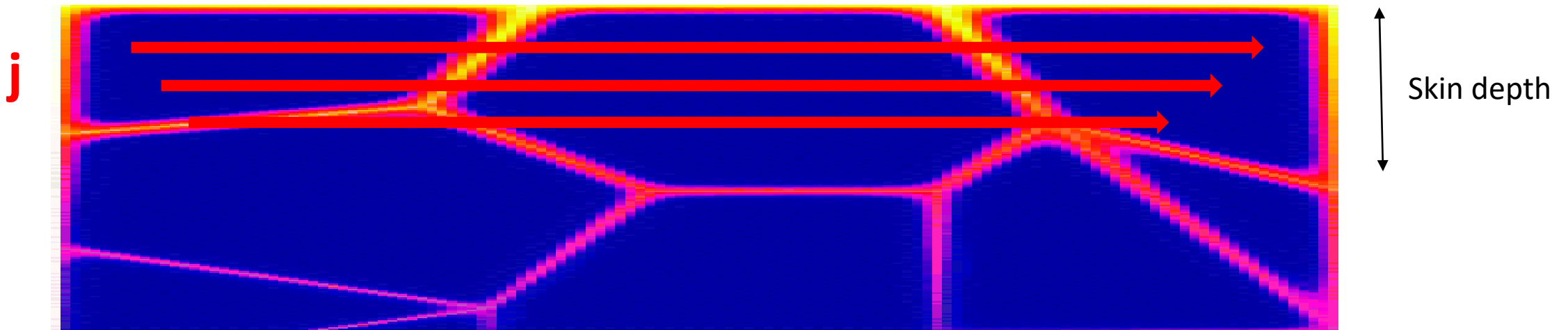


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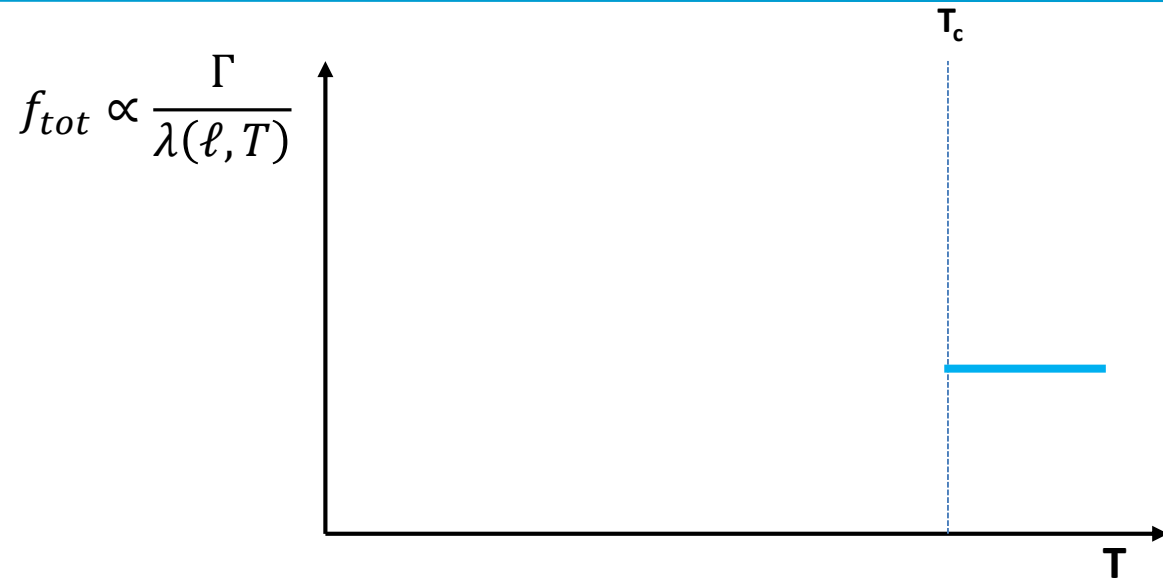


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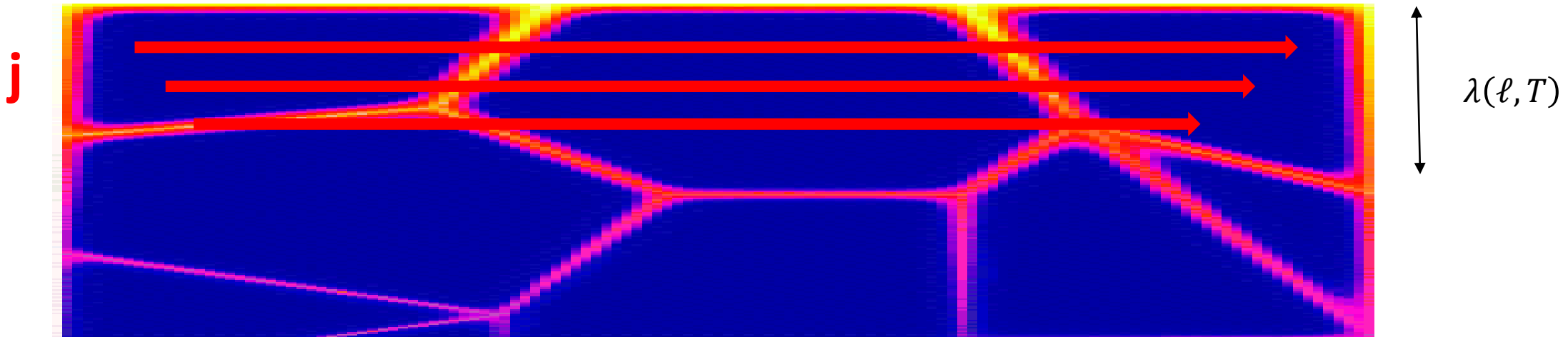


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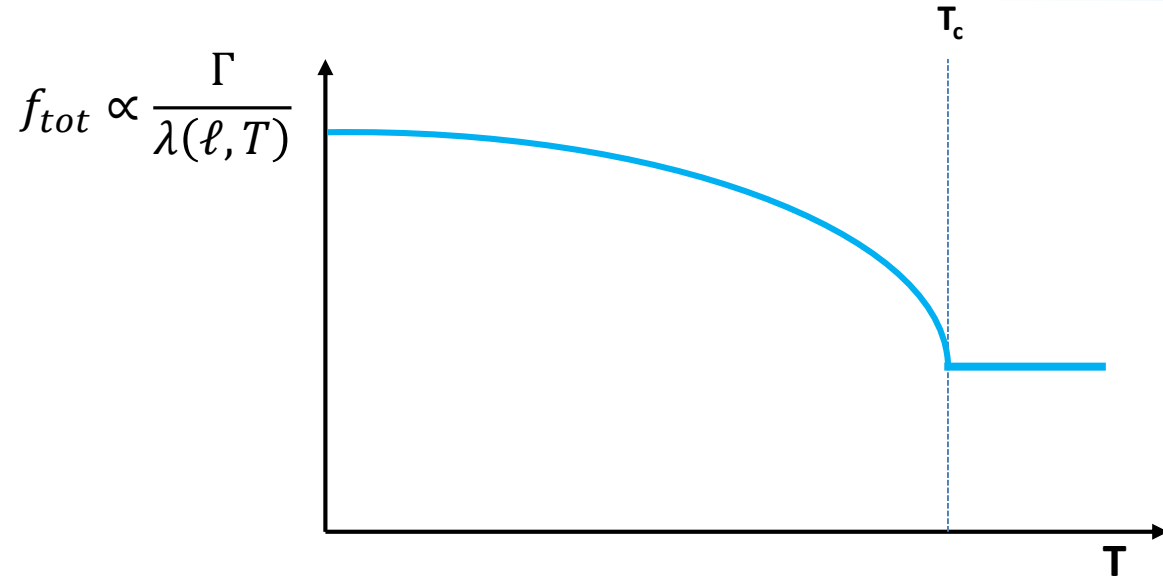


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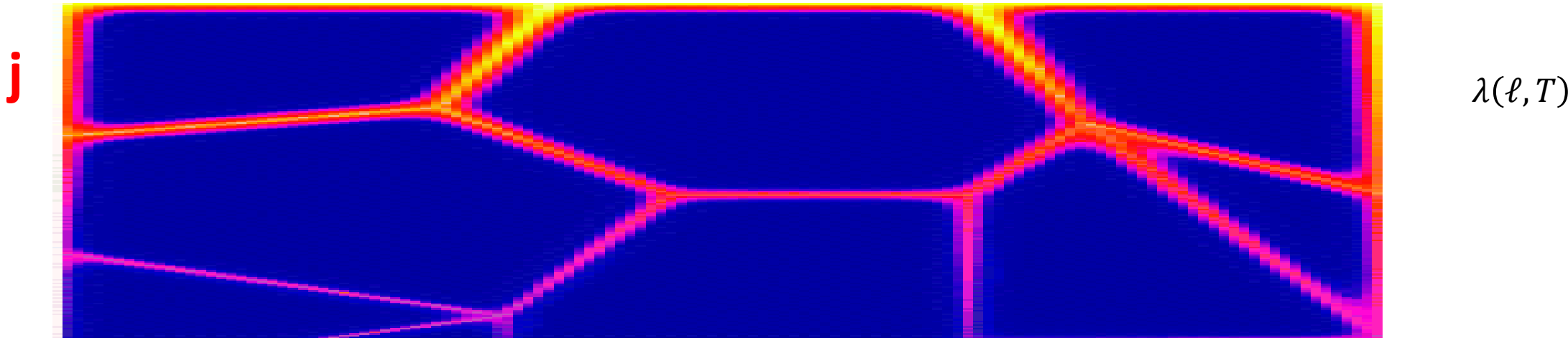


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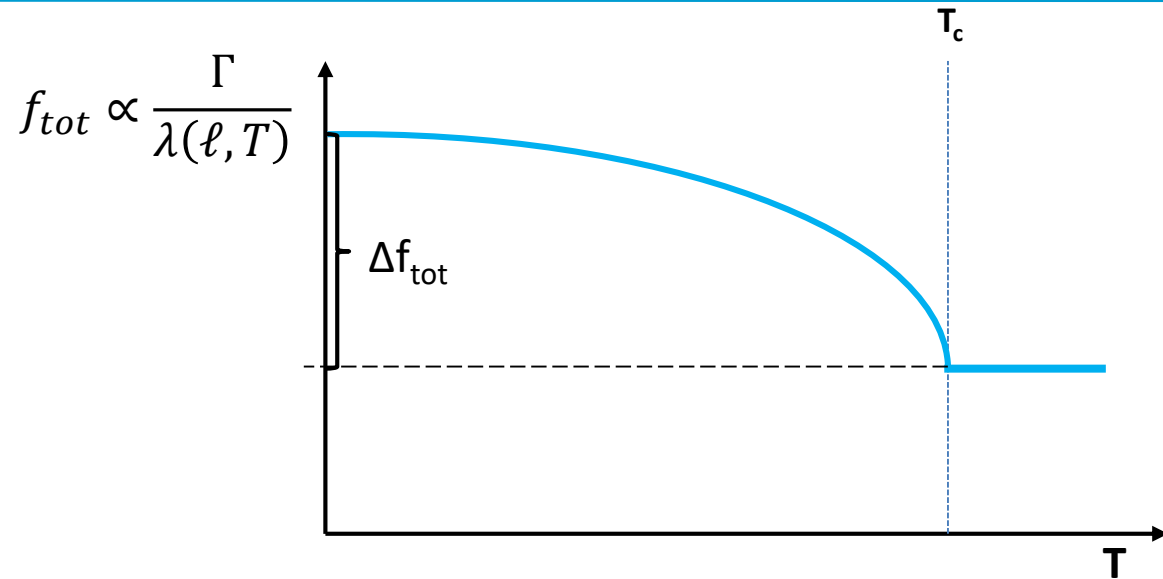


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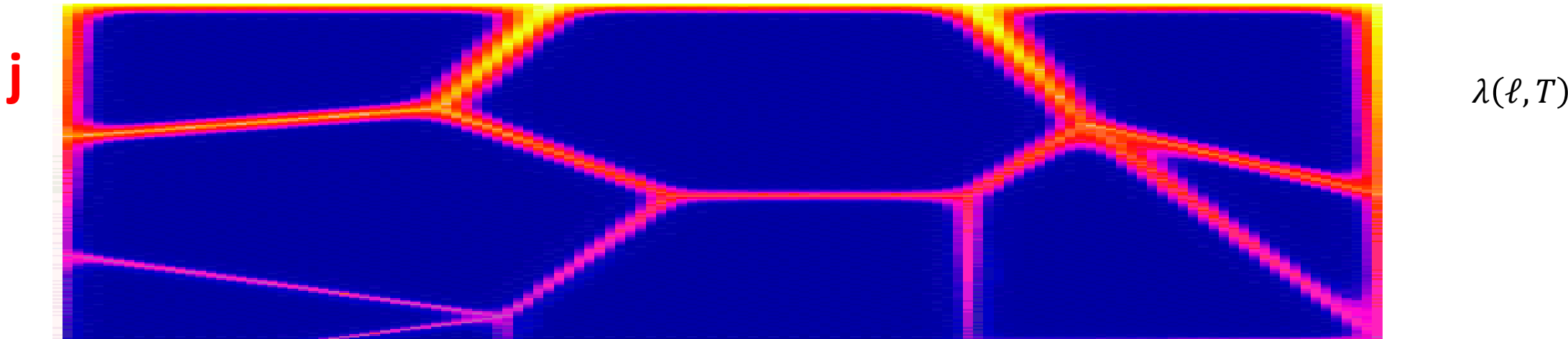
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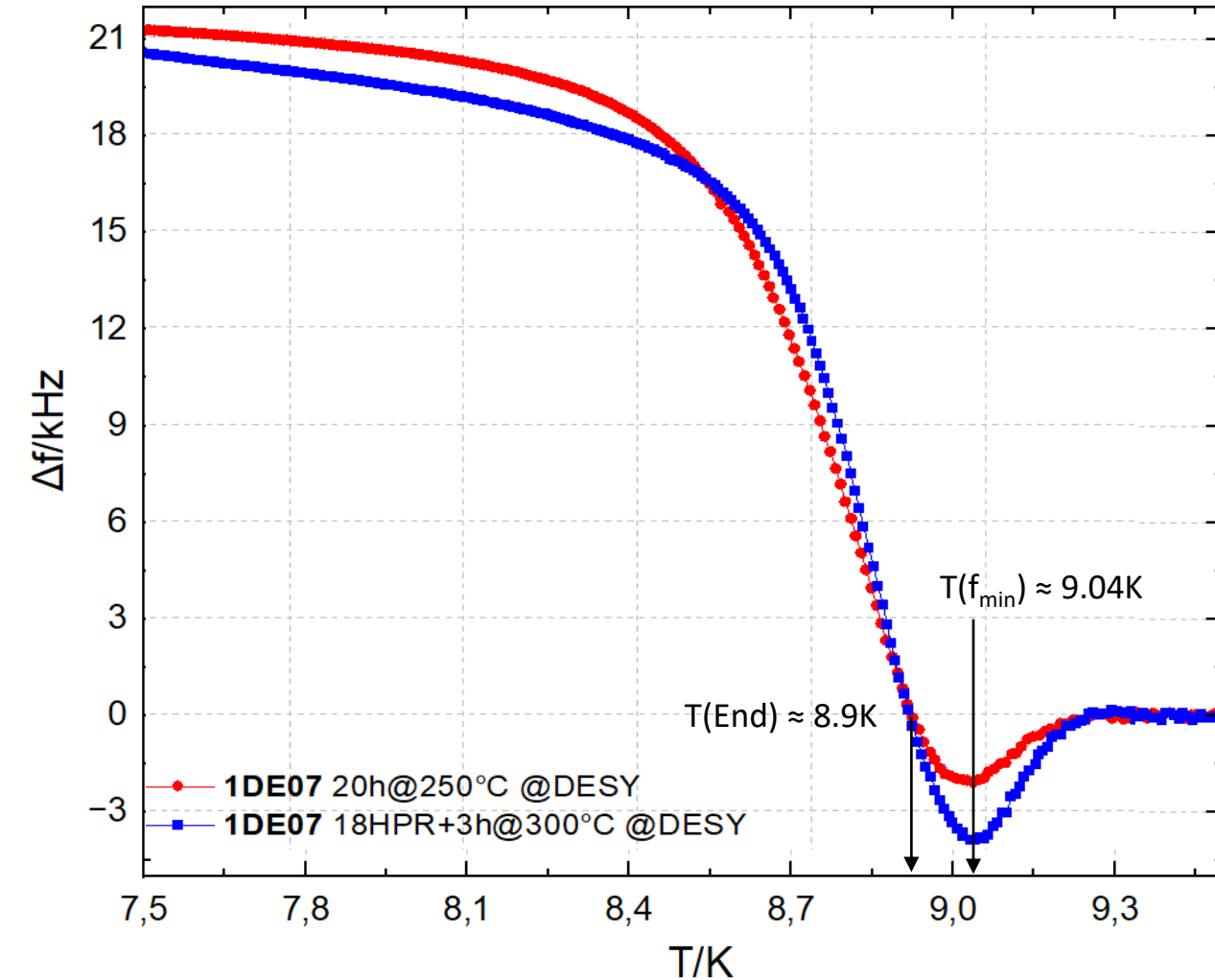
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- Δf_{tot} for EXFEL type cavities is typically 5-6 kHz



Dip is deeper for 18xHPR – Δf_{tot} similar



- Mid-T: more interstitials \rightarrow larger Δf , but yet no dip

Cavity	Treatment	$\Delta f_{\text{dip}}/\text{kHz}$
1DE19	4.5h @ 335°C	1.1
1AC02	3.25h @ 335°C	1.4
1RI04	3h @ 250°C	0.9
1DE07	20h @ 250°C	2.0
1DE79	18xHPR + 3h @ 300°C	3.9

Microscopic model for disordered superconductor

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- An increased oxygen concentration reduces T_c of Nb by 0.93K per 1 at.%

[Desorbo, W. *Phys. Rev.* 132 (1963): 107.]

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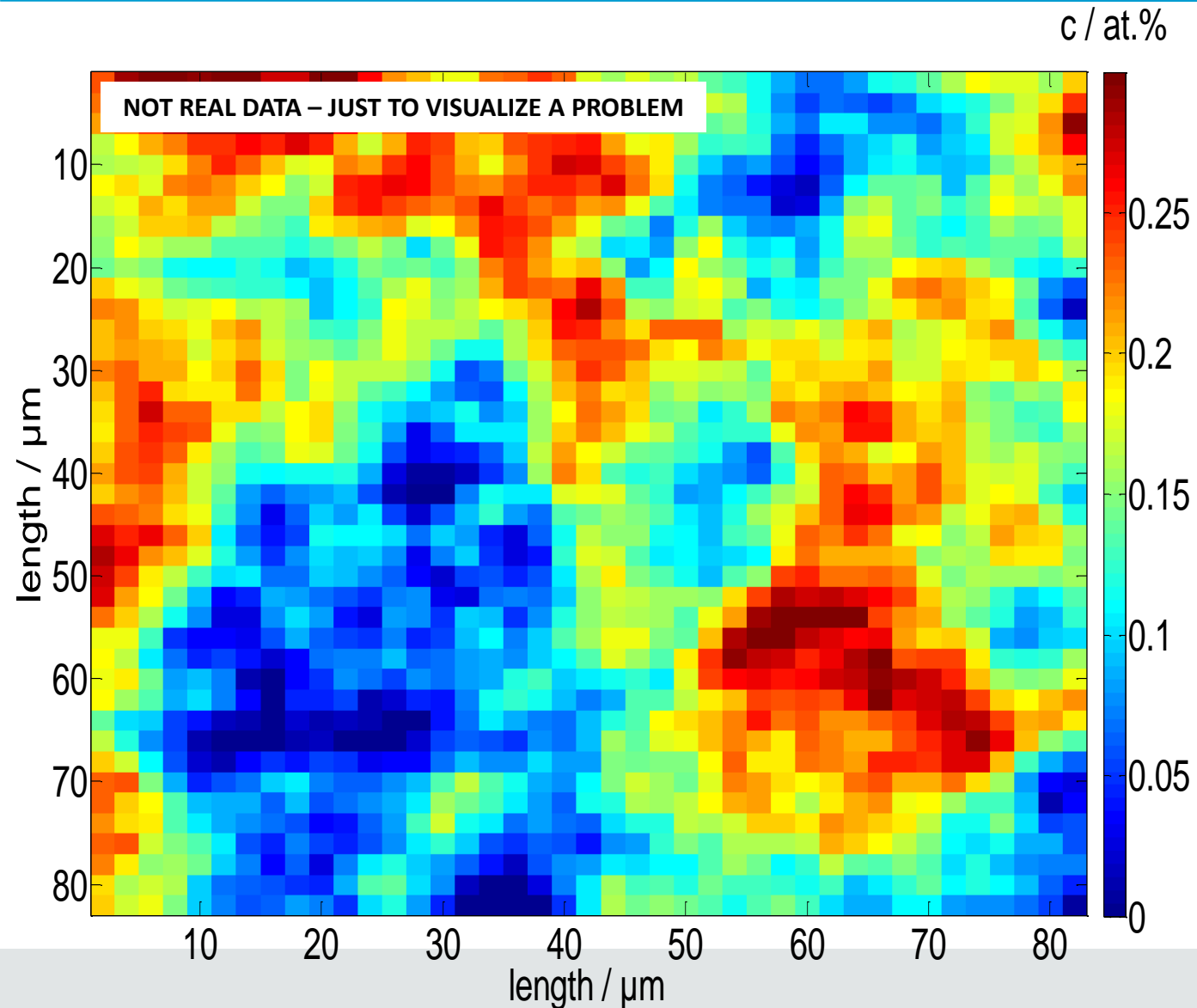
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- Lowest T_c equal to the max. at.% concentration at RT (≈ 0.33 at.%)
- Only locally saturated – not globally. If SIMS spot size \approx multiple grains, obtained c_o below saturation limit

Local Disorder: SIMS is too coarse

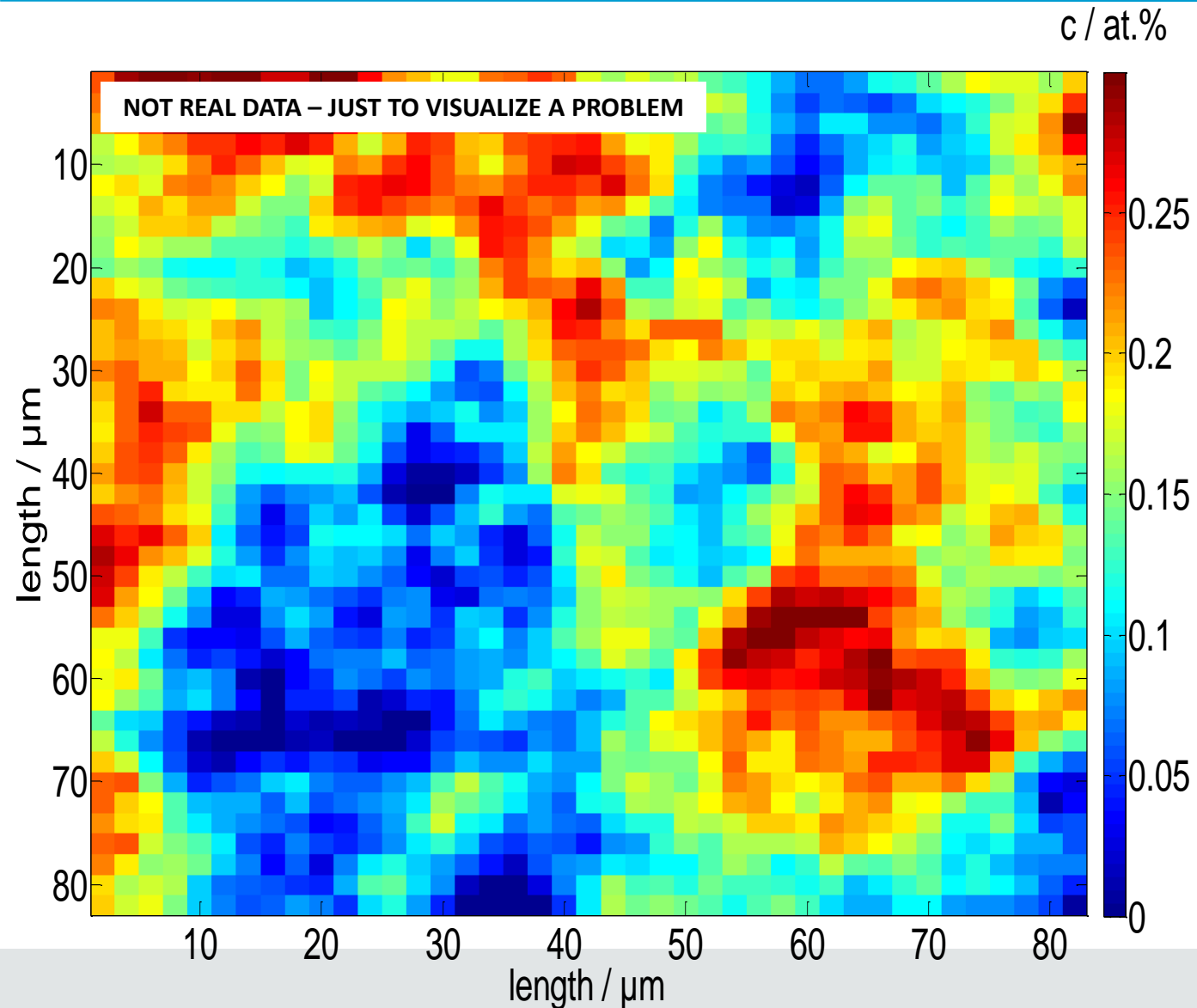
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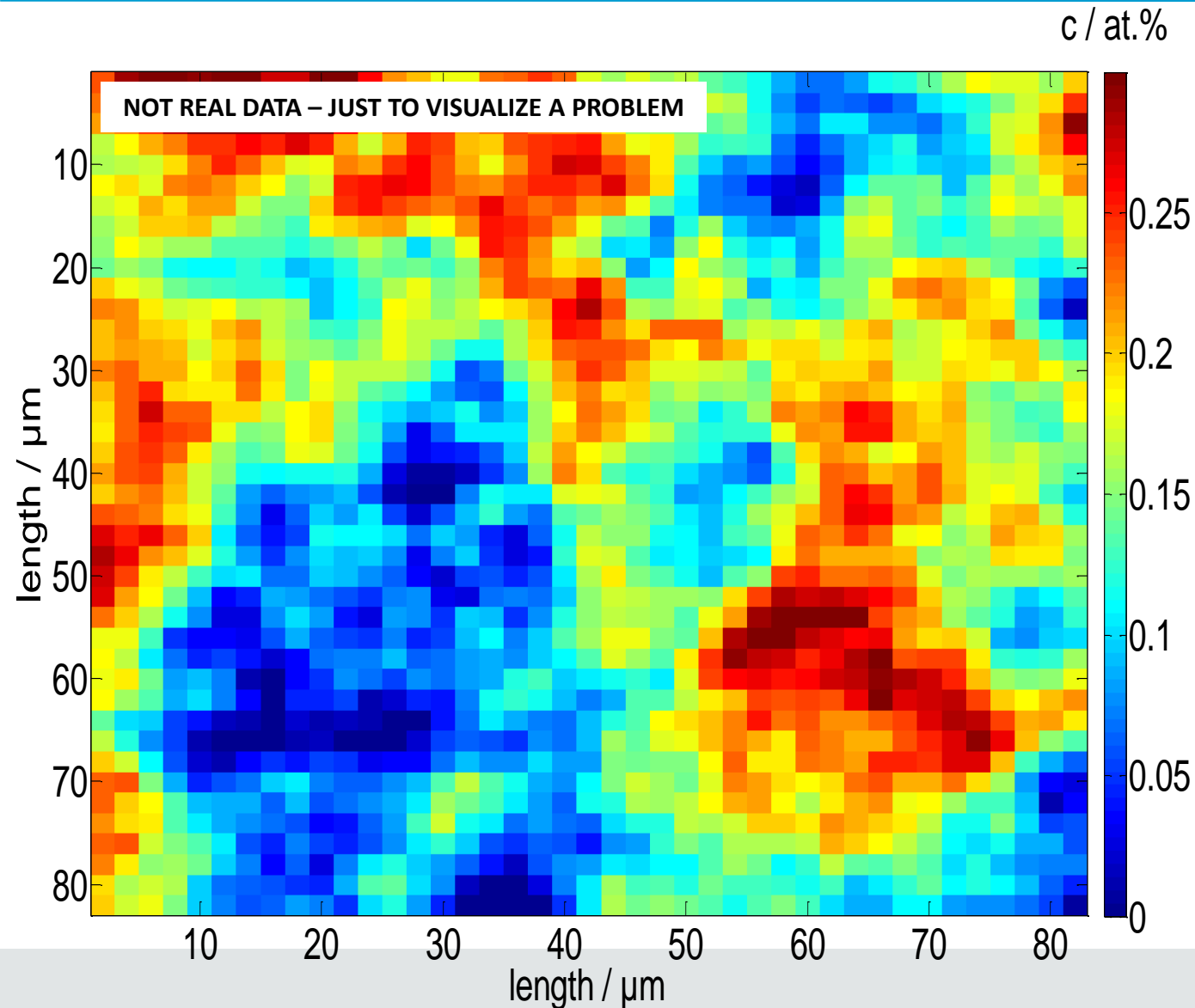
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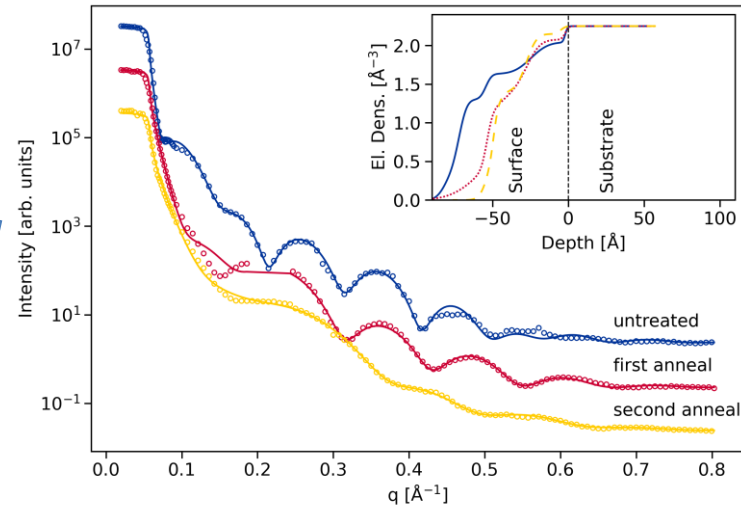
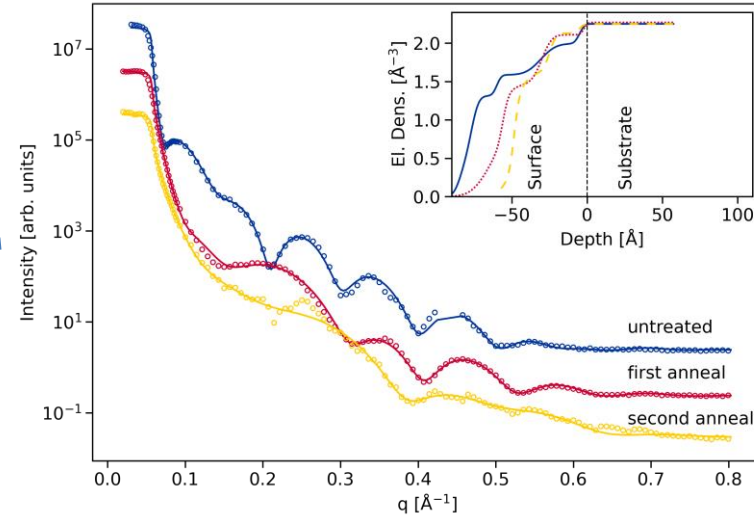
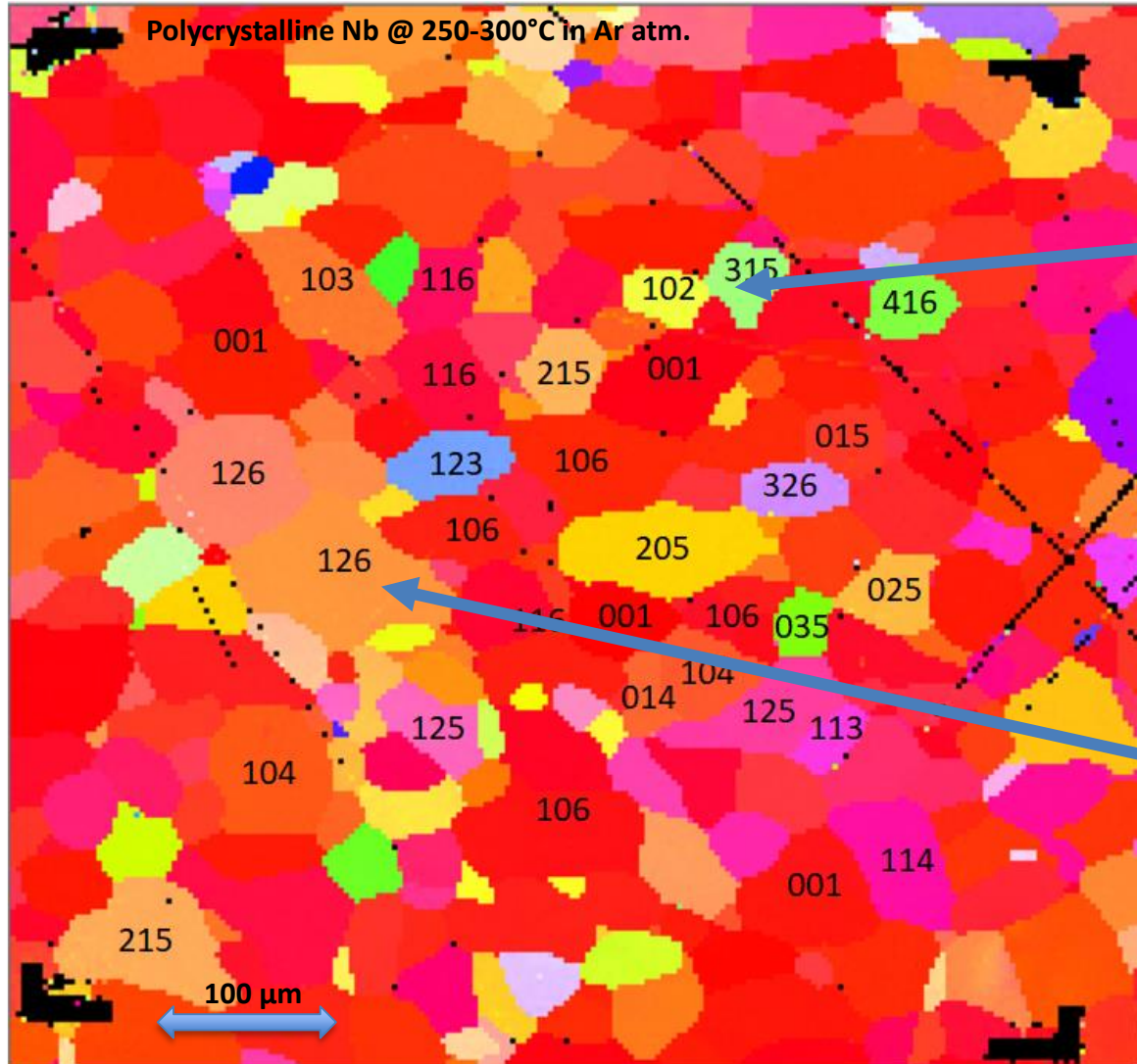
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- Need for better spatial and chemical resolution
→ „Grain Mapping“

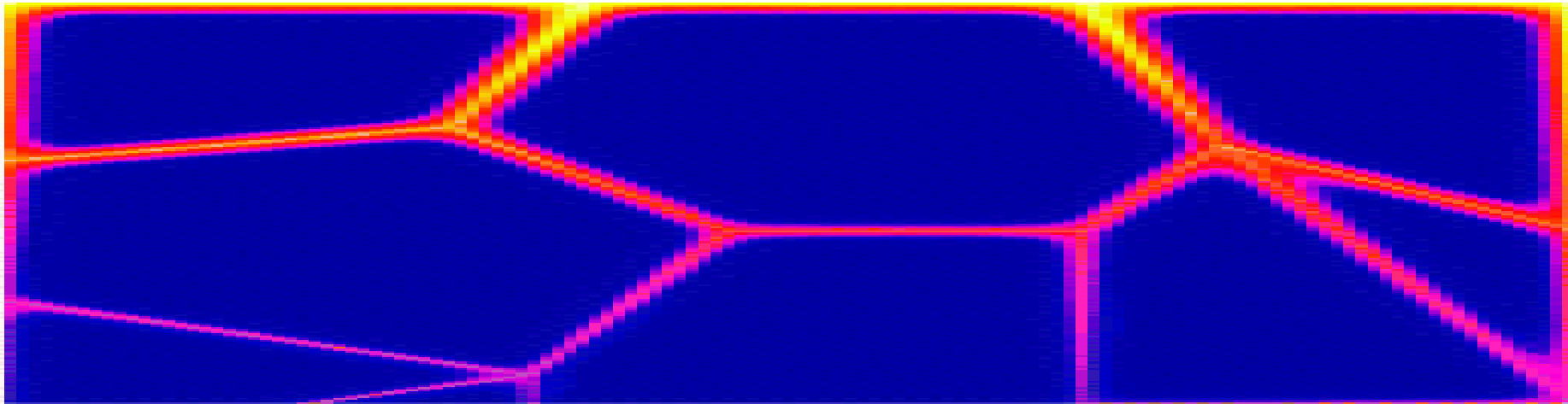
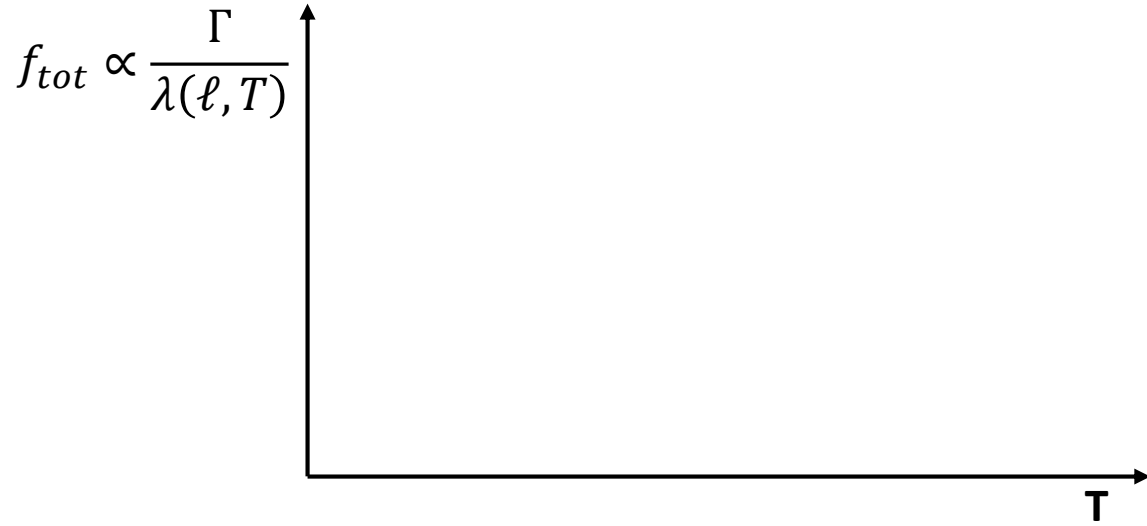
Grain observation under heat treatment with XRR



To be published

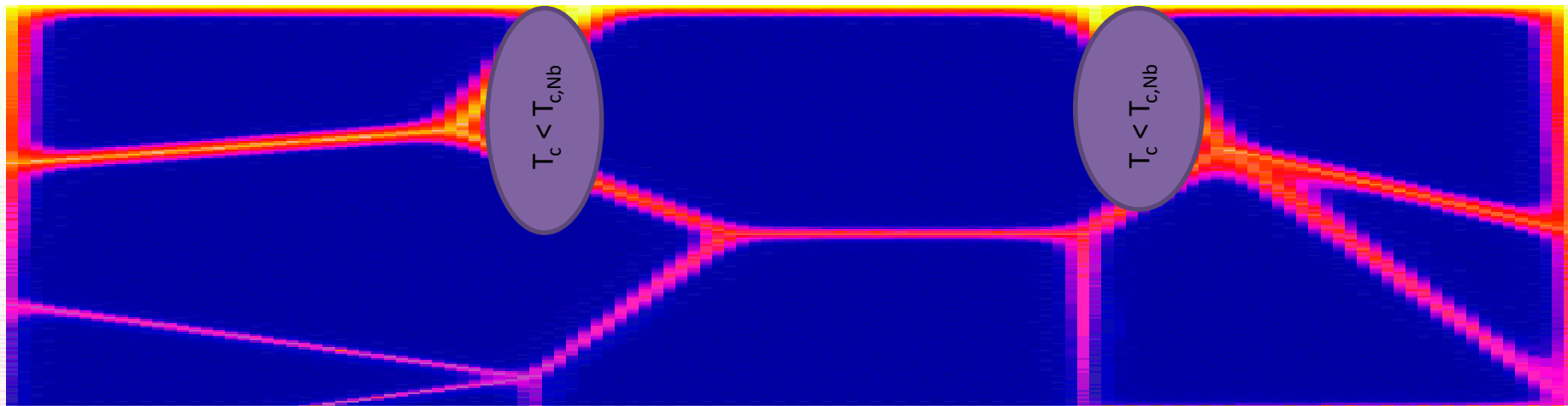
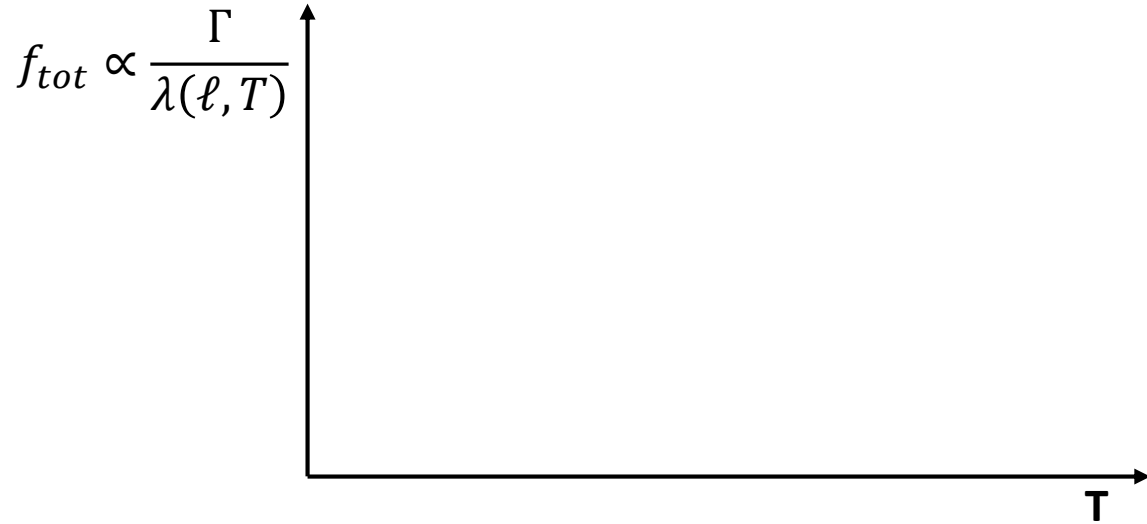
Disordered superconductor show dip

[Barra, M., et al. *SUST* 18.3 (2005): 271.]



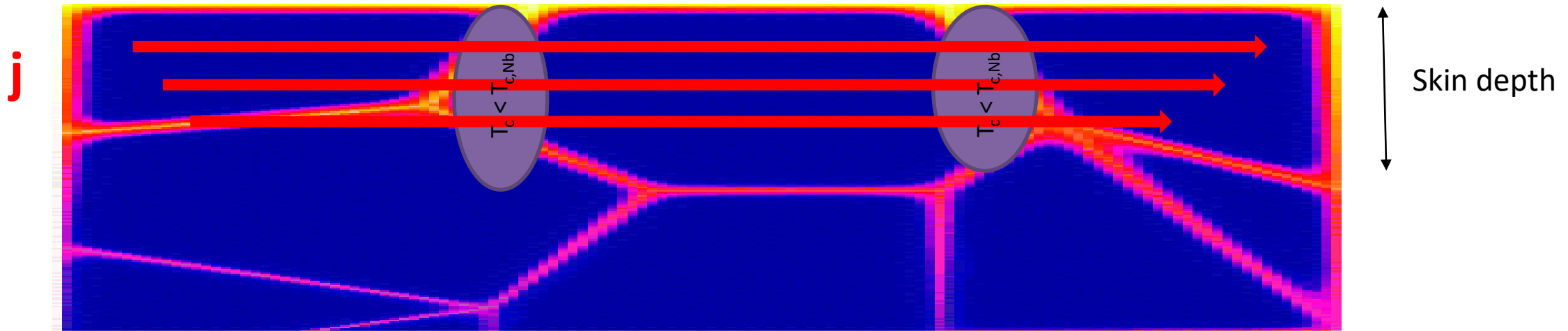
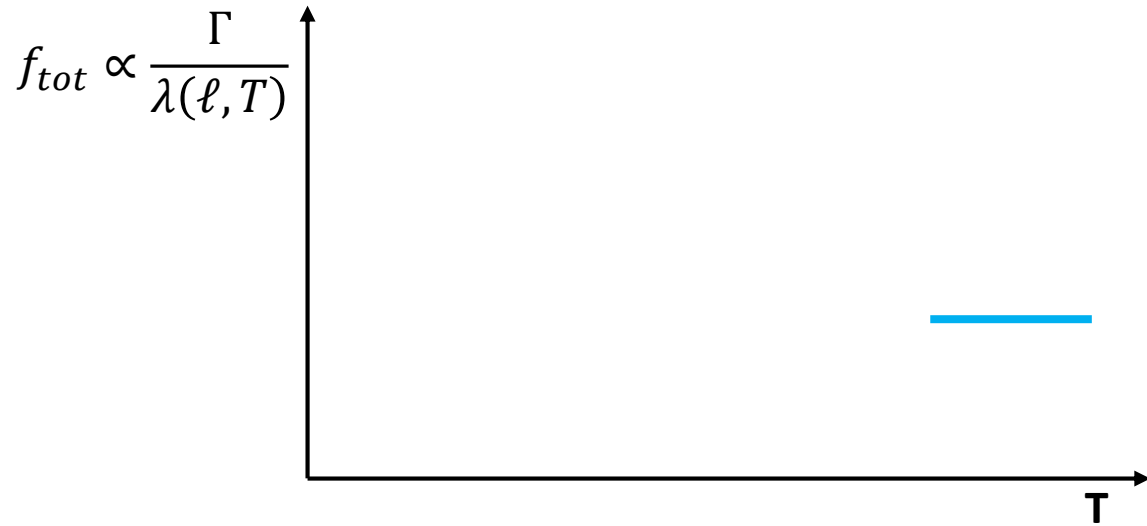
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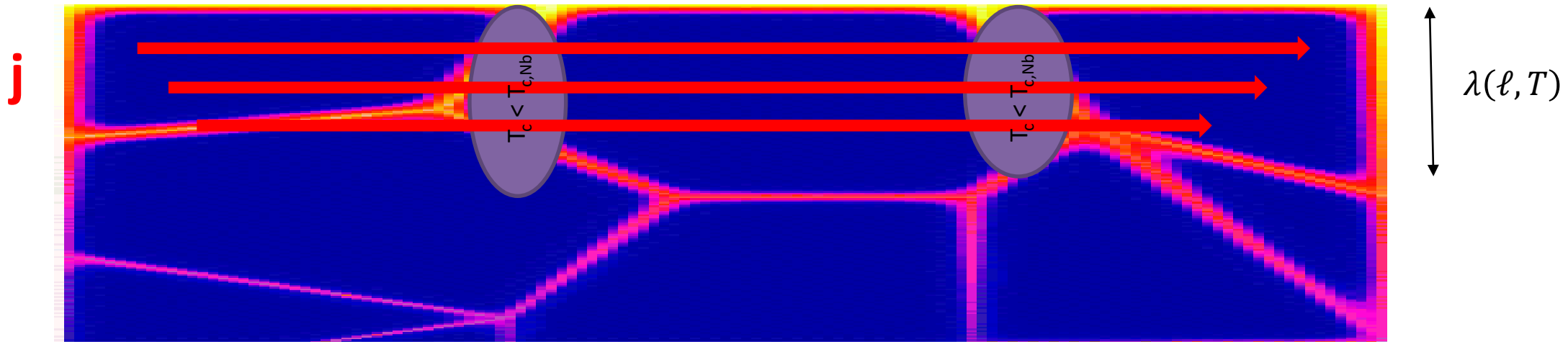
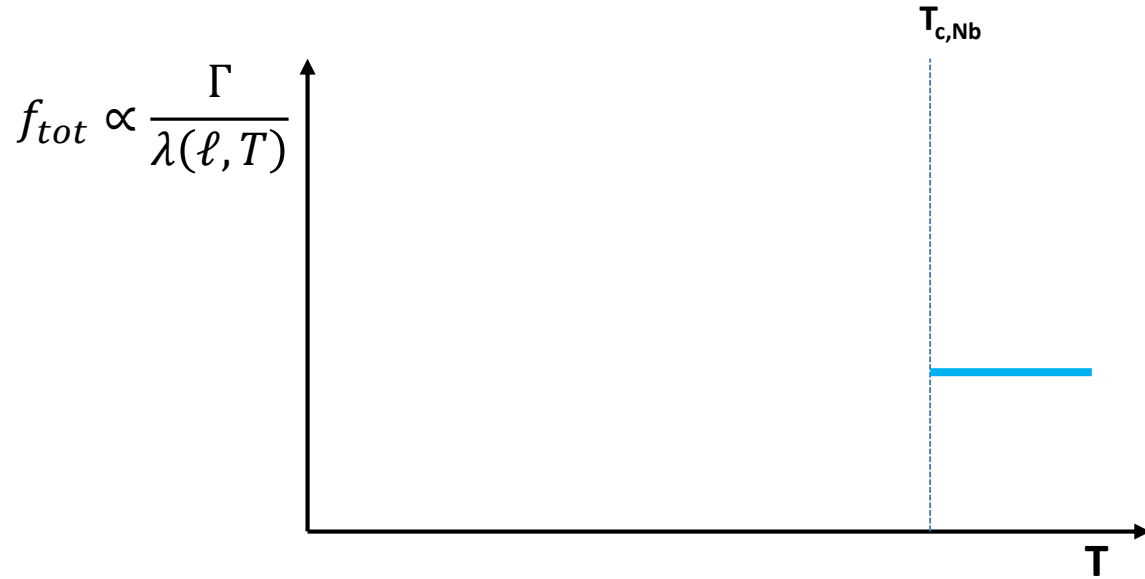
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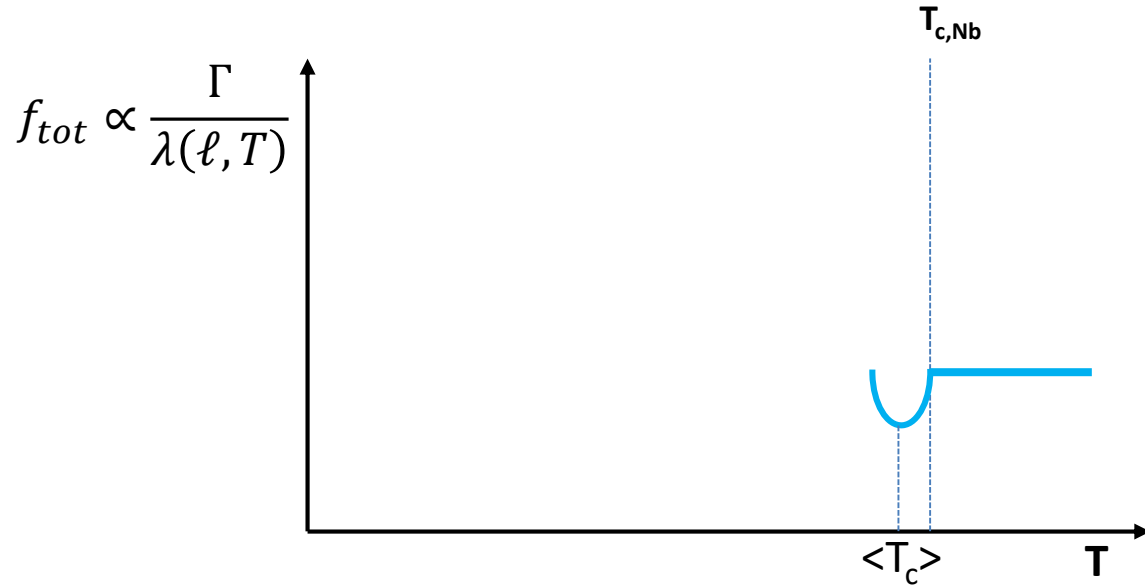
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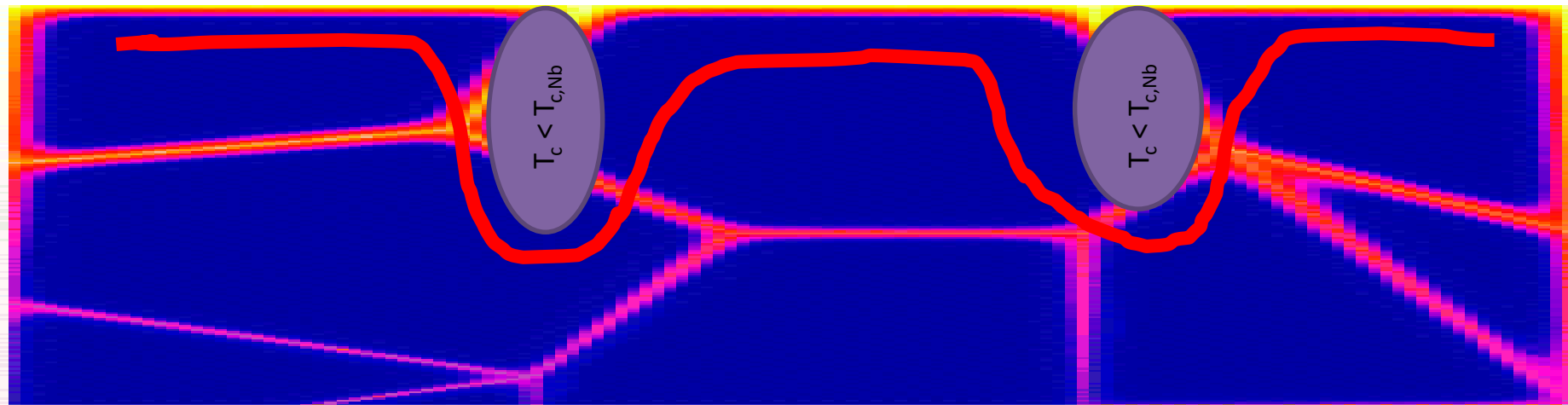


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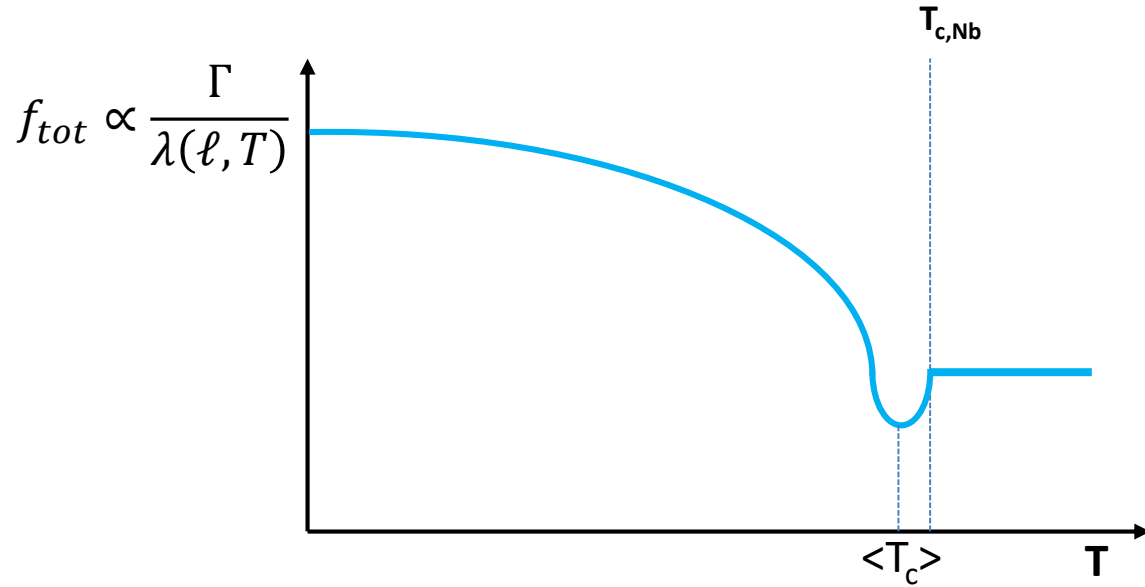
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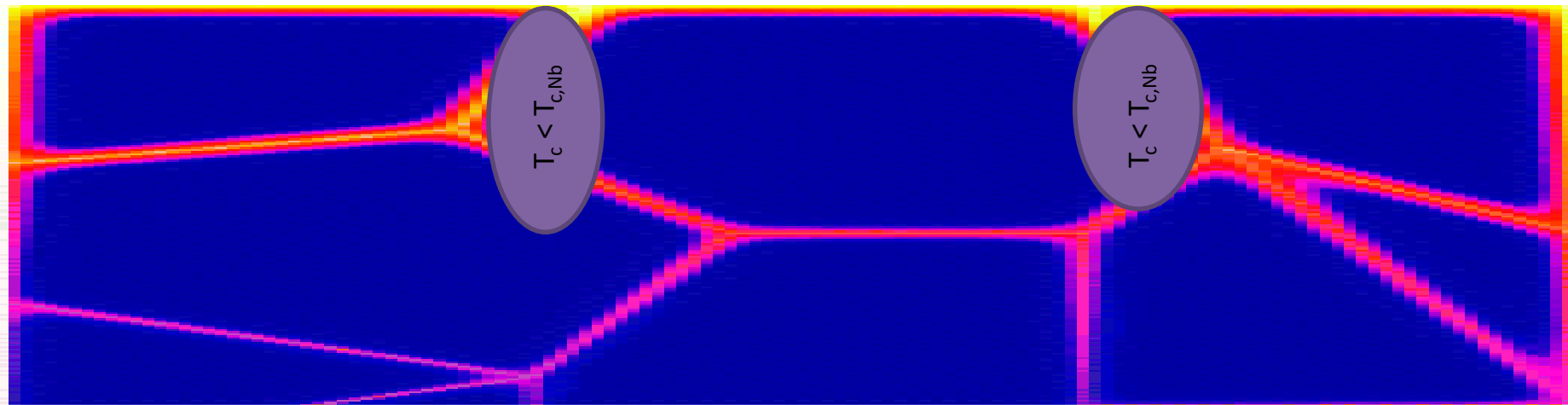
$\lambda(\ell, T)$

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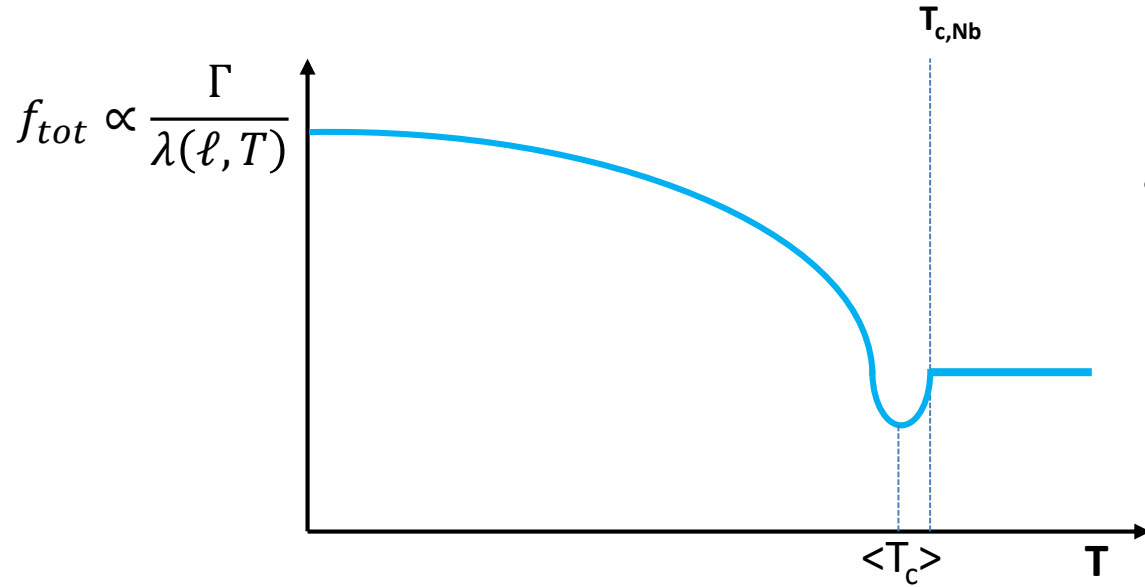
j



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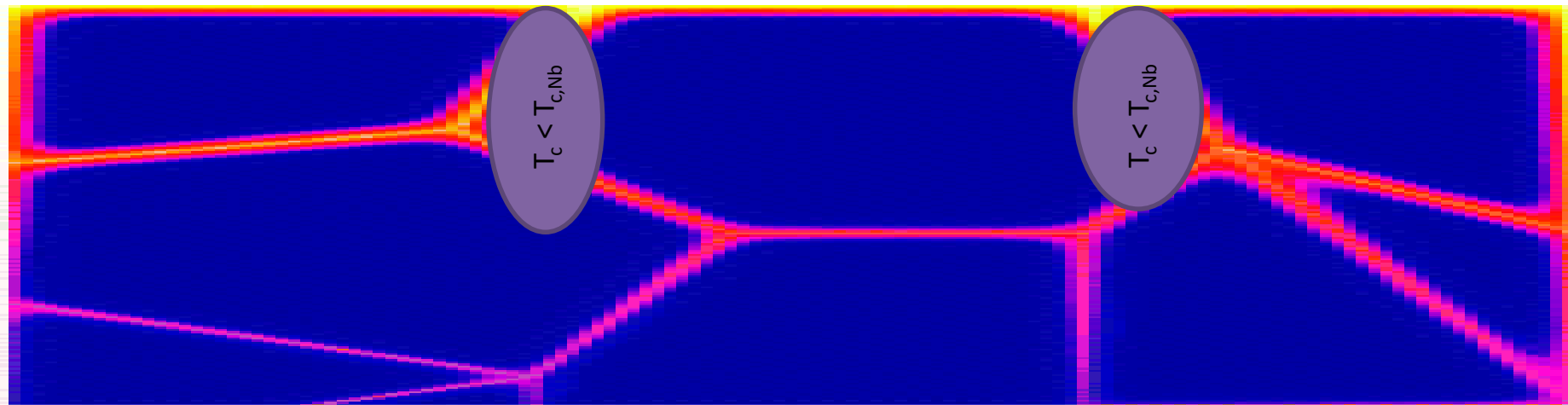
Disordered superconductor show dip

[Barra, M., et al. *SUST* 18.3 (2005): 271.]



- Mathematically speaking, the geometry constant Γ is not constant

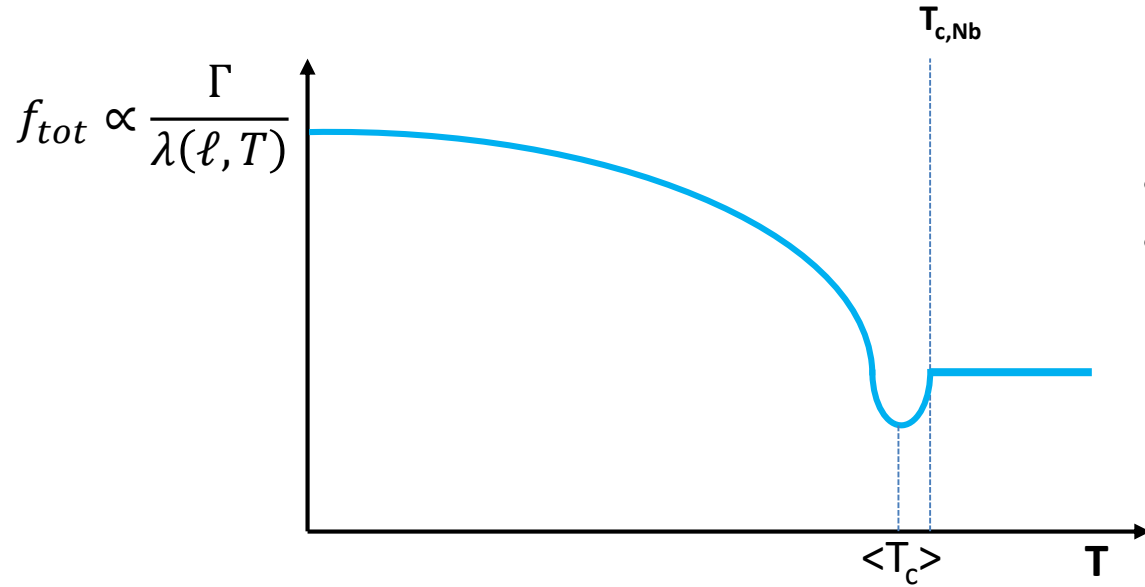
j



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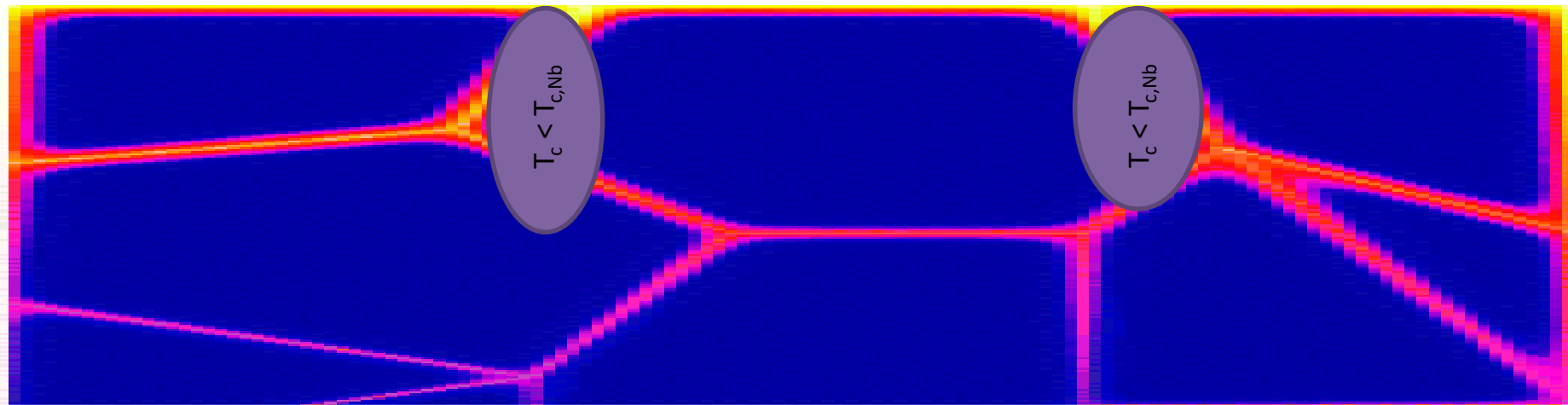
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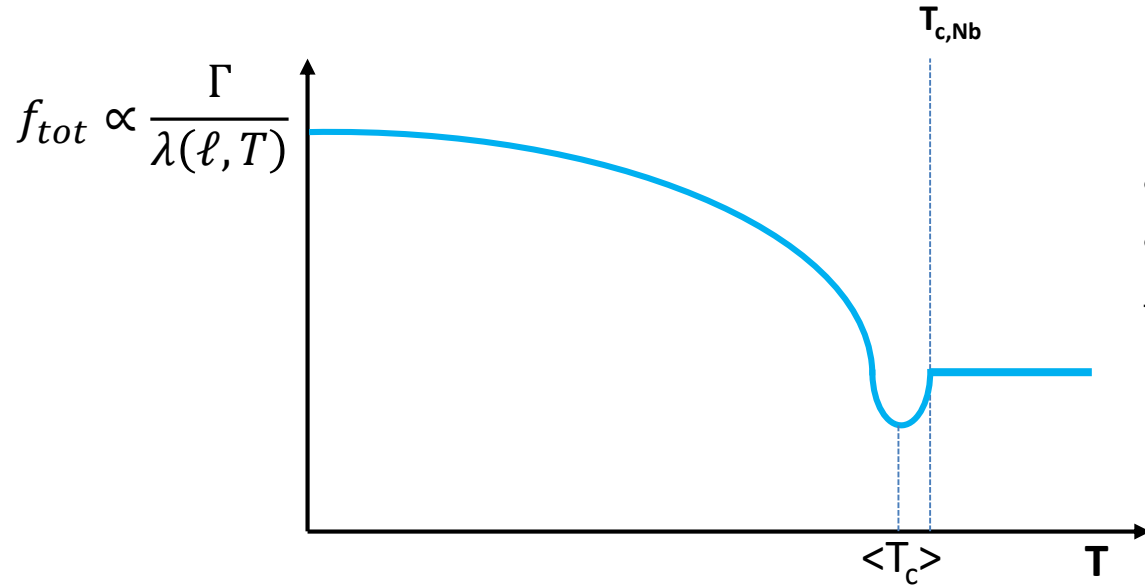
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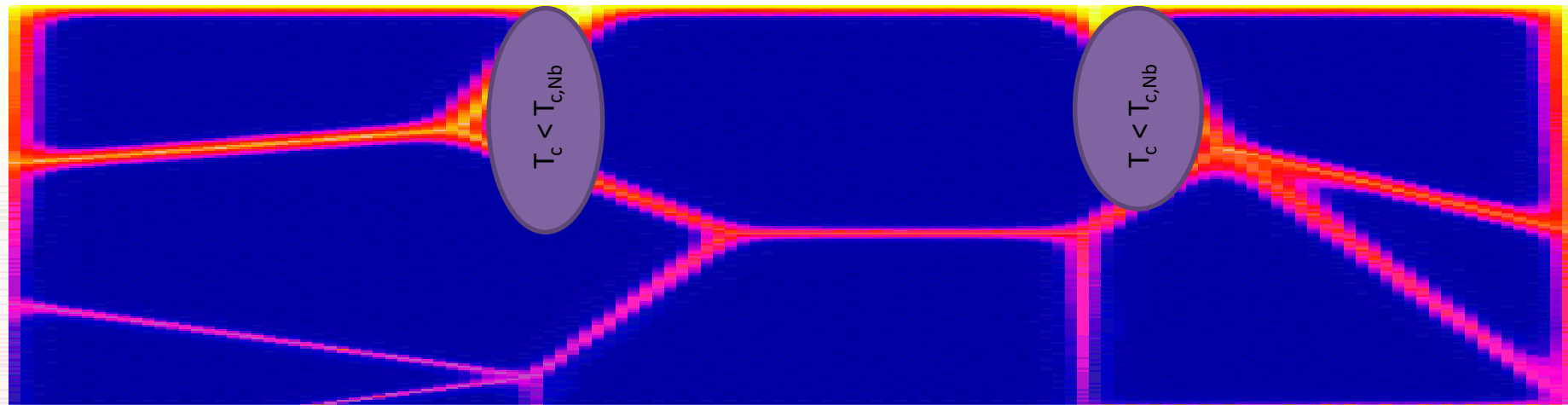
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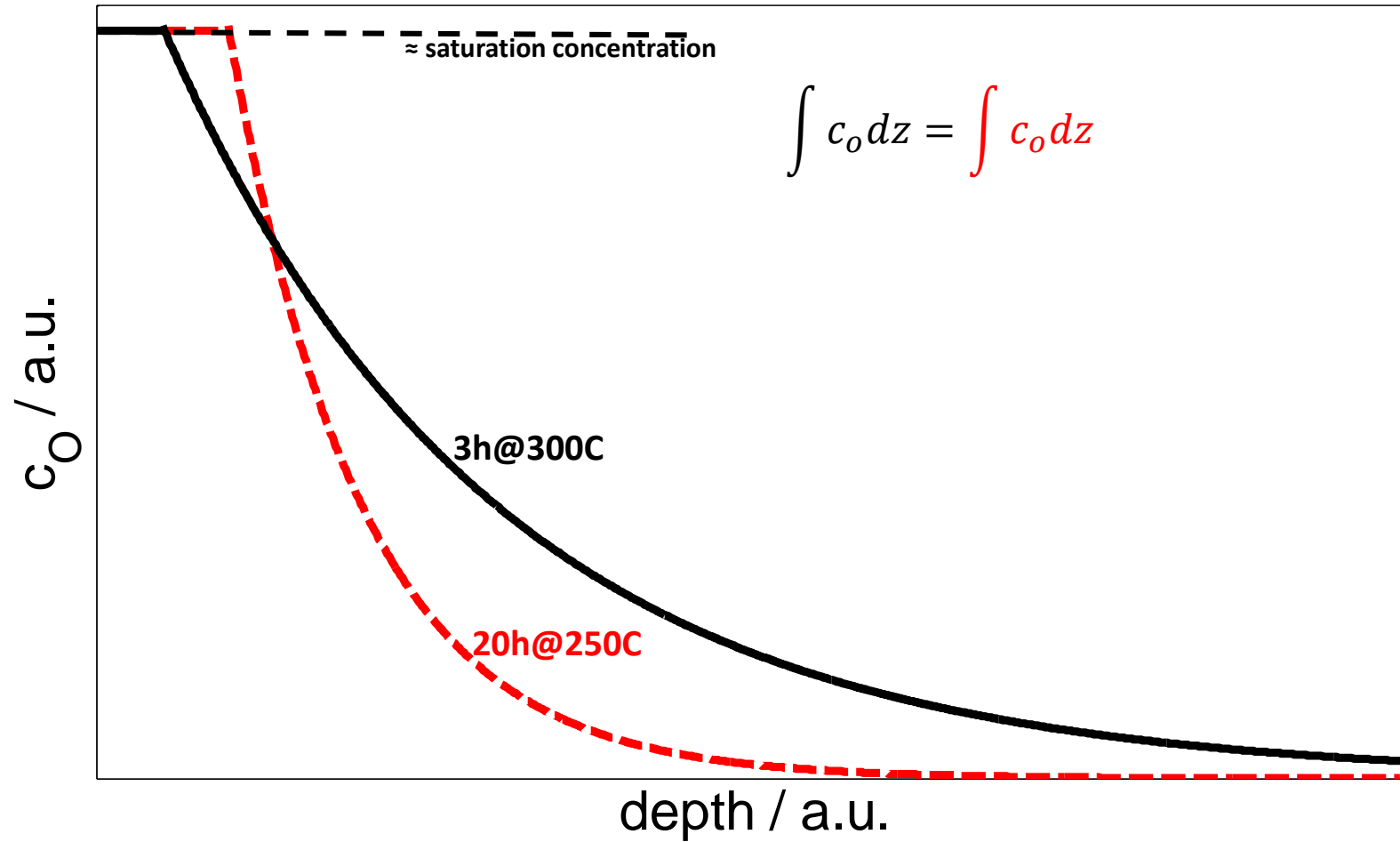
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→ Dip caused by clusters and not homogenous O-enriched Nb-layer

j

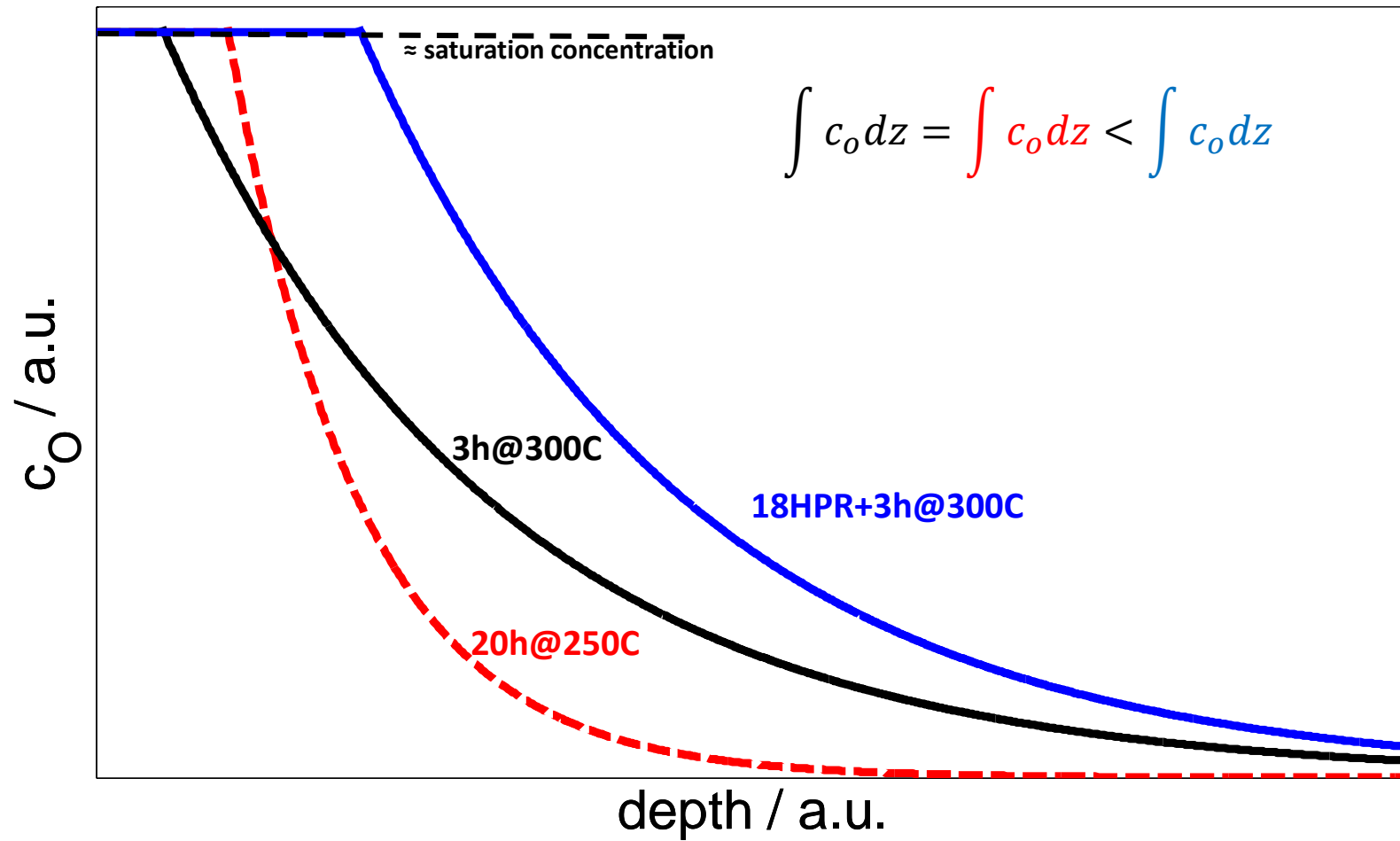


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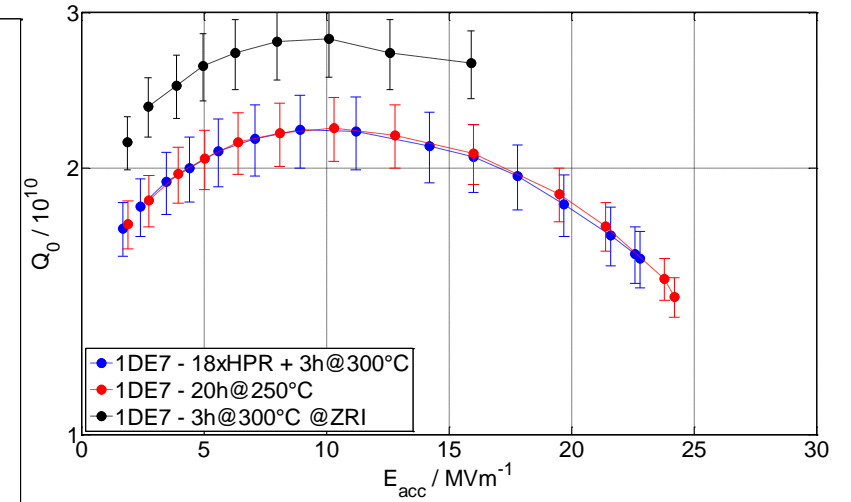
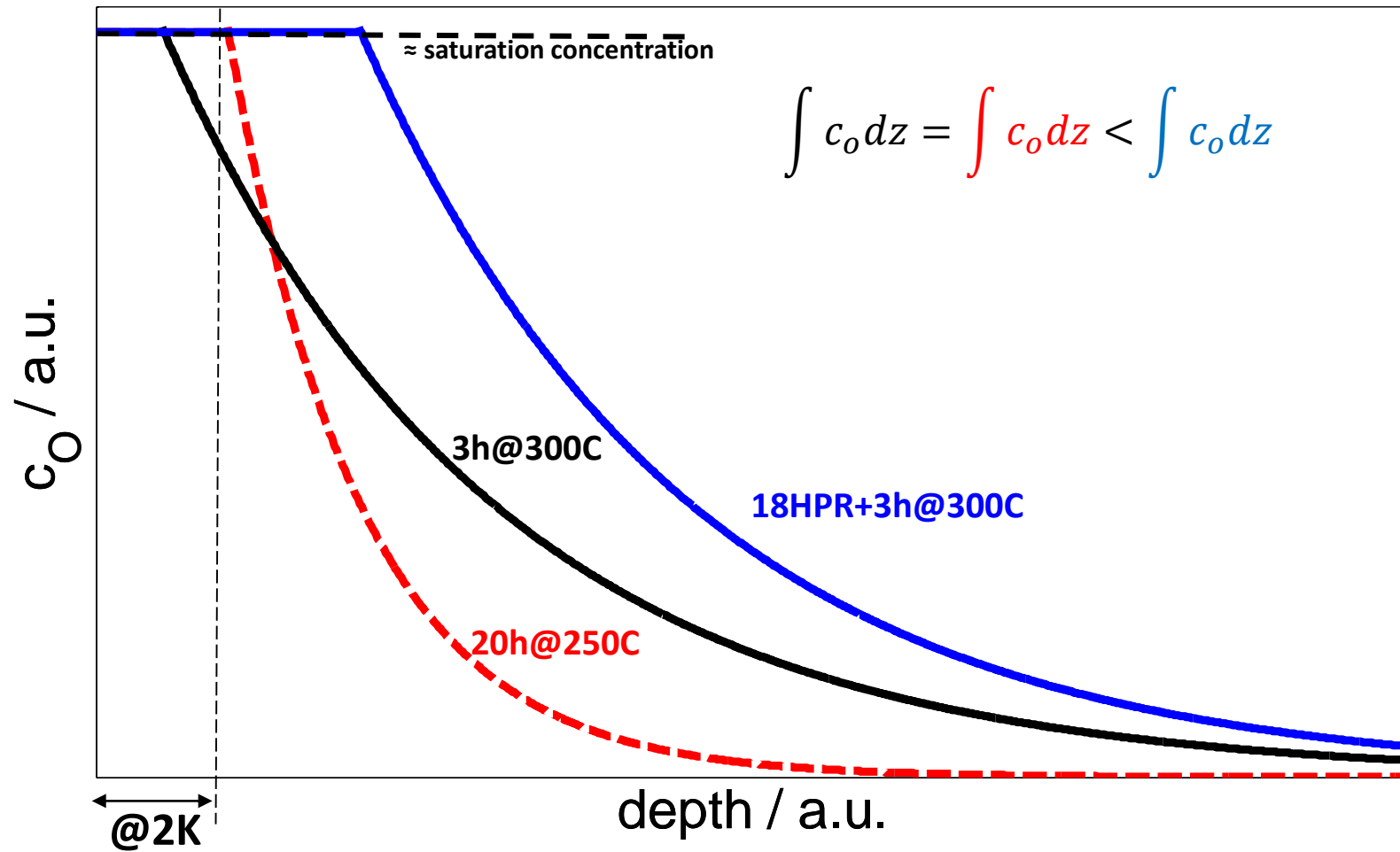
If it acts the same – is it the same?



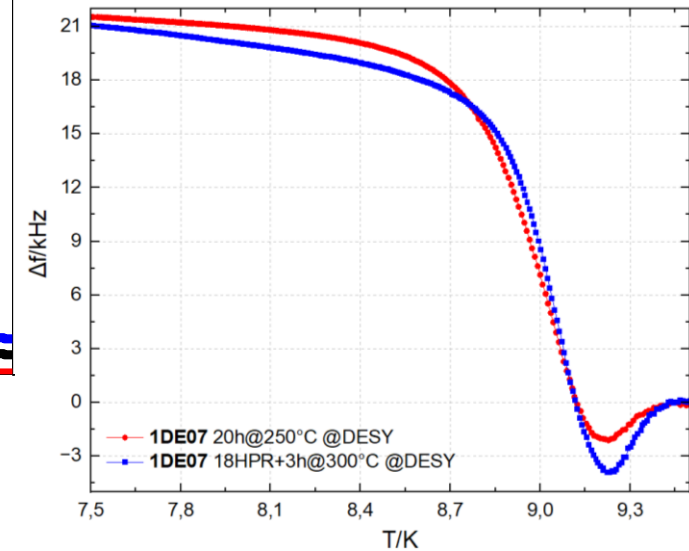
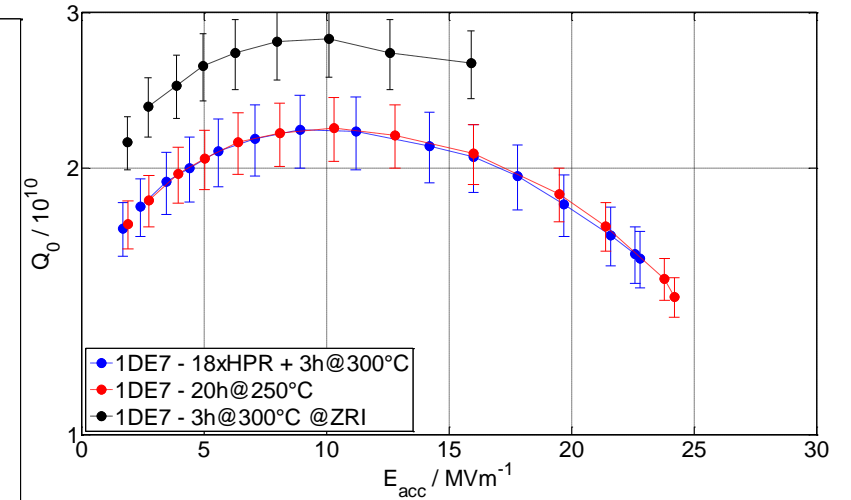
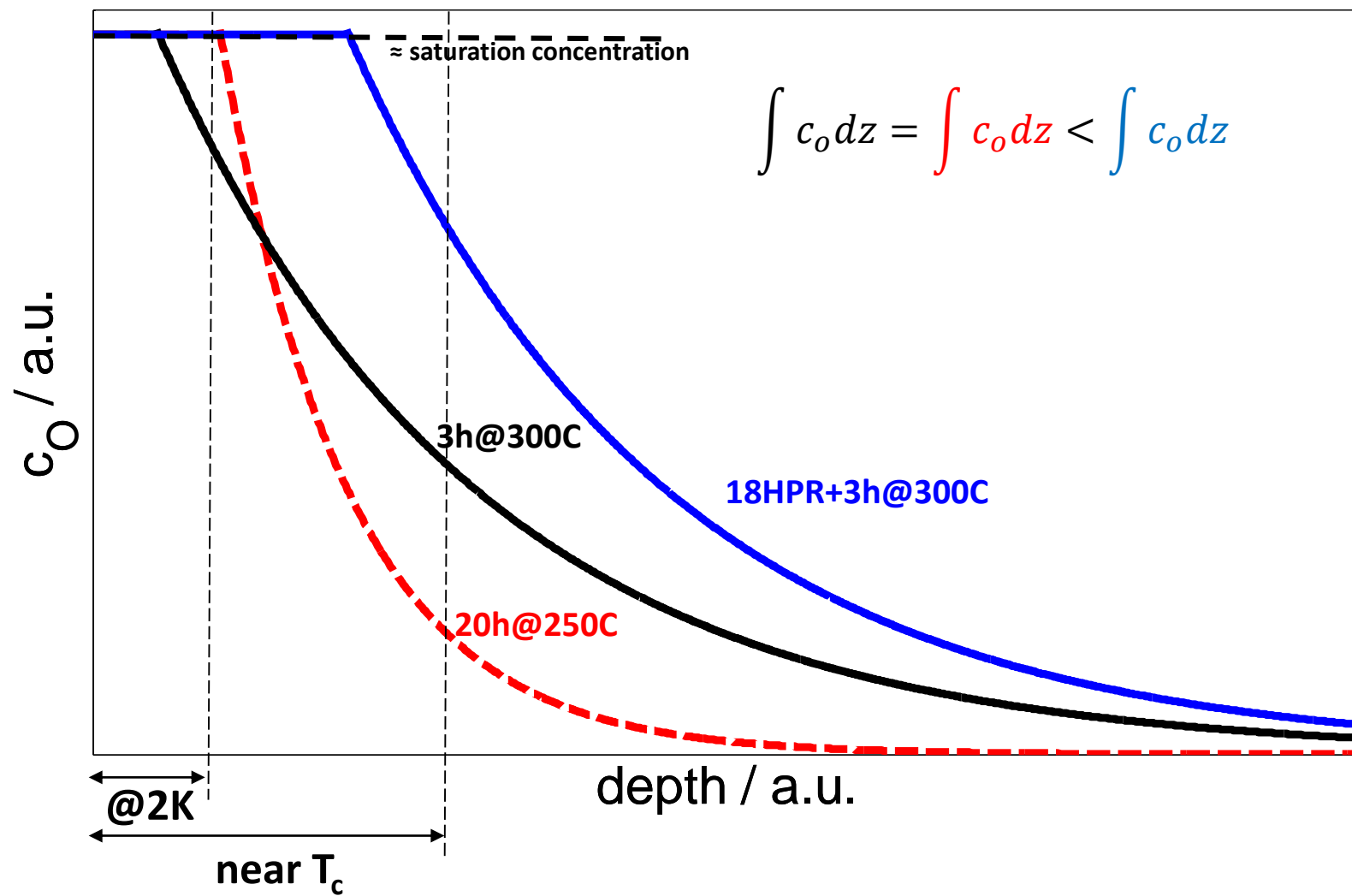
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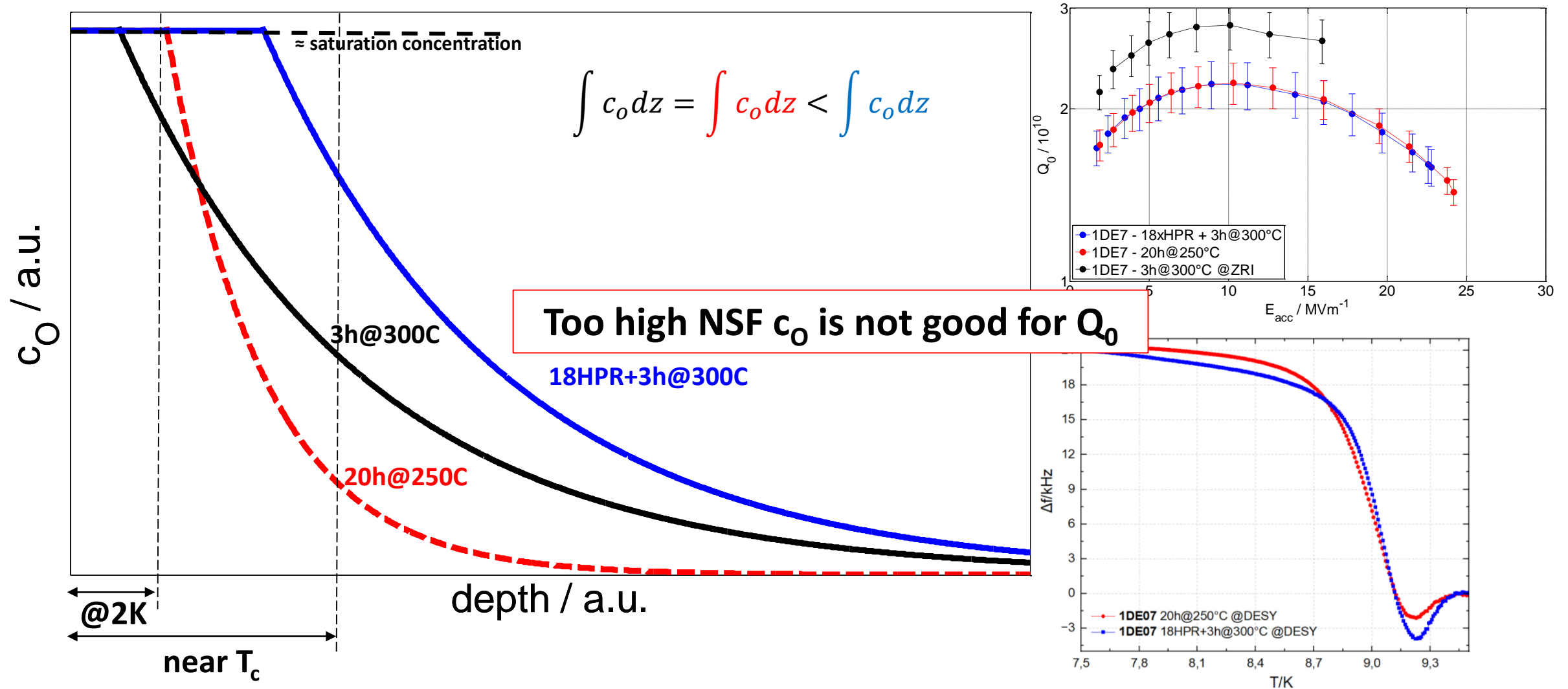
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3h@300°C ≠ 3h@300°C

[Wenskat, M., et al SRF2023 TUIBA02.]

[Wenskat, M., et al Supercond. Sci. Technol. 36 (2023) 015010 (11pp).]

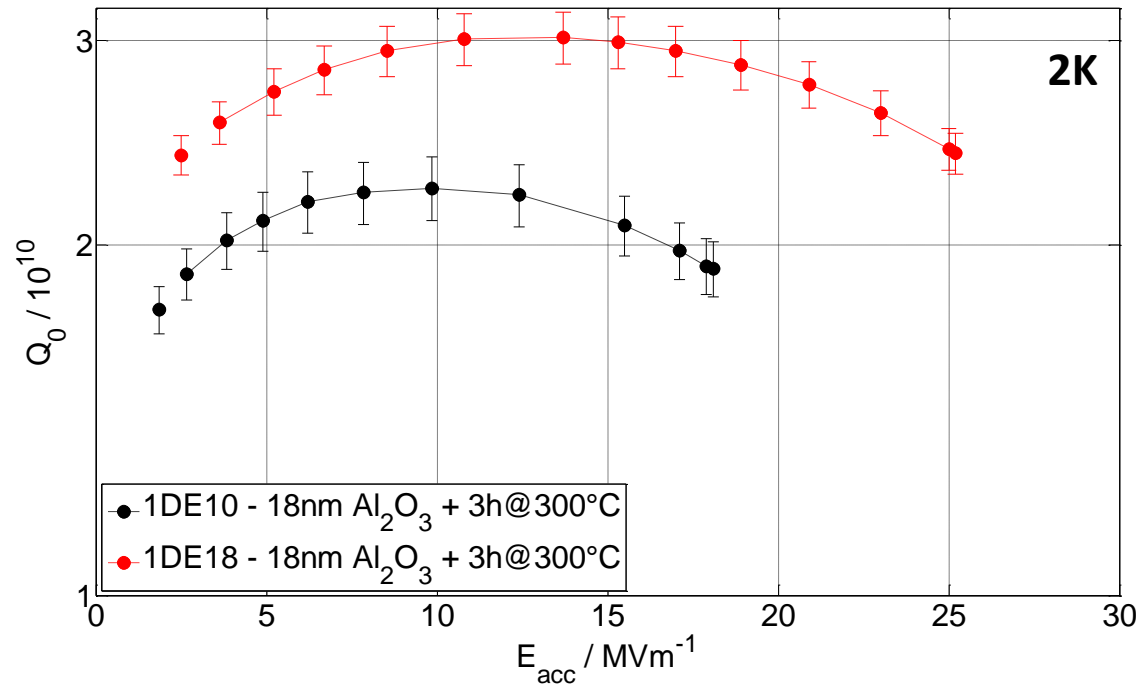
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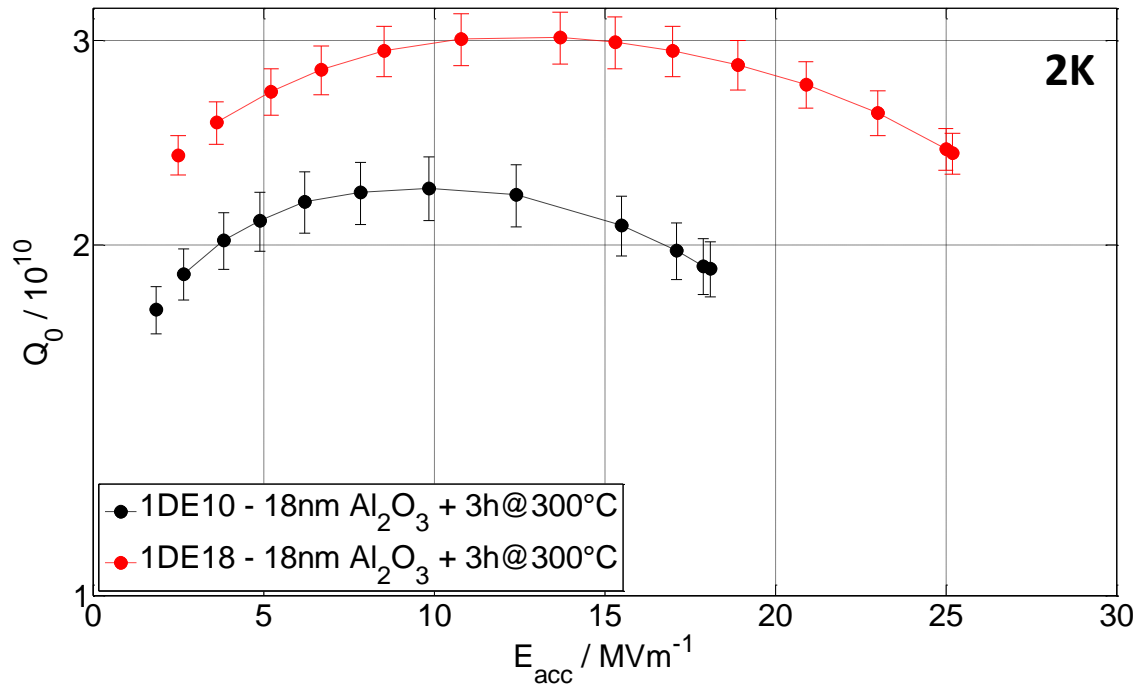


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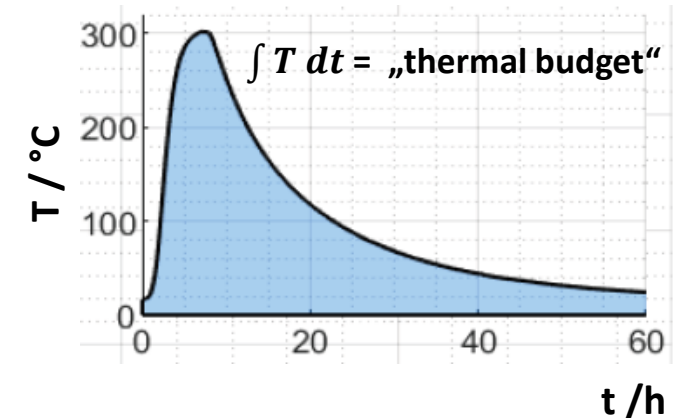
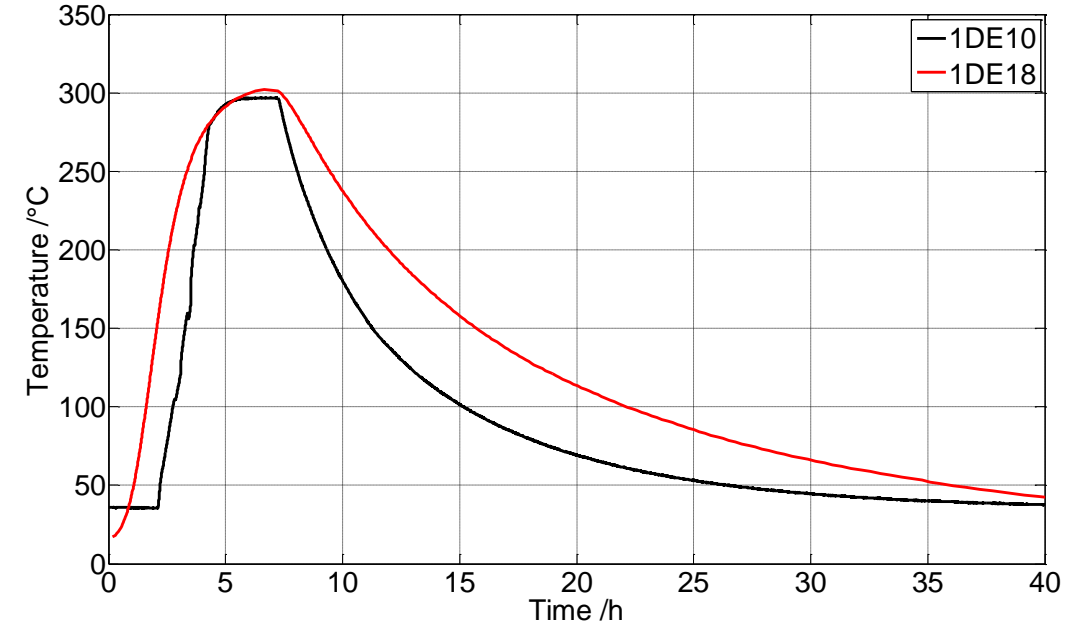
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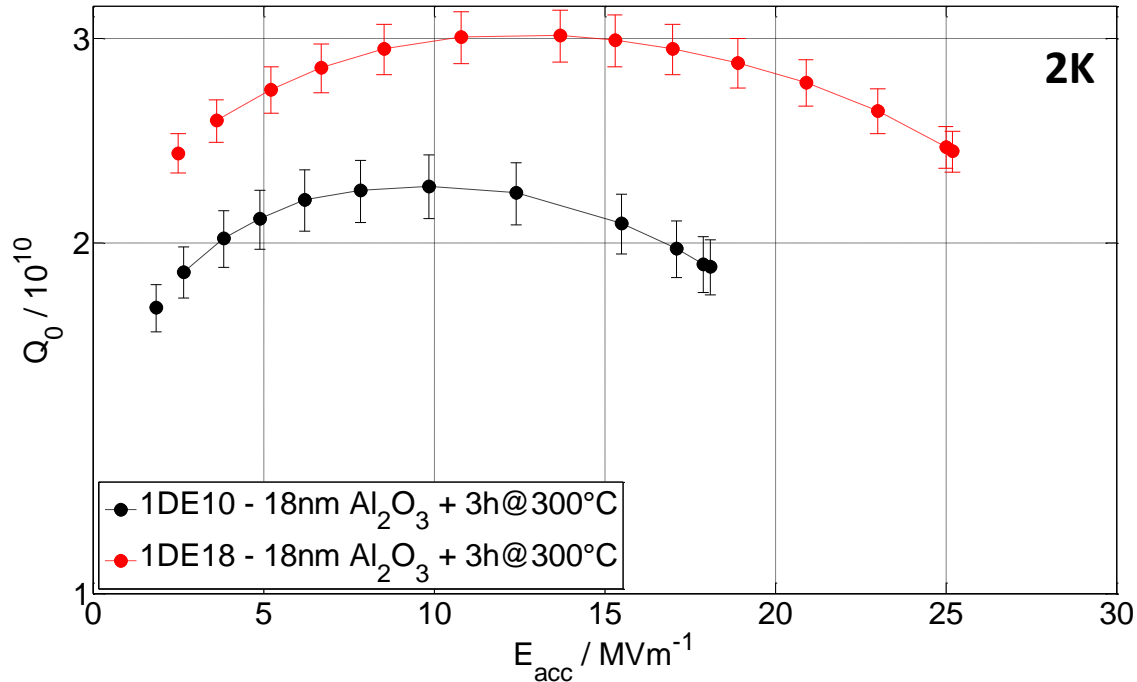


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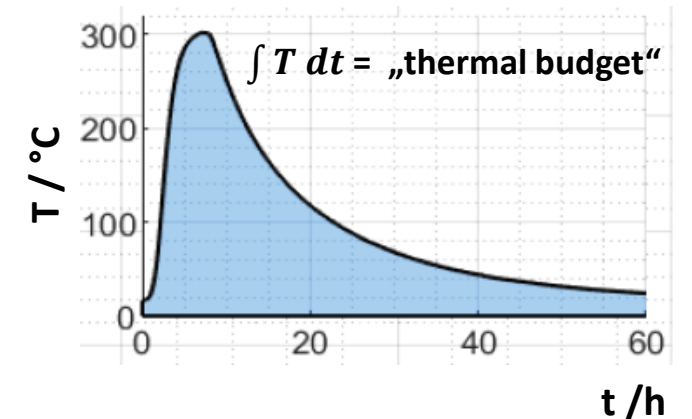
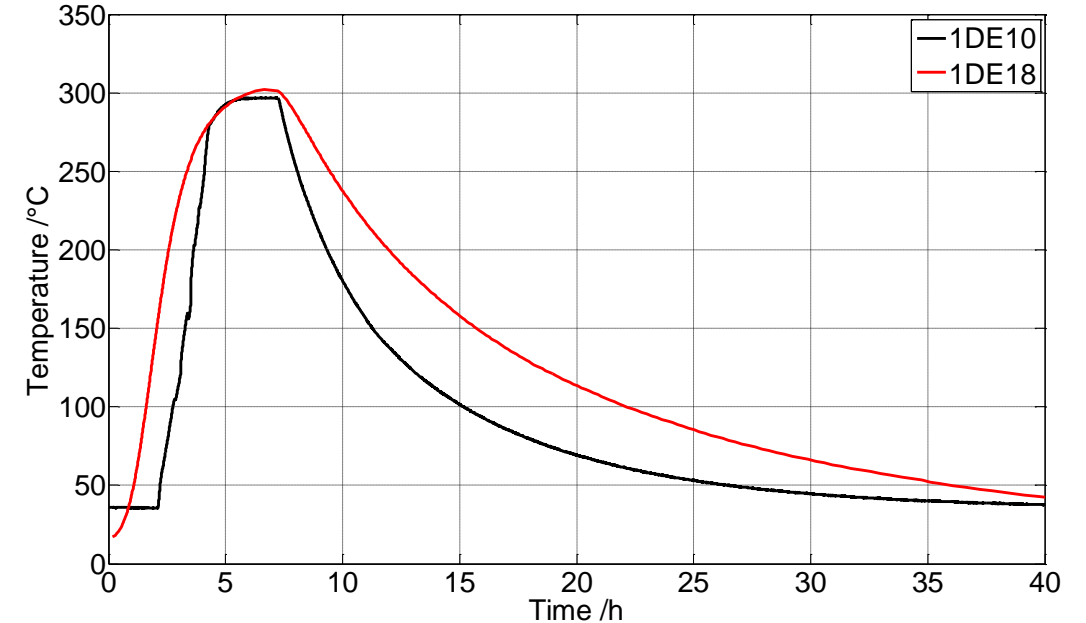
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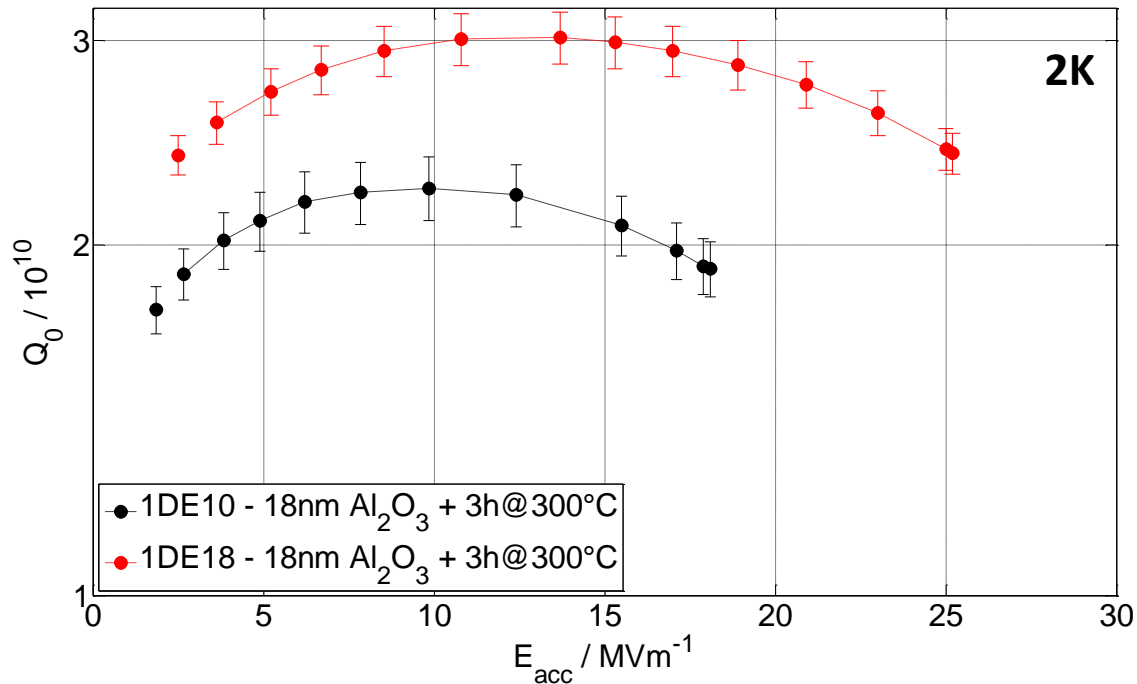


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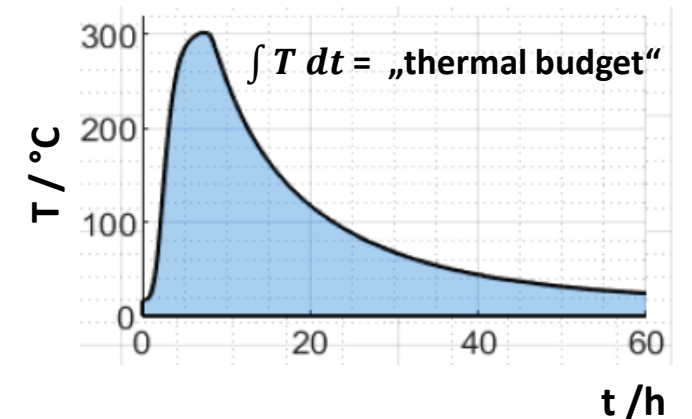
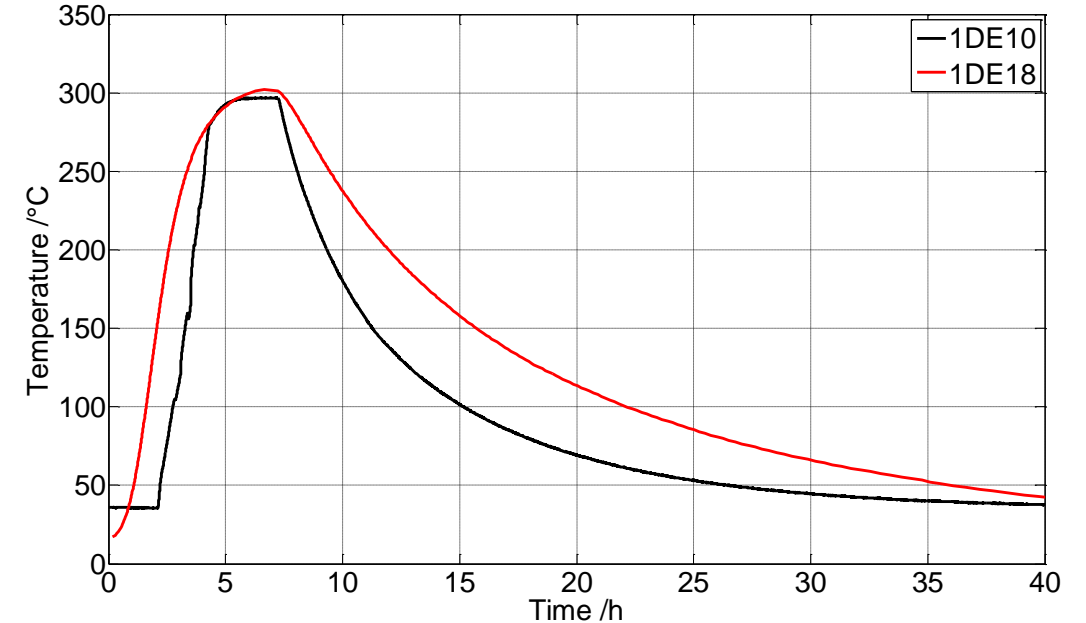
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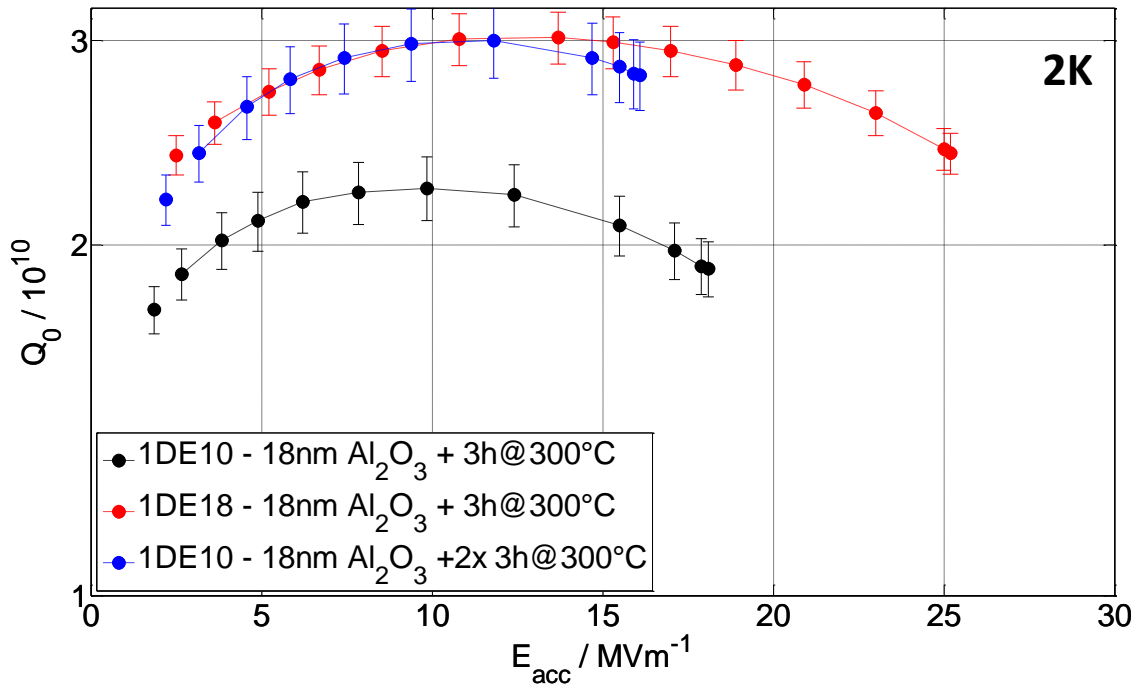


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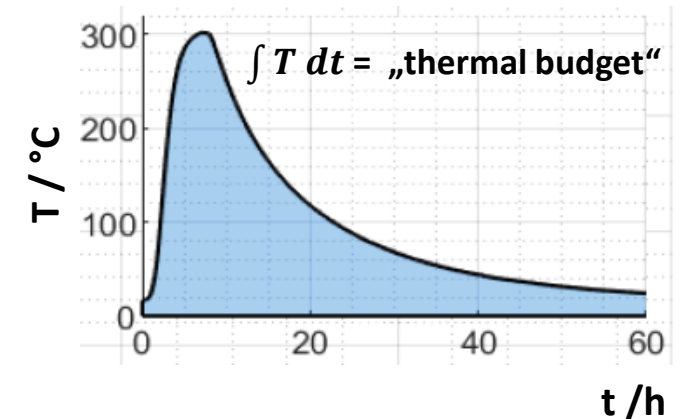
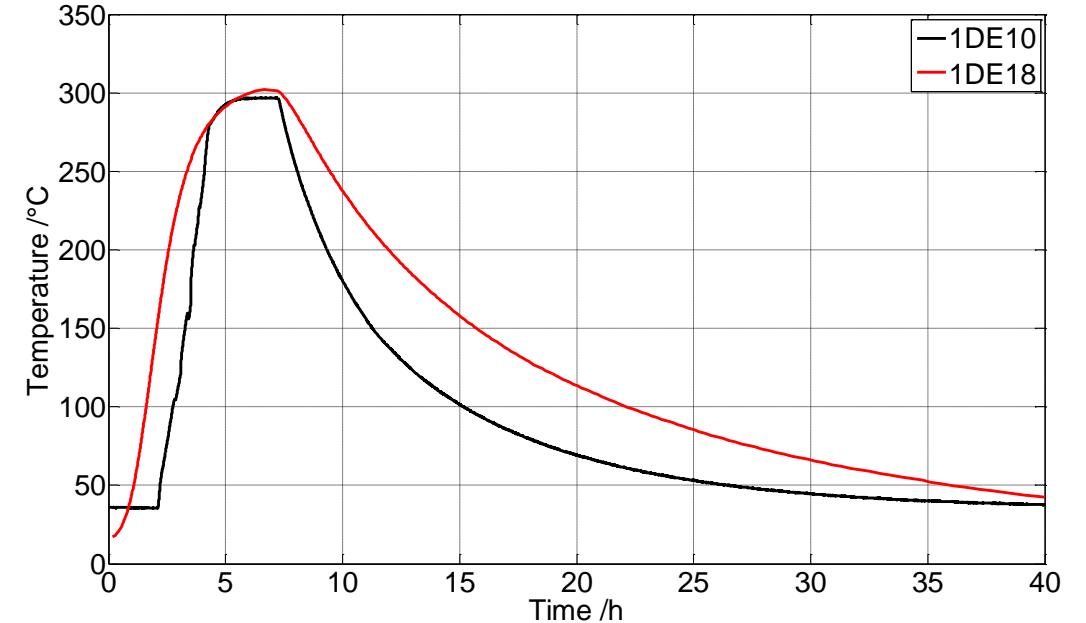
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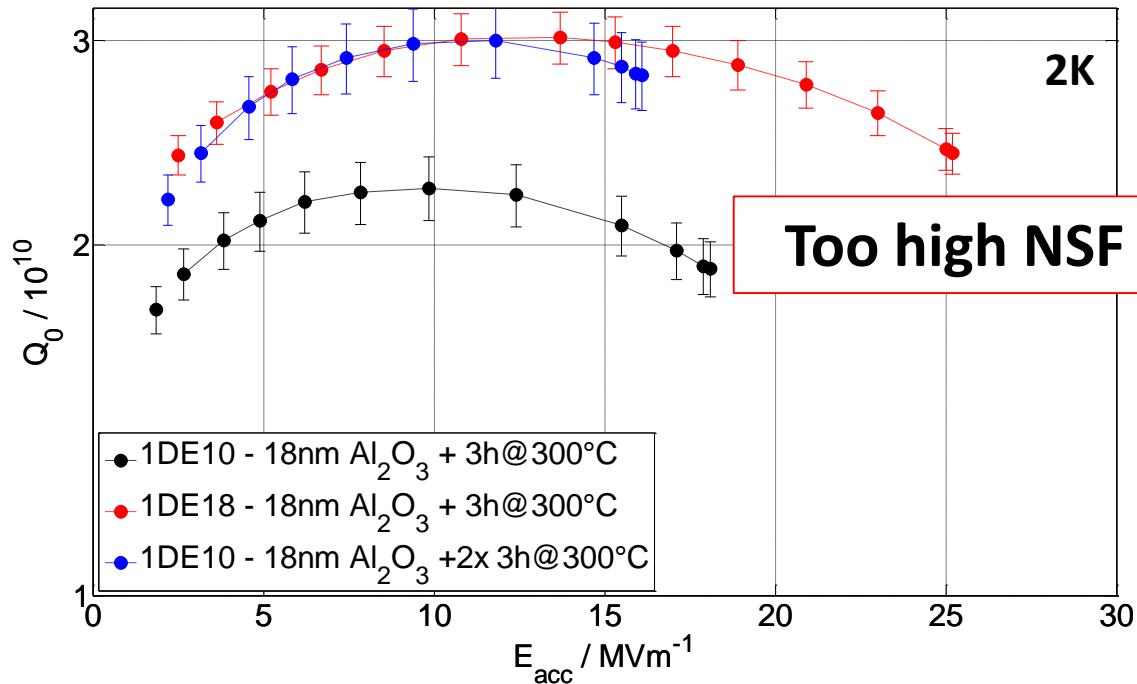


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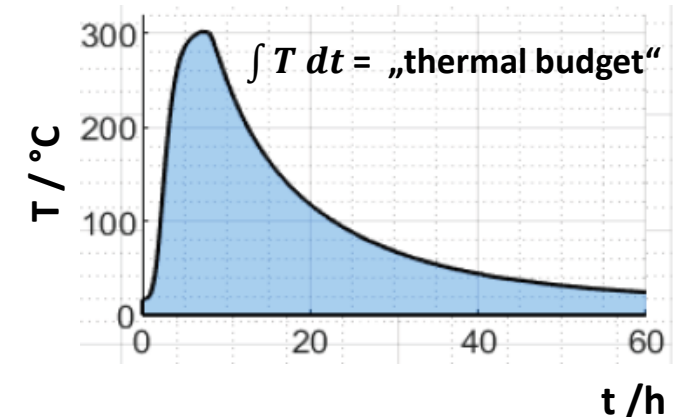
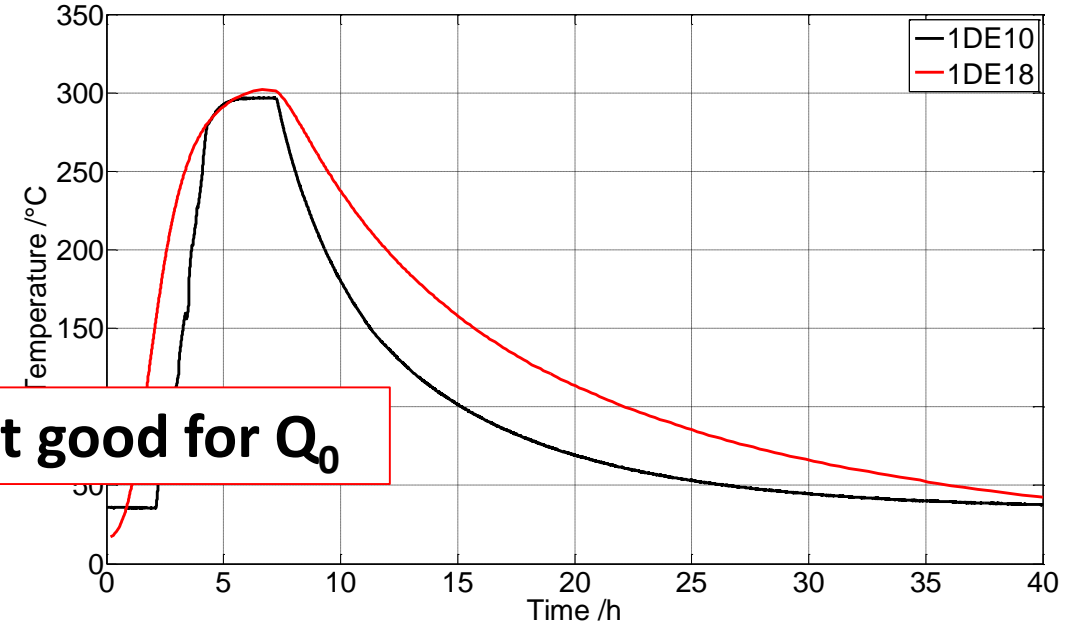
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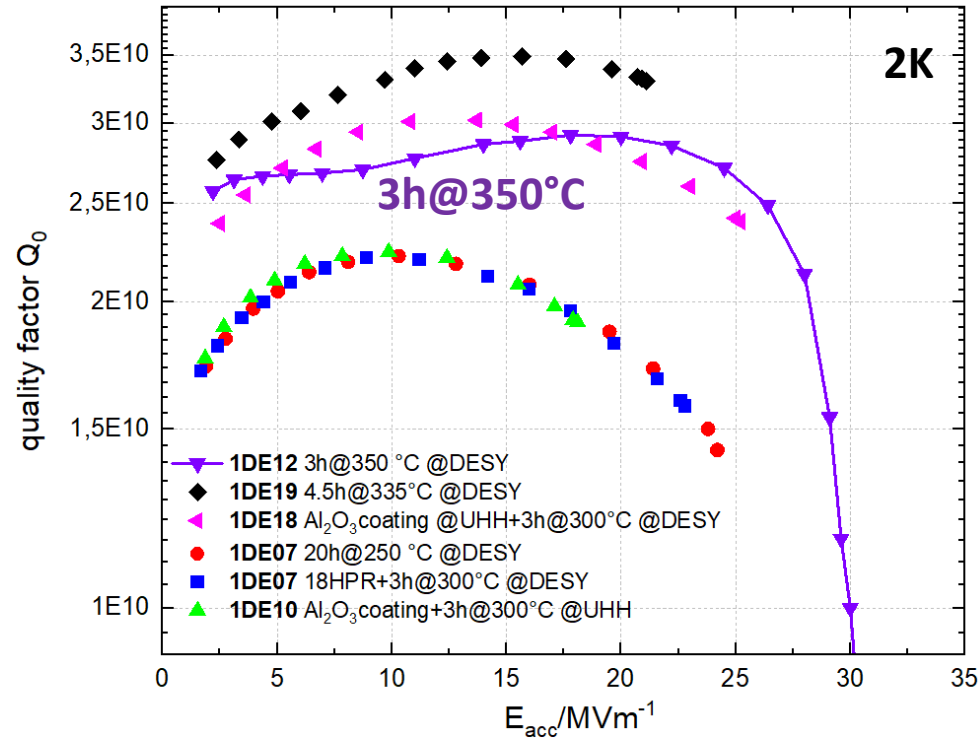
Too high NSF c_0 is not good for Q_0



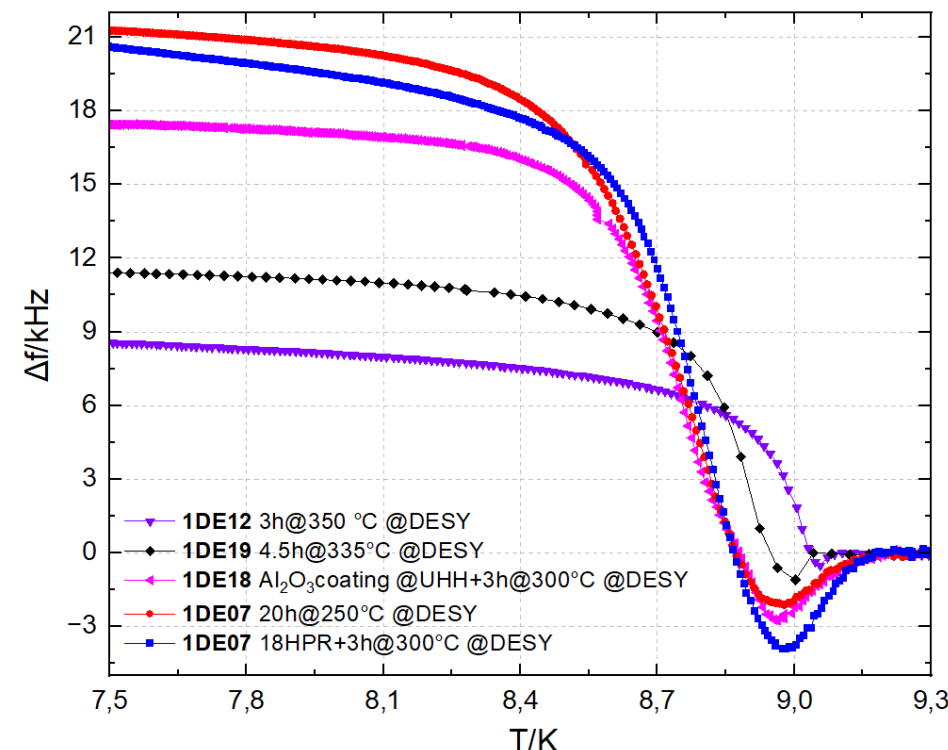
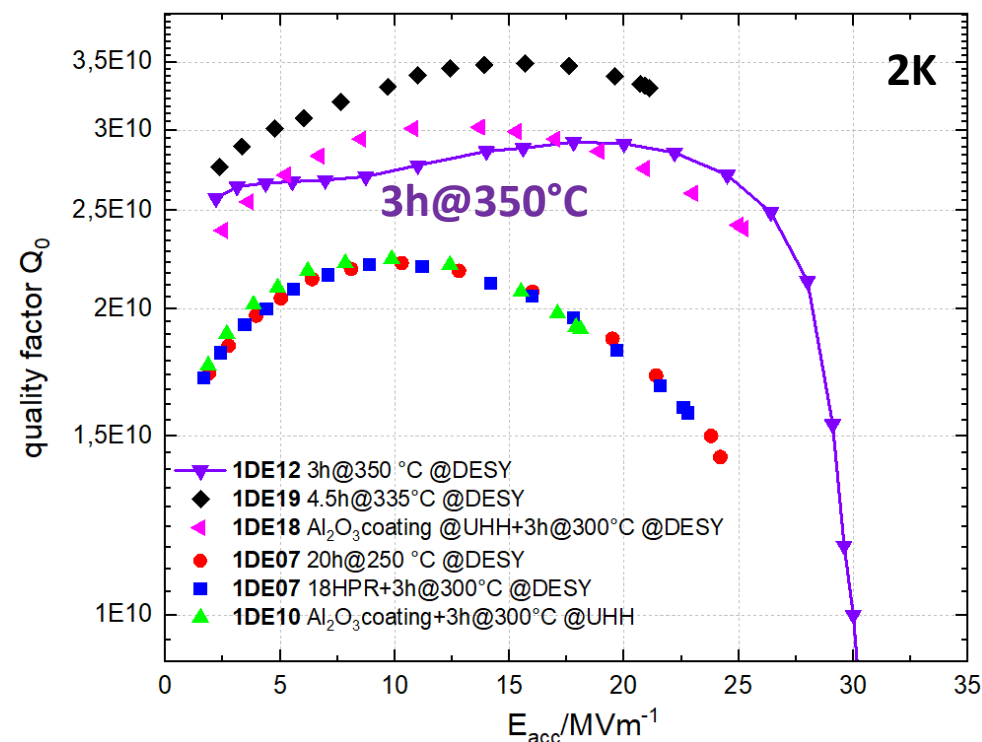
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High thermal budget

High thermal budget \rightarrow HFQS reappears

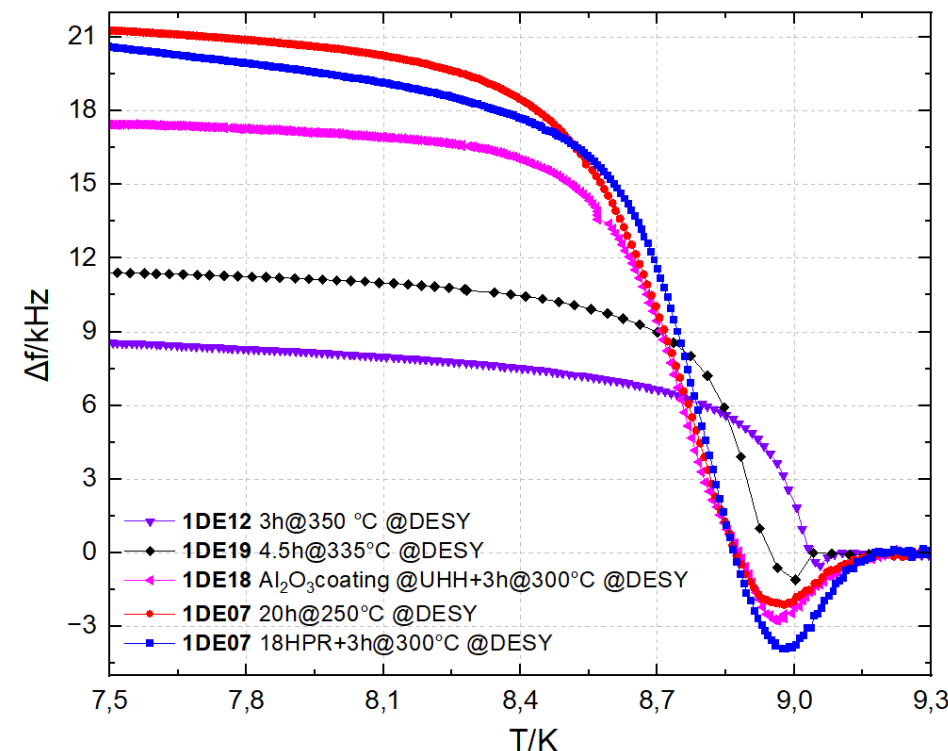
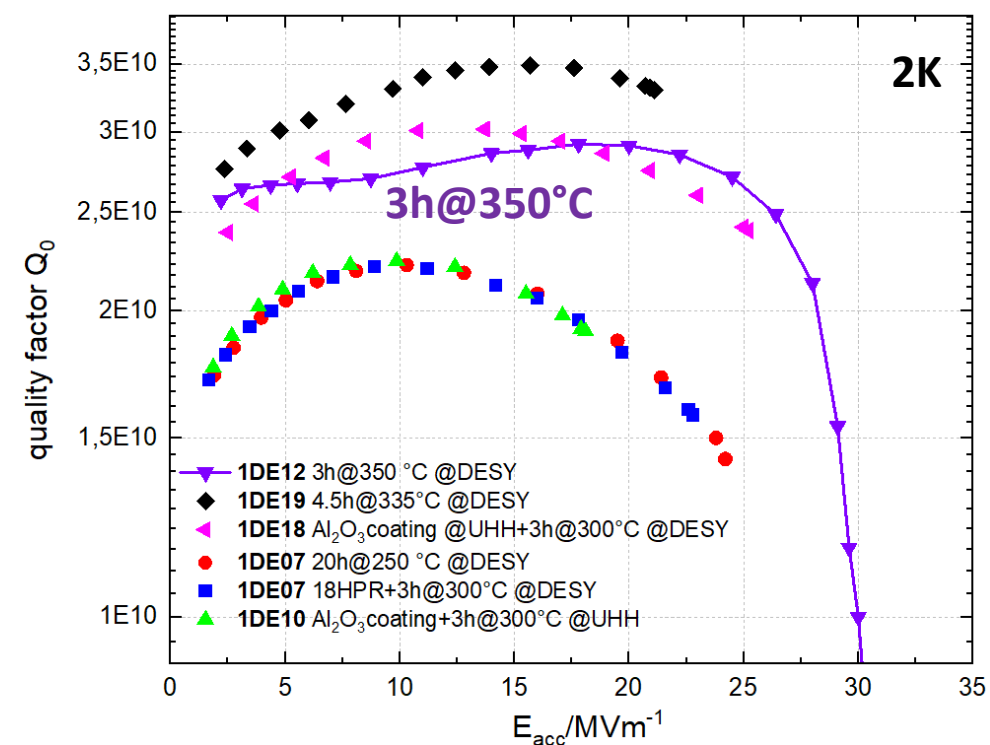


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Cavity	Treatment	$\Delta f_{tot}/kHz$	$\Delta f_{dip}/kHz$
1DE19	4.5h @ 335°C	11.7	1.1
1AC02	3.25h @ 335°C	12.3	1.4
1RI04	3h @ 250°C	18.4	0.9
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High thermal budget → HFQS reappears



- Diffuse O out of RF layer
→ HFQS reappears and $\Delta f_{tot} / \Delta f_{dip}$ decreases again

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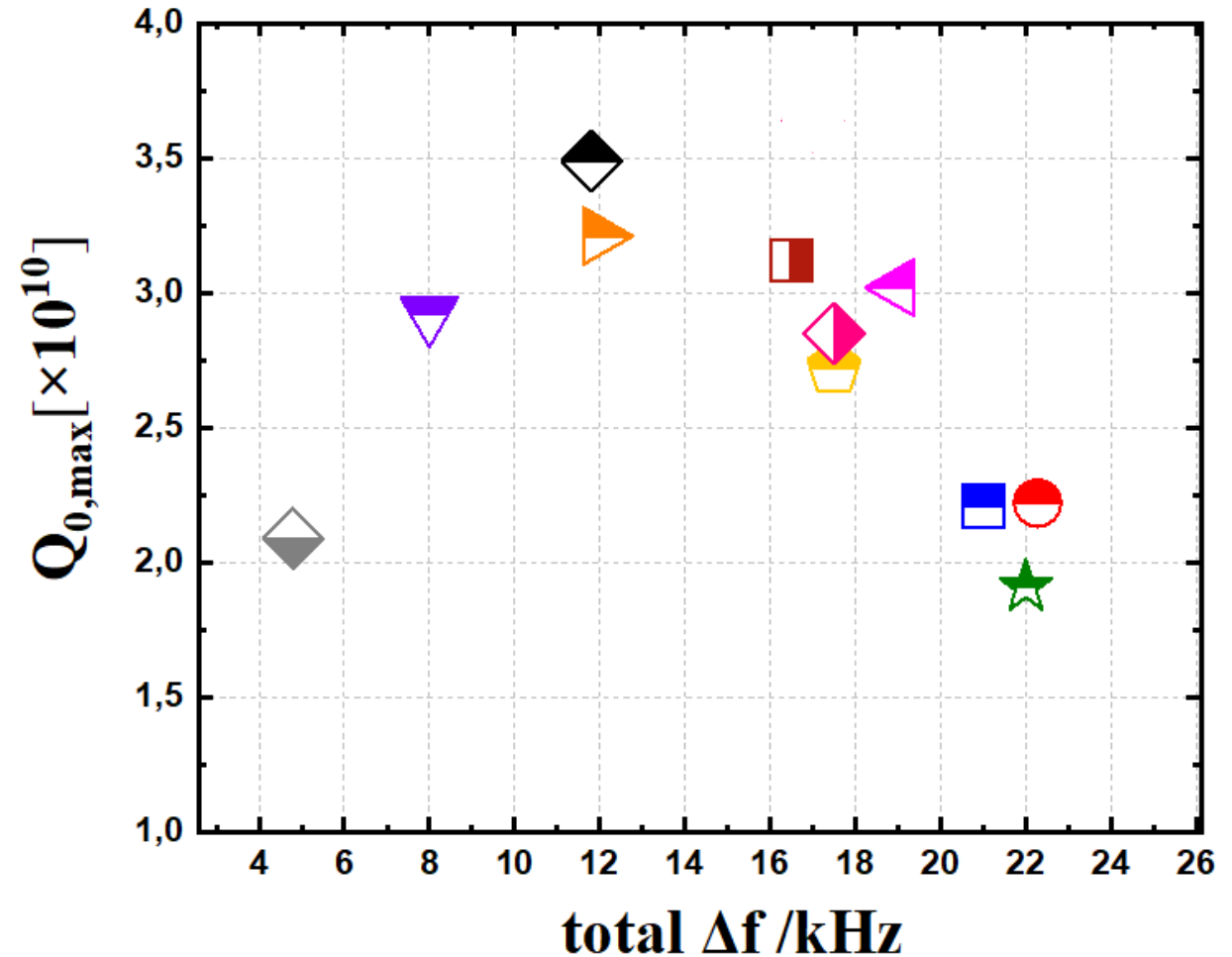
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	1DE12 3h@350 °C @DESY
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	1DE07 20h@250°C @DESY
	1DE07 18HPR+3h@300°C @DESY
	1AC02 3.25h@335°C @DESY
	1RI04 3h@250°C @DESY
	1RI02 20h@250 °C @DESY
	1DE03 baseline 20µm-removing @RI, No 120 °C baking
	1DE03 3h@300°C @DESY
	1DE04 800°C resetting+3h@300°C @DESY



Conclusion

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- Optimal recipe depends on furnace – „thermal budget“
 - 1DE10 vs. 1DE18
- Sweet spot for Q_0 seems to exist – right amount of disorder ?
 - continue investigation & model building (Δf_{tot} vs. Δf_{dip} , E_{acc} , grain mapping)

Thanks...

- to **DESY** for the cavity measurements
- to **you** for listening

Questions?



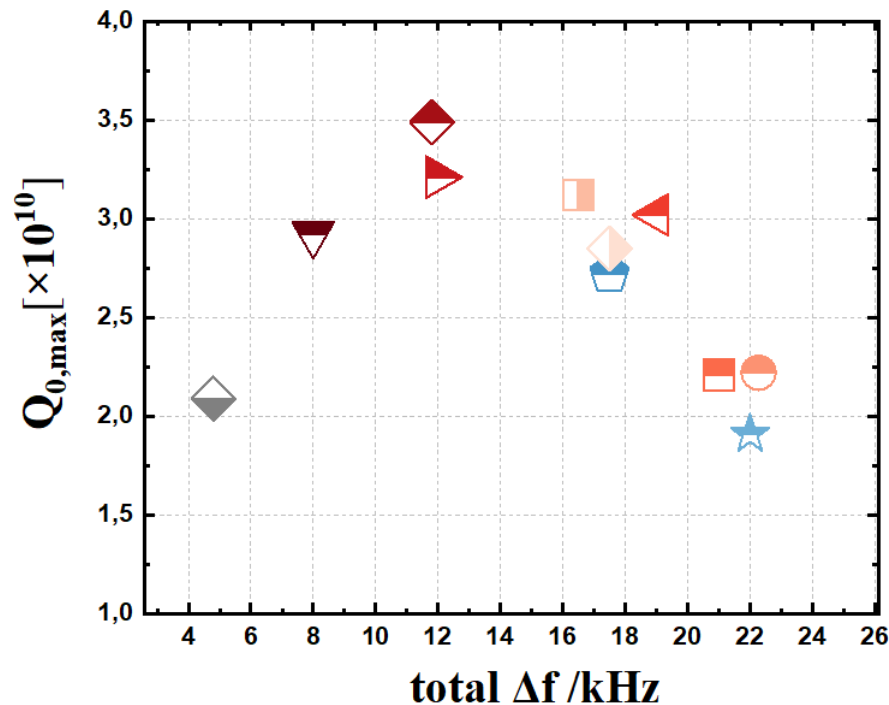
Back Up

Correlation with thermal budget?

Assumed Δf is depends c_0 ...

and we know that NSF c_0 goes down with larger thermal budget / larger $\langle z \rangle$...

some correlation of Q_0 with $\langle z \rangle$ expected as well – yet weaker as Fick's law does not accomodate uneven GB diffusion / saturation effects



2655 nm
1248 nm
865 nm
773 nm
641 nm
560 nm
537 nm
528 nm
512 nm
234 nm



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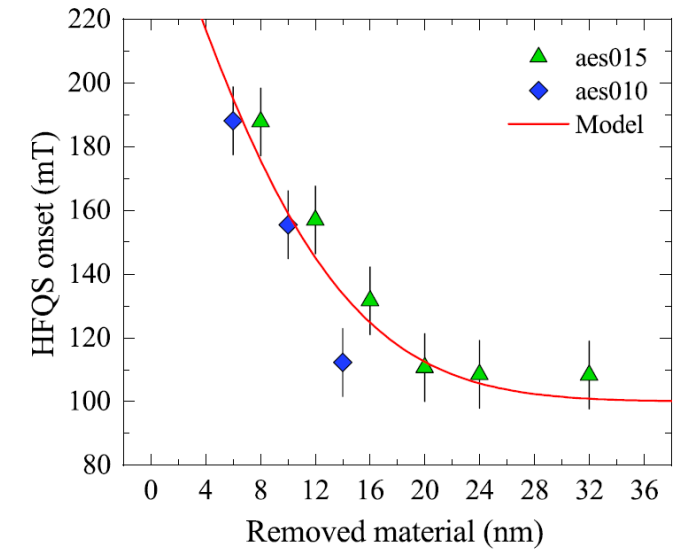
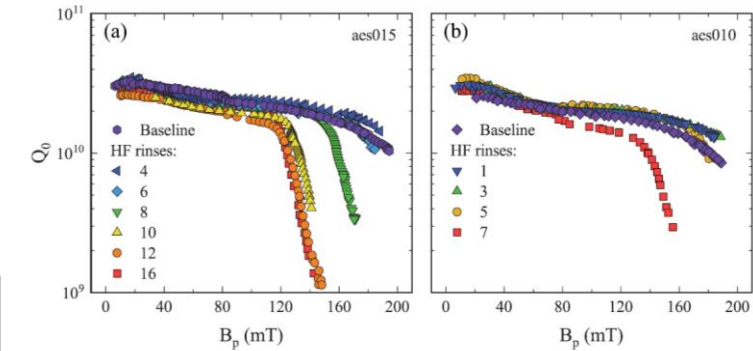
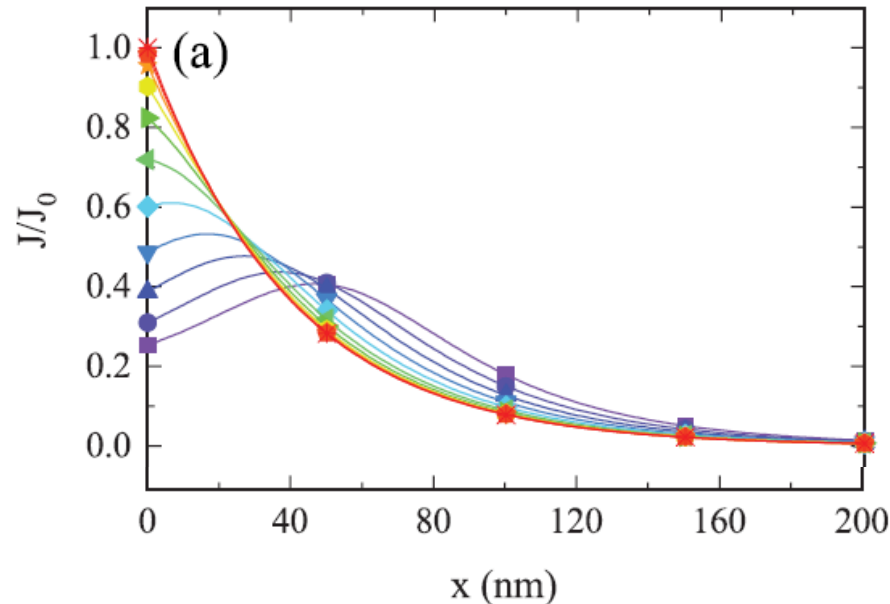
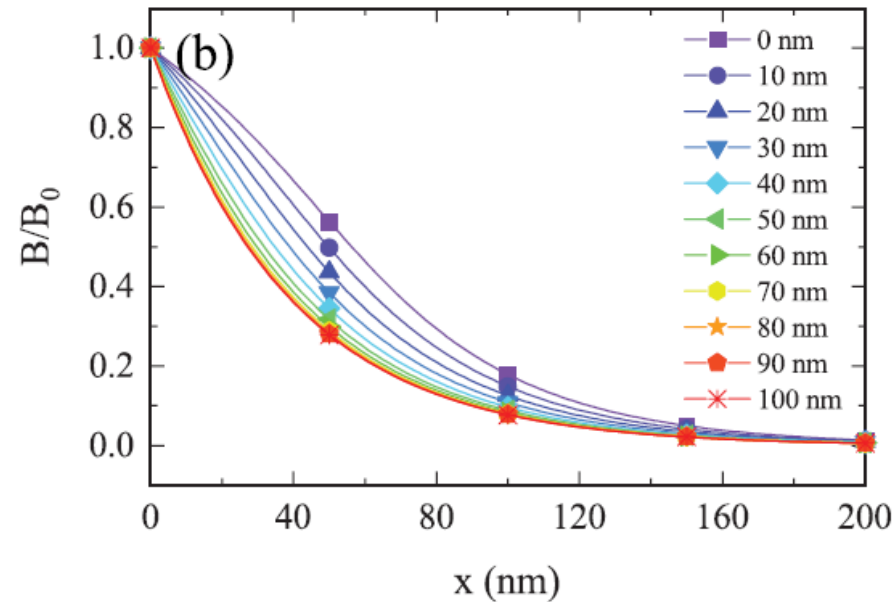
Current Redistribution

[Checchin, M. et al., Appl. Phys. Lett. 117, 032601 (2020)]

[Pambianchi, M. et al., Phys. Rev. B 50, 13659]

$$\lambda^2 B''(x) + 2\lambda\lambda' B'(x) - B(x) = 0.$$

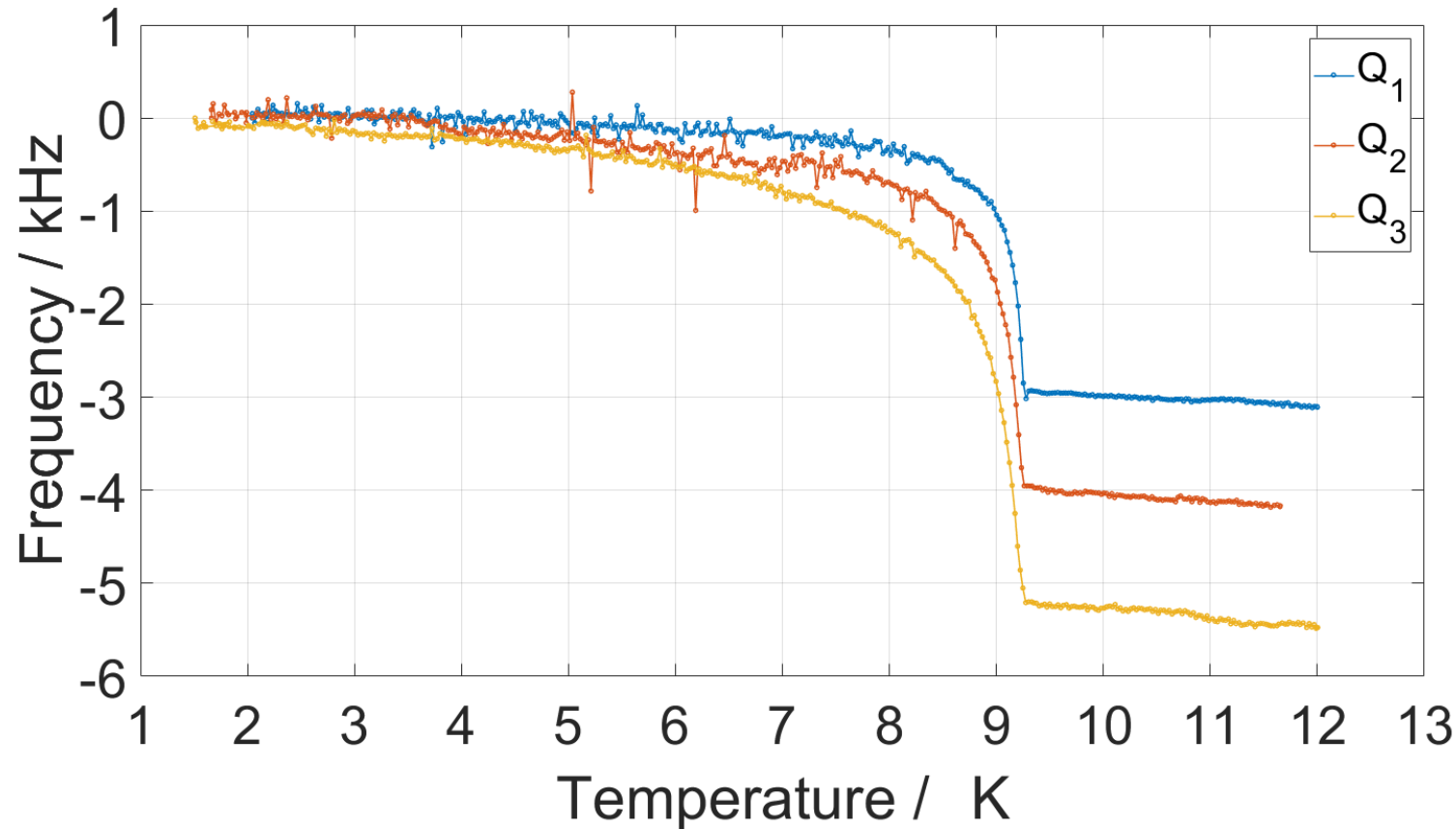
$$\lambda(x) = (\lambda_s - \lambda_0) \operatorname{Erfc}\left[\frac{x}{\delta}\right] + \lambda_0,$$



Consequence:

Currents shifted away from the surface where “lossy mechanism(s)” occur

Frequency shift is frequency dependent

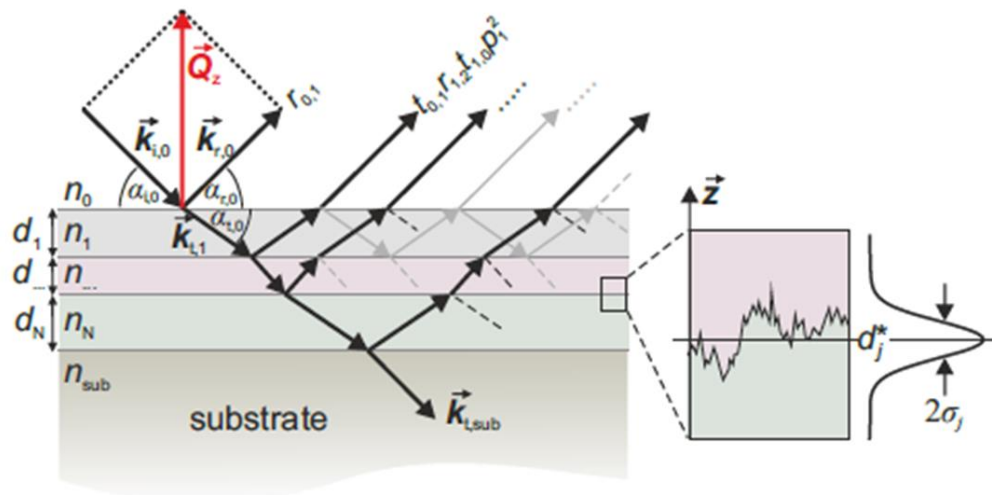


- $Q_n = n \times 433\text{MHz}$
- Lower frequency $f_{\text{op}} \rightarrow$ lower Δf_{tot}
- That is because Γ is frequency dependent
- If the dip is caused by current redistribution $\rightarrow \Delta f_{\text{dip}}$ should depend on f_{op} as well

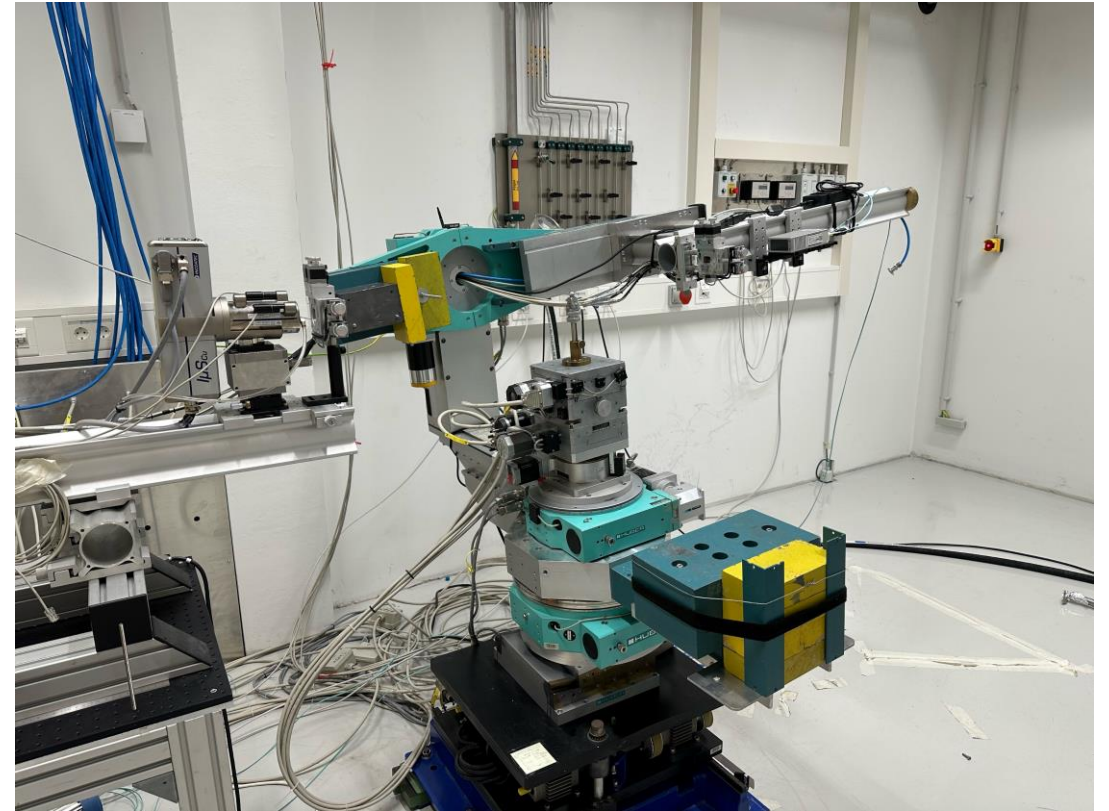
X-Ray Reflectivity (XRR)

Non-destructive method of analysis

Weak scattering cross-section --> large penetration depth



[Dissertation Uta Hejral, 2015]



101 on XRR: Information from the curve

